Reactive adsorption of molecules and radicals on surfaces under plasma exposure
Daniil Marinov

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Présentée par
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Reactive adsorption of Molecules and Radicals on Surfaces under Plasma Exposure

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Contents

I. Introduction .......................................................................................................................... 7
   I.1 Plasma-surface interactions: historical overview ......................................................... 7
   I.2 Context of the study ...................................................................................................... 8
   I.3 Organization of the thesis ............................................................................................ 9

1. Chapter I: Surface reactivity in N₂/O₂ plasmas ......................................................... 11
   1.1 Interaction of radicals with surfaces: basic concepts ............................................. 11
      1.1.1 Adsorption .......................................................................................................... 11
         1.1.1.1 Physisorption ............................................................................................... 12
         1.1.1.2 Chemisorption ............................................................................................ 13
      1.1.2 Mechanisms of surface reactions ....................................................................... 14
      1.1.3 Surface reactions: thermodynamic viewpoint .................................................... 15
   1.2 Modelling of surface reactivity in plasmas ............................................................... 16
   1.3 Mesoscopic modelling of atomic recombination on surfaces ................................ 17
      1.3.1 Surface kinetics in N₂/O₂ mixtures ................................................................. 20
      1.3.2 Role of plasma exposure .................................................................................... 20
   1.4 Surface reactions in N₂/O₂ plasmas: review of experimental studies ................. 21
      1.4.1 Recombination of O and N atoms on surfaces ................................................. 21
      1.4.2 Molecule production/conversion on surfaces ................................................... 22
   1.5 Research questions ................................................................................................... 23
   1.6 Research strategy ....................................................................................................... 24
   1.7 Definitions and notations ......................................................................................... 25

2. Chapter II: Experimental setup and diagnostic techniques ........................................... 27
   2.1 Discharge setup ......................................................................................................... 27
      2.1.1 Reactor and gas system ...................................................................................... 27
      2.1.2 Pulsed discharge systems ................................................................................ 28
         2.1.2.1 Direct current glow discharge ................................................................... 28
         2.1.2.2 Radiofrequency capacitive discharge ....................................................... 30
   2.2 Diagnostics employed ............................................................................................... 31
      2.2.1 Tuneable diode laser absorption spectroscopy in mid-infrared range .......... 31
         2.2.1.1 Principles of laser absorption spectroscopy ............................................ 31
         2.2.1.2 Advantages of laser absorption measurements ....................................... 32
2.2.1.3 Pitfalls of laser absorption measurements ........................................... 32
2.2.1.4 Diode laser spectrometer ........................................................................ 33
2.2.1.5 Three-channel quantum cascade laser spectrometer .......................... 35
2.2.2 Time resolved emission and absorption spectroscopy in UV-Vis range. .... 38
  2.2.2.1 Optical emission spectroscopy for gas temperature determination .... 39
  2.2.2.2 OES setup and data treatment ............................................................. 40
  2.2.2.3 Time resolved measurements of ozone concentration ...................... 42
2.2.3 TALIF measurements of atomic oxygen ............................................... 43
  2.2.3.1 Principles and calibration of O TALIF measurements .................... 43
  2.2.3.2 Laser setup ......................................................................................... 44
2.2.4 Mass spectrometric gas analysis ......................................................... 46
2.2.5 XPS surface diagnostics ................................................................. 47
2.2.6 Summary on used diagnostics ....................................................... 48
3. Chapter III: Adsorption and reactivity of N atoms on silica surface under plasma exposure ................................................................. 49
  3.1 Introduction .............................................................................................. 49
    3.1.1 Experimental procedures ......................................................... 49
  3.2 Determination of the coverage of N\textsubscript{ads}: XPS study ................ 51
    3.2.1 Dynamics of N adsorption on SiO\textsubscript{2} ..................................... 51
    3.2.2 Species responsible for nitridation: ions or neutrals? ...................... 54
    3.2.3 Reactivity of SiO\textsubscript{x}N\textsubscript{y} under plasma exposure .............. 54
    3.2.4 Conclusions on XPS study ............................................................. 56
  3.3 Reactivity of N\textsubscript{ads}: Isotopic study ........................................ 57
    3.3.1 Experimental details .......................................................................... 57
    3.3.2 Characterization of the discharge: measurements of N\textsubscript{2} dissociation degree... 59
      3.3.2.1 Dissociation of N\textsubscript{2} in pulsed dc discharge ....................... 59
      3.3.2.2 Dissociation in pulsed rf discharge ............................................ 62
      3.3.2.3 Estimation of atomic nitrogen exposure on the surface ............. 63
    3.3.3 \textsuperscript{14}N adsorption on SiO\textsubscript{2} under \textsuperscript{28}N\textsubscript{2} plasma exposure .................. 64
    3.3.4 Reactivity of grafted \textsuperscript{14}N atoms under \textsuperscript{30}N\textsubscript{2} plasma exposure ...... 67
      3.3.4.1 Evidence for a distribution of reactivity of N\textsubscript{ads} .................... 67
      3.3.4.2 Do N\textsubscript{ads} participate in surface recombination of N atoms? 69
    3.3.5 Conclusions on the isotopic study ............................................... 71
3.4 Recombination of N\textsubscript{ads} with O atoms .......................................................... 71
3.4.1 Experimental details ........................................................................................................ 71
3.4.2 Kinetics of NO production on the surface ...................................................................... 73
   3.4.2.1 Proof of recombination mechanism $N\textsubscript{ads} + O \rightarrow NO$ ....................... 73
   3.4.2.2 Kinetics of NOx in the probe discharge ............................................................. 74
   3.4.2.3 Estimation of the coverage of $N\textsubscript{ads}$ that produce NO .............................. 75
   3.4.2.4 NO production on the surface under continuous $O\textsubscript{2}$ plasma exposure .... 77
3.4.3 Investigation of adsorption and reactivity of N using measurements of NO production on the surface .............................................................................................................................. 78
   3.4.3.1 Kinetics of adsorption .............................................................................................. 78
   3.4.3.2 Are $N\textsubscript{ads}$* active for recombination of N on the surface? ..................... 80
3.5 Discussion and conclusions .................................................................................................. 82
   3.5.1 Summary and conclusions on used diagnostics ......................................................... 85

4. Chapter IV: Adsorption and reactivity of oxygen atoms on oxide surfaces under plasma exposure ................................................................. 87
4.1 Introduction .......................................................................................................................... 87
   4.1.1 Experimental procedures .............................................................................................. 88
4.2 Chemisorption of O on silica-like surfaces: isotopic study ............................................. 88
   4.2.1 Experimental details ..................................................................................................... 88
   4.2.2 Do O atoms of the material participate in surface reactivity? ....................................... 90
   4.2.3 $^{16}$O adsorption on the surface under $^{32}$O\textsubscript{2} plasma exposure ..................... 92
   4.2.4 Conclusions on the isotopic study ................................................................................ 94
4.3 Adsorption of atomic oxygen on Pyrex and related reactivity towards NO ... 94
   4.3.1 Experimental details ..................................................................................................... 95
   4.3.2 Evidence of NO oxidation by adsorbed O atoms ............................................................ 96
   4.3.3 Determination of the surface coverage of adsorbed O atoms ...................................... 97
   4.3.4 Evidence of a distribution of reactivity adsorbed O atoms .......................................... 98
   4.3.5 Conclusions on the study of O\textsubscript{ads} reactivity on Pyrex ..................................... 99
4.4 On the role of O\textsubscript{ads} for VOC oxidation .......................................................... 99
   4.4.1 Context of the study: influence of the chemical nature of the surface on the reactivity of O\textsubscript{ads} ................................................................. 100
   4.4.2 $C\textsubscript{2}H\textsubscript{2}$ oxidation by adsorbed oxygen atoms on TiO\textsubscript{2} .................. 101
      4.4.2.1 Experimental details ............................................................................................. 101
      4.4.2.2 Kinetics of $C\textsubscript{2}H\textsubscript{2}$ destruction on pretreated TiO\textsubscript{2} surface .... 102
4.4.2.3 Oxidation of adsorbed reaction intermediates ........................................... 103
4.4.3 Discussion and conclusions on the study of O_{ads} reactivity on TiO_{2} .............. 105
4.5 Investigation of ozone formation on surfaces .................................................... 106
4.5.1 Experimental details ......................................................................................... 107
4.5.2 Ozone production in bare silica tube ................................................................. 107
4.5.3 Ozone production in the presence of high specific surface material ................. 111
   4.5.3.1 Influence of gas pressure and surface pretreatment .................................... 113
4.5.4 Modelling of ozone production in bare silica tube ........................................... 114
4.5.5 Conclusions on the ozone production study .................................................... 117
4.6 Conclusions .......................................................................................................... 118
5. Chapter V: Study of surface vibrational relaxation of N_{2} ............................ 121
5.1 Introduction ............................................................................................................ 121
5.2 Kinetics of vibrationally excited nitrogen ............................................................ 121
   5.2.1 Role played by N_{2}(v) in nitrogen containing plasmas .................................. 121
   5.2.2 Electron impact excitation/de-excitation of N_{2}(v) ....................................... 122
   5.2.3 Vibrational relaxation of N_{2}(v) in the gas phase ........................................ 124
   5.2.4 Vibrational relaxation on surfaces: motivation of the study ....................... 125
5.3 Study of N_{2}(v) relaxation using infrared titration ........................................... 127
   5.3.1 Principles of the infrared titration technique ................................................ 127
   5.3.2 Experimental procedure .............................................................................. 127
   5.3.3 Validity of the diagnostics ............................................................................ 128
      5.3.3.1 Gas temperature and its influence on the relaxation measurements ..... 130
      5.3.3.2 Dissociation and re-association of titrating molecules ......................... 131
      5.3.3.3 Vibrational excitation of titrating molecules ........................................ 132
5.4 Modeling of vibrational kinetics in N_{2}-CO_{2} .................................................. 133
   5.4.1 Relevant relaxation processes ....................................................................... 133
   5.4.2 Model description ......................................................................................... 135
      5.4.2.1 Gas phase processes ............................................................................. 135
      5.4.2.2 Heterogeneous processes ..................................................................... 136
      5.4.2.3 Numerical solution .............................................................................. 137
   5.4.3 Validation of the model .................................................................................. 137
   5.4.4 On the possibility of experimental determination of $\gamma_{N_{2}}$ dependence on $v$ ... 138
   5.4.5 Modeling results in N_{2} – CO_{2} mixtures .................................................. 140
5.4.6 Determination of $\gamma_{N_2}$ for silica. The influence of CO$_2$ admixture .................. 142
5.4.7 Conclusions on the study of the N$_2$ – CO$_2$ system ................................................. 145
5.4.8 Data analysis using characteristic relaxation times ................................................. 145

5.5 Application of the IR titration for $\gamma_{N_2}$ determination on catalytic and plasma-pretreated surfaces ........................................................................... 149
  5.5.1 The effect of plasma pretreatment ............................................................................ 149
  5.5.2 Vibrational relaxation on TiO$_2$ ............................................................................. 152
  5.5.3 Vibrational relaxation on other catalytic surfaces ................................................. 154
  5.5.4 Vibrational relaxation on silica surface in air plasma ........................................... 155

5.6 Infrared titration as a plasma diagnostics tool: determination of the vibrational
temperature of N$_2$ ........................................................................................................... 155
  5.6.1 Formulation of the method and its application to the N$_2$ – CO$_2$ system .......... 155
  5.6.2 On the vibrational temperature measurements in N$_2$ - N$_2$O and N$_2$ - CO ...... 156

5.7 Conclusions .................................................................................................................. 158

6. Chapter VI: General conclusions and outlook ......................................................... 161
  6.1 General conclusions ..................................................................................................... 161
  6.2 Summary of the main results ..................................................................................... 162
  6.3 Implication for modelling of surface recombination ............................................. 163
  6.4 Future work ............................................................................................................... 164
  6.5 New diagnostic techniques ....................................................................................... 166

7. References ..................................................................................................................... 167
I. Introduction

I.1 Plasma-surface interactions: historical overview

The word plasma was introduced in 1928 by Irving Langmuir [1] who was struck by the analogy between blood plasma that transports red and white corpuscles and a discharge column acting as a sub-stratum carrying molecules, ions and electrons. It is interesting to note that Langmuir got the Nobel Prize in Chemistry in 1932 for his achievements in surface science. Langmuir clarified the true nature of surface adsorption and established the existence of monolayers as two-dimensional structures on the surface. Therefore, it wouldn't be exaggerating to say that both plasma science and surface science as we know them today were started by the same person almost a century ago.

The importance of surface catalyzed processes in reactive plasmas has been recognized since the early 1920s. Low pressure glow discharges in glass tubes were used in those times as a source of molecular and atomic spectra. In 1920 Wood made an observation of recombination of atomic hydrogen on glass surface in his study of Balmer series in a long discharge tube [2]. In the following, recombination of atomic hydrogen on different catalytic surfaces in a broad temperature range was thoroughly studied and the first models describing the recombination process were proposed [3,4] by the end of 1940s.

Following the advent of numerous techniques for detection of atomic species (catalytic probes, mass-spectrometry, optical emission spectroscopy, electron paramagnetic resonance), the number of studies of the surface catalyzed recombination of atoms has rapidly increased in 1950 – 1960s ([5] and references therein). In those times interaction between radicals and catalytic surfaces was investigated by the catalysis community and many ideas coming from classical heterogeneous catalysis with stable molecules were adopted in order to explain reaction mechanisms. In the majority of works, recombination of atoms was studied in flow-tube experiments in the post-discharge zone. Thus, plasma was used only as a source of radicals and there was no direct interaction between the plasma and the studied surface.

Plasma-surface interactions became an expanding field of research in 1970s when the potential of plasmas for material processing was realized. Unique properties of etching reactive plasmas used for microelectronics applications were investigated in details. In the classical work [6] a synergetic effect between Ar\(^+\) ions and reactive XeF\(_2\) molecules for poly-Si etching was discovered in beam experiments. It was found that when Si surface is exposed to both Ar\(^+\) and XeF\(_2\) the etch rate is not simply a sum of the etch rates obtained under ion bombardment or neutral gas flow but increases by an order of magnitude. Later on, synergetic effects between charged and neutral species were observed in the process of film growth in low temperature plasmas [7]. Therefore, it was finally realized that the unique property of reactive plasmas is that they produce at once flows of radicals, excited species and ions on the surface.
Introduction

Today study of plasma-surface interactions is a growing field of research which is driven by a great number of applications. Plasma processing of surfaces is widely used for microelectronics, material science, thin films and coatings. Plasma surface interactions play a key role in nuclear fusion, atmospheric re-entry and plasma medicine.

In the space, reactions of radicals and formation of molecules on solid surfaces is one of the most important problematic of astrochemistry. In the interstellar medium reactions between gas phase species are very rare and the chemistry takes place on the surface of dust particles.

Regardless a long lasting history of research on surface processes in reactive molecular plasmas this field is still barely studied and poorly understood, especially compared to the present knowledge of the mechanisms of gas phase reactions. Surface is still the “terra incognita” for plasma science. This can be clearly observed in the kinetic modelling of low pressure discharges. State of the art discharge models include dozens of gas phase reactions between stable and excited species taking into account individual electronic and vibrational levels. However, surface processes are often introduced using effective reaction coefficients that are not known a-priori and used as tuning parameters. These adjustable parameters reduce the accuracy and predictive capability of the models. Therefore, there is a real need for a deeper understanding of mechanisms of surface processes in reactive plasmas.

I.2 Context of the study

One of the promising applications of low temperature plasmas is the destruction of air pollutants. High reactivity and low gas temperature of non-equilibrium plasmas are very attractive for low energy cost oxidation of volatile organic compounds (COV). A combination of low temperature plasmas with heterogeneous catalyst was proposed in 1990s in order to improve the efficiency and selectivity of pollutant destruction [8][9][10][11][12].

The research activity on plasma-catalyst coupling for VOC abatement has started at the Laboratory of Plasma Physics in the beginning of 2000s with the PhD works of Olivier Guiatella, Frederic Thevenet and Lina Gatilova. It was shown that introduction of a porous catalytic material (SiO$_2$ or TiO$_2$) in atmospheric pressure dielectric barrier discharge (DBD) increases the efficiency of oxidation of C$_2$H$_2$ (which was selected as a model pollutant). Improvement of CO$_2$/CO selectivity was also observed. Increase of the lifetime of atomic oxygen due to its stabilization on the surface of the catalyst was proposed as an explanation of observed synergetic effects. However, the mechanisms of plasma-catalyst interaction in DBDs are very difficult to study due the complexity of the discharge phenomena at atmospheric pressure.

The originality of the approach developed at LPP consisted in the utilization of a low pressure (~1 mbar) dc discharge for investigation of elementary processes on the surface of real catalytic materials that were previously studied in atmospheric pressure DBDs. The use of pulsed dc discharge allowed much better control over the plasma parameters and various in-situ and time resolved diagnostics were applied. Similar synergetic effects in C$_2$H$_2$ destruction by plasma-catalyst combination were observed at low pressures [13]. In parallel the
elementary kinetics of air plasmas at mbar pressures was studied. Production of O atoms, NO and NO$_2$ molecules, and electronically excited species N$_2$(B$^3\Pi$, C$^3\Pi$) was measured and modelled in [14][15][16].

This effort resulted in quite a complete understanding of the gas phase kinetics in pulsed dc discharge in air and air/C$_2$H$_2$ mixtures. However, surface processes were still barely understood although it was shown that they play a very important role in low pressure conditions. How radicals are lost and molecules are formed and how vibrational energy is relaxed on surfaces under plasma exposure remained unclear even for such simple non-catalytic reactor wall materials as silica or Pyrex, to say nothing about real high specific surface catalysts.

Understanding of surface processes in N$_2$/O$_2$ containing plasmas at mbar pressures was therefore the aim of my thesis. The interest of this work is more general than just air pollution control. The research questions that will be addressed are relevant to any application where N$_2$/O$_2$ plasmas meet the surface.

Plasmas containing N$_2$ and O$_2$ play an important role for a great number of applications. Many of these applications rely on the processes that take place on surfaces in contact with the plasma. In addition to air pollution control mentioned above we can name nitridation [17], deposition of thin films [18], treatment of polymers [19], and thermal protection on re-usable space vehicles [20]. In some cases plasma-surface interactions are inevitable; they arise from the presence of reactor walls and influence the kinetics of the plasma. This is the case of atomic sources [21] as well as any type of low pressure plasmas in N$_2$/O$_2$ mixtures [22].

I.3 Organization of the thesis

In Chapter 1 of this thesis we give an outlook on the present understanding of reaction mechanisms of radicals on surfaces. Theoretical and experimental approaches to the study of surface reactions in N$_2$/O$_2$ containing plasmas are reviewed. The open questions concerning the role of chemisorbed atoms in surface catalyzed processes are outlined. Finally, we formulate our objectives and research strategy. We propose the approach which consists in the pretreatment of the surface by N$_2$ or O$_2$ plasma followed by probing of the coverage and reactivity of adsorbed atoms.

In Chapter 2 the experimental setup and the used diagnostics are presented.

In Chapter 3 we investigate adsorption and reactivity of N atoms on silica surface under N$_2$ plasma exposure. We apply surface diagnostics such as XPS in order to determine the coverage of adsorbed N atoms and follow the modification of the chemical composition of the surface by plasma. Production of N$_2$ and NO molecules on the surface catalysed by adsorbed nitrogen atoms is studied by mass spectrometry and laser absorption spectroscopy in order to get insight in the reactivity of N$_{\text{ads}}$. Different methods of titration of N$_{\text{ads}}$ are compared.

In Chapter 4 we study adsorption and reactivity of oxygen atoms on oxide surfaces (silica, Pyrex, TiO$_2$) under O$_2$ plasma exposure. Reactivity of adsorbed O towards stable molecules
Introduction

(NO, C₂H₂) and radicals (¹⁸O) is investigated using laser absorption spectroscopy and mass spectrometry. In order to get insight into the reactivity of weakly bonded oxygen atoms, we study ozone production from recombination (O+O₂)wall on silica surface.

In Chapter 5 we study relaxation of vibrationally excited nitrogen molecules on the surface using a new infra red (IR) titration technique. A short dc discharge pulse is used to excite a mixture containing a small amount of CO₂, N₂O or CO in N₂. Due to a very efficient vibrational energy transfer between N₂ and IR tracers, their vibrational excitation is an image of the vibrational excitation of N₂. In the afterglow, the vibrational relaxation of titrating molecules is monitored in-situ using quantum cascade laser absorption spectroscopy (QCLAS). Relaxation measurements have been interpreted in terms of a numerical model of non-equilibrium vibrational kinetics. Probability of N₂ vibrational quantum loss (γN₂) on the surface has been determined from the best agreement between the experiment and the model.
1. Chapter I: Surface reactivity in N$_2$/O$_2$ plasmas

1.1 Interaction of radicals with surfaces: basic concepts

Interaction between gas phase species and surfaces is a general problem that has been studied with relation to a number of applications ranging from supersonic flights to heterogeneous catalysis. Today, the global picture of gas-surface interactions is well established and can be found in textbooks [23]. In this section we introduce the basic concepts required for description of surface reactions of radicals. One particular case, which is central for our study – interaction of O and N atoms with silica like surfaces is considered as an example.

1.1.1 Adsorption

What happens when gas phase atoms arrive on a surface? The first step is the adsorption, i.e. formation of a bond between atoms and the surface. Depending on the nature of this bond, two cases are distinguished – physical and chemical adsorption, schematically these cases are represented in Figure 1. 1.

![Figure 1.1 Schematic representation of physisorption and chemisorption of atoms on the surface.](image)

Surface reactivity in N\textsubscript{2}/O\textsubscript{2} plasmas

1.1.1.1 Physisorption

Physisorption is a result of the Van der Waals interaction between gas phase species and the surface. Van der Waals forces originate from the attraction between induced electric dipoles and therefore physical adsorption is a collective effect of interaction between impinging species and atoms of the surface. Figure 1. 1 shows schematically the potential energy of this interaction which is modulated following the position of surface atoms. These periodic potential wells are called physisorption sites. The depth of the potential wells in the direction perpendicular to the surface is the energy of desorption; typically it is found in the range $E_d \sim 0.01 – 0.2$ eV per particle [23]. Apart from being desorbed, physisorbed species may also move (diffuse) in the direction parallel to the surface. The energy barrier that atoms need to overcome in order to hop between neighbouring physisorption sites is obviously smaller than the energy of desorption.

In order to describe physisorption of atoms on silica-like surfaces several parameters have to be considered:

- **The surface density of physisorption sites** $F$. The value of $F$ coincides with the number of atoms on the surface (typically $\sim 10^{15}$ cm$^{-2}$). It is usually supposed in the models that all the physisorption sites are identical, i.e. the surface is homogeneous.

- **The fractional coverage of physisorption sites** $\theta_F$. This parameter is simply the ratio of the number of occupied physisorption sites to the total number of physisorption sites.

- **The energies of desorption** $E_d$ and diffusion $E_D$. These parameters represent the depths of potential wells in the direction perpendicular ($E_d$) and parallel ($E_D$) to the surface. Typically, in the models $E_d \sim 0.5$ eV [5]. The activation energy for diffusion $E_D$ is supposed to be a fraction of the activation energy for desorption $E_d$, according to [24] on glass surfaces $E_D/E_d \sim 0.5$.

- **The characteristic frequencies of desorption** ($\nu_d$) and diffusion ($\nu_D$). For illustration purposes, one can imagine that physisorbed atoms oscillate in the potential wells. The frequency of these oscillations in perpendicular ($\nu_d$) and parallel ($\nu_D$) directions is the frequency at which an atom attempts to leave the surface or hop on the neighbouring physisorption site. The characteristic residence time of an atom on a physisorption site with respect to desorption ($\tau_d$) and surface diffusion ($\tau_D$) can be written as follows [25]:

$$\tau_{d(D)} = 1/\nu_{d(D)} \exp \left( E_{d(D)}/kT_{\text{wall}} \right) \quad \text{(1.1)}$$

Typically, for atoms adsorbed on silica-like materials $\nu_d \sim 10^{15}$ s$^{-1}$ and $\nu_D \sim 10^{13}$ s$^{-1}$ [5]. In (1.1) the dependence of the characteristic times on $T_{\text{wall}}$ is exponential. Therefore, the temperature of the surface is a very important parameter for processes involving physisorbed atoms.
• **Sticking coefficient $s$.** This parameter accounts for the probability of an atom to be physisorbed in a single collision with the surface. The value of $s$ depends on the surface coverage, $s = s_0 (1 - \theta_F)$ where $s_0$ is the sticking coefficient on clean surface. Usually, in the models of surface atomic recombination it is supposed that $s_0 = 1$. However, as mentioned in [26] this assumption may break down when the kinetic energy of impinging species is increased.

1.1.1.2 **Chemisorption**

Oxygen and nitrogen atoms have unpaired electrons and therefore they may efficiently form a chemical bond (ionic or covalent) with the surface. In contrast to physisorption, formation of this chemical bond is possible only on specific places on the surface which are called chemisorption sites. The binding energy in the case of chemisorption is typically found in the range $E_{d}^{chem} \sim 0.4 – 8$ eV [23] per particle.

### Are chemisorbed atoms necessarily stable?

Generally speaking, words “chemisorbed” and “stable” shouldn’t be used as synonyms. The lifetime of chemisorbed species can be calculated using (1. 1); result of calculation with a typical value of $\nu_d \sim 10^{15}$ s$^{-1}$ [25] at room temperature is shown in the graph:

![Graph showing lifetime vs. binding energy](image)

One can see that for $E_{d}^{chem}$ in the range $0.4 – 2$ eV the value of $\tau$ changes over 25 orders of magnitude. Species with $E_{d}^{chem} \leq 1$ eV have the lifetime on the surface of the order of 1 minute and less; therefore, they can’t be considered as absolutely stable. In order to be able speak about the stability of adsorbed species, their lifetime on the surface should be compared with other characteristic times in the system.

Parameters required for description of chemisorption on silica-like surfaces are similar to those considered above for the case of physisorption:
Surface reactivity in N\textsubscript{2}/O\textsubscript{2} plasmas

- **The surface density of chemisorption sites** [S]. The density of chemisorption sites [S] is always smaller than the density of physisorption sites [F]. For silica-like surfaces, the literature values of [S]/[F] are scattered in the range $10^{-3} – 10^1$ [5] [22] [26] [27][28]. One of the reasons of such a big uncertainty is rather fundamental – in fact, the nature of chemisorption sites is not yet clear. It is believed that chemisorption sites are associated with non-saturated Si atoms, impurities and surface defects. But to the best of our knowledge the density of chemisorption sites has never been measured directly. As in the case of physisorption, in the models all the chemisorption sites are supposed to be identical and homogeneously distributed on the surface.

- **The fractional coverage of chemisorption sites** $\theta_S$. This is the ratio of the number of occupied chemisorption sites to the total number of chemisorption sites.

- **The energy of desorption** $E_{d}^{chem}$. As the nature of chemisorption sites on silica-like surfaces is not well understood, the value of $E_{d}^{chem}$ is generally an unknown parameter. In the models, chemisorbed atoms are supposed to be irreversibly trapped by surface sites. In [5] the value $E_{d}^{chem} \sim 3$ eV was found for both O and N chemisorbed on fused silica. Due to this high desorption energy, thermal desorption and diffusion of chemisorbed atoms is discarded in the models when surface temperature is not too high.

- **Activation energy for chemisorption.** Usually it is supposed that adsorption of atoms on vacant chemisorption sites proceeds with zero activation energy, i.e. there is no potential barrier for chemisorption.

1.1.2 Mechanisms of surface reactions

As we have seen above, chemisorbed atoms are trapped by active sites, while physisorbed species may diffuse along the surface. Due to the existence of these mobile species there exist two mechanisms of surface processes: i) Eley-Rideal (E-R) according to which reaction takes place in a direct impact between gas phase species and adsorbed species ii) Langmuir-Hinshelwood (L-H) that proceeds via diffusion on the surface. Schematically, E-R and L-H mechanisms are shown in Figure 1. 2. Occupation of free adsorption sites, recombination of atoms and chemical reactions on the surface may proceed according to one of these two mechanisms. Surface diffusion and L-H reactions become pronounced at lower temperatures when physisorbed species spend more time on the surface. At higher temperatures direct E-R mechanism is dominating.
An important parameter for description of atomic recombination on surfaces is the activation energy of recombination $E_{\text{rec}}$. Recombination of atoms A on the surface

$$S - A + A \rightarrow S + A_2$$

where $S$ states for a chemisorption site is similar to the chemical reaction $BC + D \rightarrow B + CD$. According to [29], if this exchange reaction is exothermic, its activation energy can be estimated as $0.055D(B-C)$ where $D(B-C)$ is the bond strength in the molecule BC.

Nitrogen and oxygen atoms chemisorbed on silica-like surfaces are strongly bound with the bond energy $E^\text{chem}_d$ of few electron volts. Therefore, the recombination process should have the energy barrier of the order of $E_{\text{rec}} \approx 0.2$ eV [5]. It is supposed in the models that $E_{\text{rec}}$ is the same for both L-H and E-R recombination mechanisms. The value of $E_{\text{rec}}$ determines the temperature dependence of the reaction rate of (1.2):

$$k = k^0 \exp \left( -E_{\text{rec}} / kT_{\text{wall}} \right)$$

where $k^0$ is a so-called steric factor.

### 1.1.3 Surface reactions: thermodynamic viewpoint

As any other type of chemical reactions, reactions on the surface in equilibrium conditions are determined by the laws of thermodynamics. According to the classical thermodynamics, at constant temperature and pressure spontaneous chemical reactions proceed with a reduction of Gibbs free energy ($\Delta G < 0$), where $G = H - TS$ ($H$ – enthalpy, $S$ – entropy and $T$ – temperature of the system). Following this general rule, let us consider a recombination reaction between adsorbed species $A_{\text{ads}}$ and species B coming from the gas phase. Product $AB$ is supposed to leave the surface. As an example of such reaction one may consider recombination of atoms ($O + O_{\text{ads}}$, $O + N_{\text{ads}}$, $N + N_{\text{ads}}$) or production of molecules on the surface ($NO + O_{\text{ads}}$, $O_2 + O_{\text{ads}}$). Reaction $A_{\text{ads}} + B \rightarrow AB$ will be thermodynamically favourable if
Surface reactivity in N\textsubscript{2}/O\textsubscript{2} plasmas

\[ \Delta G = (H_{AB} - H_A - H_B) - T(S_{AB} - S_A - S_B) < 0 \quad (1.4) \]

Condition (1.4) signifies that depending on the nature of the reaction partner B different species A\textsubscript{ads} may be potentially involved. Let’s consider for example two recombination reactions: (i) \( \text{O} + \text{O}_{\text{ads}} \rightarrow \text{O}_2 \) and (ii) \( \text{O}_2 + \text{O}_{\text{ads}} \rightarrow \text{O}_3 \). Standard enthalpies of formation and absolute entropies of reacting species are listed in Table 1.1 [30].

<table>
<thead>
<tr>
<th>( \Delta H_f ) (kJ/mol)</th>
<th>( S^0 ) (kJ/mol·K)</th>
</tr>
</thead>
<tbody>
<tr>
<td>O</td>
<td>249</td>
</tr>
<tr>
<td>O\textsubscript{2}</td>
<td>0</td>
</tr>
<tr>
<td>O\textsubscript{3}</td>
<td>142.7</td>
</tr>
</tbody>
</table>

Table 1.1 Thermodynamic data for O, O\textsubscript{2} and O\textsubscript{3} [30].

For reaction (i) calculation using (1.4) at 300 K yields \( \Delta G = H_{O_{\text{ads}}} - 498 \text{ kJ/mol} - 300 \cdot (0.44 \text{ kJ/(mol K)} - S_{O_{\text{ads}}}) \) and for reaction (ii) \( \Delta G = H_{O_{\text{ads}}} - 106 \text{ kJ/mol} - 300 \cdot (0.44 \text{ kJ/(mol K)} - S_{O_{\text{ads}}}) \), where \( H_{O_{\text{ads}}} \) is the heat of adsorption of O. The value of \( S_{O_{\text{ads}}} \) is not known, typically in condensed phase absolute entropy is found in the range 0.02 – 0.1 kJ/(mol K). Therefore, the maximum uncertainty related to the entropy term is rather small, only of the order of \( \pm 10 \text{ kJ/mol} \) (or \( \pm 0.1 \text{ eV} \)). The physical meaning of the condition \( \Delta G < 0 \) in this case is very simple – the adsorption energy of O\textsubscript{ads} at the surface should be smaller than the bond energy of O in the product molecules. For (i) this means that \( E_{d_{\text{chem}}} (\text{O}_{\text{ads}}) < D(\text{O}_2) \approx 5 \text{ eV} \) and for (ii) \( E_{d_{\text{chem}}} (\text{O}_{\text{ads}}) < D(\text{O}_3) \approx 1 \text{ eV} \).

This example demonstrates that the binding energy of adsorbed species is the key parameter that determines surface reactivity.

1.2 Modelling of surface reactivity in plasmas

Processes introduced in the previous section play a role of elementary steps in surface reactions. What we call a mechanism of surface reaction is in fact a sequence of elementary steps by which products are formed. From the theoretical viewpoint we can distinguish three levels of description of surface reactions in reactive plasmas.

- “Macroscopic” level. The elementary reaction mechanisms in this case are ignored and surface reactions are characterized using effective probabilities (\( \gamma \)). An example of this approach can be found in [31][32][33]. Values of \( \gamma \) and their dependencies on the conditions are usually unknown and they are adjusted in order to reach the best agreement with the experiment. From a perspective of plasma modelling the predictive power of this approach is very limited.
Chapter I

- **Mesoscopic level.** In this case the kinetics of surface reactions is described in terms of the fractional coverage of active sites governed by a set of differential equations. Elementary processes on the surface (adsorption, desorption, diffusion, recombination) are supposed to occur with defined rates. A great number of mesoscopic models was developed in the past in order to explain recombination of atoms in low pressure plasmas and afterglows \[5\][22][26][27][28] and in the conditions relevant to the atmospheric re-entry [34][35][36]. Mesoscopic description may be considered on a more microscopic scale by using Monte-Carlo technique as it was done in [37]. Monte-Carlo methods allow inclusion of the effects of local interactions between adsorbed species.

- **Simulation on the atomic level.** This approach gives a complete picture of surface reactivity from the first principles without introduction of any empirical parameters. It has been developed over the past 10 years in [35][38][39][40] for description of O and N atoms recombination on SiO\(_2\) surfaces. *Ab-initio* modelling of surface recombination is split in two parts. First, using density functional theory (DFT) computation the electronic structure of the crystalline solid interacting with incoming gas phase species is calculated. This gives a gas-surface interaction potential and a spectrum of lattice phonons that are used for semi-classical molecular dynamics simulation of the recombination process. In addition to calculation of recombination probability, ab-initio calculations provide information about energy accommodation between recombining species and the surface. Although this approach is very promising, so far it has been applied only to adsorption and recombination of atoms on model SiO\(_2\) clusters composed of less than 100 atoms. Extrapolation to real conditions is not straightforward due to the complexity of real disordered surfaces containing various defects and impurities. Effects of plasma exposure is yet another complication in real systems.

We conclude that at present mesoscopic approach presents the most useful and reliable way to describe and predict surface reactivity in plasmas.

### 1.3 Mesoscopic modelling of atomic recombination on surfaces

We have described a number of elementary processes that come into play when atoms interact with surfaces. The overall result of this interaction that is observable in the experiment is the loss of gas phase atoms which can be characterized by the **recombination probability** \(\gamma\). By definition \(\gamma\) is the probability that impinging gas phase atoms A will recombine on the surface with the formation of volatile molecular species A\(_2\). It shouldn’t be mixed with the effective loss probability \(\beta\) that takes into account all the processes leading to losses of atoms on the surface (adsorption and recombination). Values of \(\gamma\) for N and O atoms on silica-like surfaces have been intensively measured experimentally. The aim of the modelling is to reproduce experimental results based on the defined set of elementary processes.
Surface reactivity in N\textsubscript{2}/O\textsubscript{2} plasmas

Here we will sum up the main results of the models of atomic recombination on silica-like surfaces developed in [5][26][27][28]. In these models only recombination in the post-discharge is described.

- When the surface is exposed to a flux of atoms, chemisorption sites become almost fully occupied, i.e. 0\textsubscript{S}≈1. This is explained by the fact that chemisorbed atoms leave the surface only via recombination which is a thermally activated process. Population of chemisorption sites is faster (it has no energy barrier) and it compensates losses of chemisorbed atoms.
- Surface recombination takes place between chemisorbed atoms and impinging gas phase atoms (E-R) or diffusing physisorbed atoms (L-H). Recombination between two physisorbed atoms is usually discarded because of a low fractional coverage of physisorption sites. This result breaks down and requires special treatment at very low surface temperatures as it is mentioned in [26].

The exact values of the parameters of elementary surface processes ([S], E\textsubscript{d}, E\textsubscript{D}, E\textsubscript{rec}, v\textsubscript{d}, v\textsubscript{D}, steric factors for chemisorption and recombination) are not known \textit{a-priori}. With an appropriate adjustment of these parameters measured in the experiment, temperature dependence of \(\gamma\) may be reasonably well reproduced by models. For example, variation of the recombination probability \(\gamma\textsubscript{O}\) of atomic oxygen on pyrex as a function 1000/T\textsubscript{wall} measured and modelled in [28] is shown in Figure 1. One can see that \(\gamma\) exhibits a complex non-monotonous temperature dependence. Similar results were obtained in [5] for O and N recombination on silica. The high-temperature branch of the \(\gamma\textsubscript{O}\) dependence on SiO\textsubscript{2} was studied in [34][35] in conditions relevant to the atmospheric re-entry.

![Figure 1. Measured and modelled in [28] recombination probability of O atoms on pyrex at different surface temperatures.](image-url)
Three characteristic temperature regions were distinguished in [28]:

- High temperatures ($T_{wall} > 330$ K): desorption of atoms from physisorption sites is faster than surface diffusion. Only E-R mechanism is efficient. The slope of the dependence of $\gamma$ versus $1000/T_{wall}$ is determined by the activation energy of E-R recombination.
- Intermediate temperatures ($160$ K $< T_{wall} < 330$ K) where both E-R and L-H mechanisms have comparable efficiency.
- Low temperatures ($T_{wall} < 160$ K). Physisorbed atoms have sufficiently long residence time on the surface and L-H mechanism is dominating. The decrease of the value of $\gamma$ with decreasing the temperature is determined by the activation energy of L-H recombination.

We can see that the measured variation of $\gamma_O$ is reproduced reasonably well. But a question may arise: does the model describe the reality or it is just an effective way to fit the evolution of $\gamma_O$ observed in the experiment? Another question which is related to the first one – is the set of parameters of elementary processes obtained from the best agreement with the experiment unique? Regardless a huge number of published experimental and theoretical studies these questions are still open. The reason for this is that the recombination of atoms on the surface is a result of an interplay between many elementary processes. The rates of these processes are generally unknown. Deduction of several parameters from one measured quantity ($\gamma$) is an ill-posed problem from both physical and mathematical viewpoints.

Let us show to what extent the fitting procedure is “unstable” and dependent on the assumptions made about the parameters of the model. Consider for example the high temperature part of $\gamma_O$ in Figure 1. 3. It is well established that at high temperatures only E-R recombination is efficient because physisorbed atoms are immediately desorbed back into the gas phase. This has been recently confirmed by molecular dynamic simulations [35]. The $\gamma_O$ dependence on $1/T_{wall}$ can be well fitted with

$$\gamma_O = a \cdot \exp (-b/T_{wall})$$  

In the mesoscopic model of Kim&Boudart [5], coefficient $b$ is interpreted as an activation energy of ER recombination. In later work of Bedra et.al [35] this coefficient is vaguely called “the total recombination activation energy” and ab-initio calculations performed in the same study show that ER recombination process itself has no energy barrier. Similar barrierless behaviour of recombination reactions $O_{ads}+O$ and $O_{ads}+N$ was found in ab-initio calculations performed in [40]. It is evident that there is a conflict between mesoscopic and microscopic interpretation of the activation barrier for recombination.

Understanding of the pre-exponential factor $a$ is not much better. According to [5], $a = [S] \cdot k^0_{ER}$, where $k^0_{ER}$ is the steric factor for E-R recombination (see expression (1.3)). In principle, both $k^0_{ER}$ and [S] are unknown. If we suppose that $k^0_{ER}=1$ as it was done in [5], expression (1.5) immediately gives the density of chemisorption sites $[S] = a$. However, if we assume $k^0_{ER} \approx 0.1$ as in [27] or [41], higher value of [S] would be estimated. The value of [S]
Surface reactivity in N\textsubscript{2}/O\textsubscript{2} plasmas

gained from the high temperature measurements influences in turn the best fit parameters of L-H processes that come into play at intermediate and low temperatures.

We can see that the description of recombination of one sort of atoms in a gas containing only one sort of molecules is already a difficult task with many unknown parameters. The complexity increases manyfold when we just mix N\textsubscript{2} and O\textsubscript{2}.

1.3.1 Surface kinetics in N\textsubscript{2}/O\textsubscript{2} mixtures

Extension of models for pure gases to mixtures has been done for Pyrex [22], silica-based thermal protection systems [42] and metallic surfaces [43]. According to these models N and O atoms may compete for active sites or even occupy different types of sites. Recombination pathways include formation of O\textsubscript{2} and N\textsubscript{2} as in pure gases but also NO in association between O and N. NO produced on the surface may undergo further heterogeneous reactions forming NO\textsubscript{2} or N\textsubscript{2}O. Theoretical description of the ensemble of these processes requires introduction of a great number of parameters.

1.3.2 Role of plasma exposure

The picture of surface reactivity discussed so far doesn’t take into account any effect of plasma exposure. So what is the possible influence of charged and excited species produced in the plasma on the surface reactivity? In low pressure plasmas, positive ions are accelerated towards reactor walls in the near wall sheath [44] and gain kinetic energy which easily exceeds ~10 eV. This energy is enough to break chemical bonds formed between the surface and chemisorbed species and even between atoms of the material (in quartz bond energy of oxygen atoms is of the order of 5 eV [45]). Therefore, ion bombardment may remove atoms from occupied active sites, create new sites (by creating defects) or even modify structure of the surface. Moreover, ions may activate chemical reaction due to a local supply of thermal energy to the surface. Similar effects are expected from exposure to UV photons and excited species carrying few electron volts of energy.

These examples clearly demonstrate that there is a need for further studies that would limit the number of unknowns and shed light on the role of plasma exposure for mesoscopic description of surface reactivity in N\textsubscript{2}/O\textsubscript{2} plasmas.

Let’s see what types of experimental investigations have been performed so far.
1.4 Surface reactions in N₂/O₂ plasmas: review of experimental studies

A great number of studies of surface catalyzed reactions in N₂/O₂ containing plasmas is available in the literature. Two main groups of processes under investigation may be distinguished:

- Recombination of N and O atoms on surfaces.
- Production/conversion of molecules on the surface.

Most of the studies were performed at low pressures (p ~ 1 mbar) because in low pressure conditions surface processes dominate the overall chemical kinetics of the plasma and the mechanisms of heterogeneous reaction may be investigated in details.

1.4.1 Recombination of O and N atoms on surfaces

Recombination probabilities of oxygen ($\gamma_O$) and nitrogen ($\gamma_N$) atoms on different surfaces have been measured by many authors. As a general rule, the value of $\gamma$ depends on:

- Type of recombining atoms.
- Type of the material. For the same chemical composition of the material there is a dependence on the crystalline structure and surface morphology.
- Pretreatment history.
- Surface temperature.
- Plasma exposure on the surface and conditions in the plasma (pressure, gas mixture).

Catalytic properties of silica-based materials (silica, Pyrex, various glasses) have been studied intensively in connection with atomic sources and thermal protection systems on reusable space vehicles. Several experimental techniques for $\gamma$ determination were employed:

- *Spatial post discharge*. Atoms produced in a discharge are transported by the gas flow outside the plasmas zone and the value of $\gamma$ is deduced from the measured profiles of atomic concentrations. Using this technique recombination probability of O atoms ($\gamma_O$) was determined on silica [33][46] and Pyrex [47] at 300 K and as a function of the wall temperature between 194 K and 1250 K on silica [5][48]; $\gamma_N$ was measured on silica [5][33][49] and Pyrex [50] at different temperatures.
- *Temporal post discharge*. The value of $\gamma$ is deduced from the time evolution of atomic concentrations in a pulsed discharge during plasma OFF phase. Recombination of atoms takes places on the surface that was exposed to the discharge during plasma ON. This technique was used for $\gamma_O$ determination on silica [21][27] and Pyrex [28] [51].
- *Stationary discharge*. Under continuous plasma exposure recombination probabilities are found from the measured gradients of atomic concentration in front of the studied surface or by means of global modelling. This technique was employed for $\gamma_O$
Surface reactivity in N₂/O₂ plasmas

Measurements on silica at high temperatures relevant for re-entry conditions \[34\][35][20] and at 300K \[52\] as well as on Pyrex \[22\][53] at various temperatures.

- **Spinning wall technique:** Recently, a so-called spinning wall technique for the study of surface catalyzed processes in reactive plasmas has been developed by the group of V. Donnelly \[54\]. With this method, a cylindrical section of the wall of the plasma reactor is rotated and periodically exposed to the plasma and then to a differentially pumped mass spectrometer. Using spinning wall technique the products of L-H recombination may be detected 0.5 – 40 ms after plasma exposure. This information is complementary to the measurements of the total recombination probability. Recombination of atomic oxygen on stainless steel, anodized aluminium and SiO₂ using the spinning wall technique was investigated in \[54\][55].

A summary of the published measurements of \(\gamma_N\) can be found in a recent review \[56\]; comparison of the values of \(\gamma_O\) determined by different authors is done in \[46\]. Analysis of the results for silica and Pyrex reveals a significant scatter of the published values depending on the experimental conditions and notably on the technique that was employed for \(\gamma\) determination. For the same material the values of \(\gamma\) measured in stationary discharges or temporal post discharges are systematically higher (by at least one order of magnitude) than those found in the flowing post discharge where there is no contact between the plasma and the studied surface.

In \[27\] it was shown that the effect of plasma exposure on the value of \(\gamma_O\) may persist during many minutes after the end of the wall treatment by a discharge. In \[57\] the effect of O₂ and N₂ plasma pretreatment on the recombination of atomic oxygen on silica and Pyrex surface was studies and interpreted in terms of population and depopulation of surface active sites under plasma exposure. It was suggested that ion bombardment “clean” active sites and increase therefore catalytic activity of the surface, while O atoms passive the surface when they stick to chemisorption sites.

1.4.2 Molecule production/conversion on surfaces

While heterogeneous atomic recombination is a “classical” process that has been studied for several decades, only recently the role of the surface as a source of new molecules in reactive plasmas has been recognized. New molecules may be produced in surface reactions of atoms, for example \((O+N)_\text{wall} \rightarrow NO\) or \((O+NO)_\text{wall} \rightarrow NO_2\). Therefore, losses of atoms and production of new molecules are closely coupled. However, investigation of molecule formation on surfaces requires a special approach because surface terms have to be separated from production of molecules in the gas phase. This is usually done by a combination of measurements of species concentrations with kinetic modelling.

In \[43\][58][59] formation of NO, NO₂ and N₂O in recombining N₂ – O₂ plasmas in a stainless steel vessel at a pressure ~ 0.1 – 1 mbar was investigated. Measured concentrations of N₅Oₓ were compared with the results of a kinetic model. The evidence of NO, NO₂ and N₂O production on the surface was demonstrated. It was shown that molecules are formed in
recombination between mobile adsorbed O, N and NO and impinging gas phase species. A set of sticking coefficients and activation energies for different surface reactions was obtained from the best fit between measured and calculated concentrations.

In [31][32][60][61] molecule formation was studied in a hollow-cathode discharge with NO, NO₂, N₂O and N₂/O₂ used as precursors at a pressure p ~ 1 mbar. An important role of NₓOᵧ production reactions on the stainless steel cathode surface was demonstrated. Probabilities of heterogeneous NO, NO₂ and N₂O formation were obtained from the best agreement between measurements and kinetic modelling.

Recently production of NO from surface recombination of N and O atoms on silica has been evidenced in [33][62]. Measurements of O, N and NO concentrations were performed in a side arm reactor with the wall temperature ranging between 300 K and 1200 K. It was found that the reaction rate of \((N+O)_{wall}\rightarrow NO\) is comparable in magnitude to \((N+N)_{wall}\rightarrow N₂\) and \((O+O)_{wall}\rightarrow O₂\) in the whole temperature range.

Here we conclude that the fact of production and conversion of molecules on the surface in low pressure N₂/O₂/NₓOᵧ plasmas is well established. However, mechanisms of surface reactions in such complex environment are far from being fully understood. First, due to a great number of different elementary processes that take place simultaneously (in [43] 17 recombination reactions on the surface were considered). And second, the rates of surface reactions in cited works are not measured directly but obtained from the best agreement between experiment and simulations. Gas phase kinetics in N₂/O₂ plasmas itself is very complex. For example, in order to describe NO production in air discharge a number of reactions with electronically and vibrationally excited N₂ has to be considered [16][63]. The rates of these reactions are not known with a good precision. Therefore, the “formula”

\[
\text{[Surface Production]} = \text{[Measured Production]} - \text{[Modeled Gas Phase Production]}
\]

is limited in accuracy, although it allows in many cases to evidence the importance of surfaces for molecule production.

1.5 Research questions

In order to get insight into elementary processes in N₂/O₂ plasma – surface interactions simple systems with reduced number of relevant reactions (on the surface as well as in the gas phase) should be studied. Ideally, it would be desirable to isolate and investigate one surface reaction at a time. The objective of this thesis is to investigate chemisorption and reactivity of N and O atoms on oxide surfaces (silica, Pyrex, TiO₂) under plasma exposure. The following question will be addressed:

- Can atoms be chemisorbed? Although introduced in the models, chemisorbed N and O atoms on silica-like surfaces have never been observed experimentally, so this question is the first to be answered.
- What is the coverage of these atoms?
Surface reactivity in N\textsubscript{2}/O\textsubscript{2} plasmas

- What are the main processes of adsorption and desorption?
- How chemisorbed atoms catalyse production of molecules on the surface and participate in surface recombination of atoms?

1.6 Research strategy

In this thesis we will study adsorbed atoms that are sufficiently stable and have a lifetime on the surface of at least few minutes. Therefore, once being adsorbed these atoms remain attached to the surface even after the end of plasma/atomic flux exposure. This opens a way to separate in time the adsorption step and the study of grafted species. We propose the approach which consists in the pretreatment of the surface by N\textsubscript{2} or O\textsubscript{2} plasma followed by probing of the density and reactivity of adsorbed atoms. We must acknowledge that the idea of this approach was inspired by work of G. Cartry \cite{57}, dosing experiments of R. Zijlmans \cite{43} and fruitful discussions with Prof. D. Schram.

The role of the studied surface in our experiments is played by the inner wall of the discharge tube which can be made of silica, Pyrex or silica with a sol-gel film of an oxide catalyst (TiO\textsubscript{2}). For ex-situ surface diagnostics, small samples of the same materials are treated in the discharge in the same conditions as employed for the pretreatment of the reactor surface. Schematically the experimental sequence is shown in Figure 1.4.

![Figure 1.4 Schematic of the experimental procedure.](image)

The so-called “intermediate step” may be just pumping of the reactor or exposure of the pretreated surface to elevated temperatures, UV light or Ar plasma in order to investigate the stability of adsorbed atoms. During the third step the surface is probed in three possible ways:

- **Ex-situ x-ray photoelectron spectroscopy (XPS) analysis.** This diagnostics is mainly applied after N\textsubscript{2} plasma exposure in order to monitor nitridation of SiO\textsubscript{2}.
- **Reactivity of adsorbed atoms under plasma exposure:** after the pretreatment the discharge tube is filled with an alternative gas (for example O\textsubscript{2} after N\textsubscript{2} plasma treatment or \textsuperscript{36}O\textsubscript{2} after \textsuperscript{32}O\textsubscript{2} plasma treatment) and a discharge is started in closed reactor. Molecules produced on the surface in recombination between gas phase and adsorbed atoms are detected using laser absorption spectroscopy or mass spectrometric diagnostics.
- **Reactivity of adsorbed atoms in the post discharge:** after plasma pretreatment a controlled amount of probe molecules (NO, NO\textsubscript{2}, C\textsubscript{2}H\textsubscript{2}) is admitted in the reactor. Losses of these molecules and production of new species on the reactor walls...
catalyzed by adsorbed atoms are monitored by laser absorption and mass spectrometric diagnostics.

In the following chapters we will separately investigate adsorption and reactivity of nitrogen (Chapter 3) and oxygen (Chapter 4) atoms on various surfaces using proposed experimental methods.

1.7 Definitions and notations

In the following chapters we will see that different types of O and N atoms on the studied surface may exist. Here we will give some definitions:

We denote $\text{N}_{\text{ads}}$ and $\text{O}_{\text{ads}}$ – adsorbed atoms that have a residence time on the surface at least $\sim 10^3$ s, so they can be detected in the experimental sequence shown in Figure 1. 4.

We will find that in some conditions there exist sub-groups of stable adsorbed atoms $\text{N}_{\text{ads}}$ and $\text{O}_{\text{ads}}$ that are more reactive; we will use $\text{N}_{\text{ads}}^{\text{weak}}$ and $\text{O}_{\text{ads}}^{\text{weak}}$ to denote these atoms.

For atoms that leave the surface during the pumping of the reactor after the pretreatment we use $\text{N}_{\text{weak}}^{\text{weak}}$ and $\text{O}_{\text{weak}}^{\text{weak}}$. These atoms may be either physisorbed of weakly chemisorbed.

And finally we will see that oxygen atoms belonging to the crystalline network of oxide materials (such as silica or Pyrex) may also contribute to surface reactivity. But we will not use any special notation for these atoms.
2. Chapter II: Experimental setup and diagnostic techniques

2.1 Discharge setup

2.1.1 Reactor and gas system

A dedicated experimental setup for investigation of interaction between low pressure plasmas and catalytic surfaces has been created in the Low Temperature Plasmas group during the PhD works of Olivier Guaitella [64] and Lina Gatilova[65]. With some further modifications and addition of new diagnostics the same setup is used in this study.

Figure 2. 1 shows the view of the setup. Plasma is ignited in a cylindrical reactor of 2 cm inner diameter and 60 cm full length. Discharge tube consists of three parts. Central part has a length of 40 cm and it is installed between two Pyrex sections using specially designed vacuum connections. This part can be easily dismounted. Therefore, reactors made of different materials or containing different catalysts can be studied without any modification of the system. In the present geometry plasma is in contact only with the studied surface what significantly simplifies the analysis of the results. Two fast pneumatic valves isolate the reactor from the rest of the system in order to perform experiments in static conditions with no gas flow. With the low leak rate (3·10⁻⁵ sccm) adsorption/desorption reactions on the catalytic surfaces may be followed during hours without a strong influence of the atmospheric impurities. KBr windows are fixed on each end of the tube allowing infrared laser absorption diagnostics inside the reactor.

![Experimental setup diagram](image)

Figure 2. 1 Experimental setup (1) – interchangeable discharge tube section, (2) – buffer volume, (3) – high voltage electrode, (4) – grounded electrode, (5) – pneumatic valves, (6) – mass-flow controllers
Experimental setup and diagnostic techniques

The vacuum system is pumped using an oil-free scroll pump (Edwards XDS10) to a base pressure of 0.1 Pa. Introduction of working gases is performed using 3 mass flow controllers (10, 100 and 500 sccm). When working in flowing conditions, gas pressure is adjusted by changing the pumping rate using a valve at the reactor outlet. Pure gases Ar, N₂, O₂ with the typical level of impurities <3 ppm and prefabricated gas mixtures containing 1% of NO, NO₂, N₂O, CO, CO₂ or C₂H₂ diluted in argon or N₂ are employed in the experiments.

When reactivity of plasma-pretreated surfaces is studied, it is essential to introduce in the reactor a gas mixture containing a well defined number of probe molecules. The buffer volume is used to prepare the desirable gas mixtures and rapidly inject them in the reactor using the pneumatic valves. Then the valves are closed again and the evolution of the gas phase species may be followed by different in-situ diagnostics. Due to the operation in static conditions with precise dosing of reactive gases we are able to perform experiments with specially pretreated surfaces in which kinetics of gas phase species in a single discharge pulse is investigated.

2.1.2 Pulsed discharge systems

The focus of this thesis is the investigation of surface processes in low pressure N₂/O₂ plasmas. From the view point of the discharge type our objective was to create the plasma in the most simple and well controlled way. For this reason direct current (dc) glow discharge and radiofrequency (rf) capacitively coupled discharge are selected. In this study, pulsed discharge technique is used in order to investigate kinetic processes in plasmas. The advantage of pulsed discharges compared to continuous ones is that processes having different characteristic timescales (electronic excitation, vibrational excitation, dissociation, gas heating, etc..) may be easily controlled and separated by an appropriate selection of the discharge pulse duration.

2.1.2.1 Direct current glow discharge

A pulsed dc glow discharge is ignited by applying a high voltage to a pair of electrodes via a ballast resistor. The schematic of the discharge setup is shown in Figure 2. Power supply consists of a capacitance bank charged by a continuous (0-30 kV) power supply, high voltage pulses are formed using a triggered solid state switch. Positive pulses with the rise time of 1 µs and up to 10 kV in amplitude are obtained. The maximum pulse duration is limited by the energy stored in the capacitance and by the amplitude of the desired discharge current. Discharge current is adjusted by choosing the value of the ballast resistor (R_b=15-70 kΩ) and the applied high voltage.

Electrical diagnostics of the dc discharge consists in the measurements of current and voltage waveforms. The discharge voltage is measured with a high voltage probe (LeCroy PPE20kV). The discharge current is deduced from the voltage drop on an R_m=18.4 Ω series resistor placed between the cathode and the ground. Both current and voltage signals are digitalized.
using an oscilloscope (LeCroy 44Xi, 400 MHz). Typical voltage and current waveforms are shown in Figure 2.3.

Figure 2.2 Schematic of the experimental setup. Both dc and rf discharge power supplies are shown.

![Schematic of the experimental setup](image)

Figure 2.3 Discharge voltage and current waveforms, N\textsubscript{2} p=133 Pa.

The main advantages of using a pulsed dc discharge for investigation of plasma-surface interactions are the following:

- Easy control of the discharge parameters (discharge current, pulse duration).
- Discharge column is homogeneous along the reactor axis – different parts of the discharge tube undergo the same plasma exposure.
- Easy in-situ diagnostics. Homogeneity of the discharge column allows for a number of quantitative in-situ diagnostics (laser absorption, UV absorption). Local species concentrations may be obtained from measurements averaged along the discharge axis.
- Very well studied discharge type. The pulsed dc discharge system used in this work was characterized in the PhD works of O. Guaitella [64] and L. Gatilova [65]. Kinetics of dc discharges in N\textsubscript{2} [66], O\textsubscript{2} [67] and their mixtures [16][63] similar to one used in this study have been intensively investigated in the past and several numerical models
Experimental setup and diagnostic techniques

were created. With these models all the discharge properties may be predicted with a
good precision based on four input parameters: i) discharge tube radius, r i) gas
pressure, p iii) gas mixture iv) discharge current, I. Results of different studies may be
compared due to the existence of scaling laws for dc glow discharges [68].

The conditions of dc discharge operation used in this study and typical plasma parameters
(according to previous studies [63][65][66][67]) are listed in Table 2. 1.

<table>
<thead>
<tr>
<th>Gas</th>
<th>p, [mbar]</th>
<th>i, [mA]</th>
<th>τ [ms]</th>
<th>E/N [Td]</th>
<th>n_e [cm⁻³]</th>
<th>T_e [eV]</th>
<th>P¹ [W/cm³]</th>
</tr>
</thead>
<tbody>
<tr>
<td>N₂</td>
<td>0.53</td>
<td>100</td>
<td>5</td>
<td>120</td>
<td>1.7·10¹⁰</td>
<td>3</td>
<td>0.4</td>
</tr>
<tr>
<td>N₂</td>
<td>1.3</td>
<td>50</td>
<td>5</td>
<td>80</td>
<td>1.1·10¹⁰</td>
<td>1.7</td>
<td>0.3</td>
</tr>
<tr>
<td>O₂</td>
<td>0.53</td>
<td>100</td>
<td>10</td>
<td>60</td>
<td>1.9·10¹⁰</td>
<td>3.8</td>
<td>0.17</td>
</tr>
<tr>
<td>O₂</td>
<td>1.3</td>
<td>100</td>
<td>10</td>
<td>50</td>
<td>2.2·10¹⁰</td>
<td>3.6</td>
<td>0.35</td>
</tr>
</tbody>
</table>

¹P – power density

Table 2. 1 Typical dc discharge conditions used in this study.

2.1.2.2 Radiofrequency capacitive discharge

A capacitive rf discharge is ignited in the same discharge tube. Two copper ring electrodes are
placed on the tube outer surface and driven symmetrically by a 13.56 MHz generator (Sairem
300W) through a specially designed push-pull matching network. The discharge is operated in
either pulsed or continuous mode. Typically, the rf discharge is operated in the same pressure
and gas flow conditions as the dc one. The length of visually homogeneous rf discharge
column is 40 cm and it occupies entirely the interchangeable section of the discharge tube.
The total length of rf plasma column is 50 cm, i.e. the same as in the case of the dc discharge.
The use of a rf discharge in addition to the dc discharge is motivated by several reasons:

- When surface cleaning by plasma is performed it is desirable to use relatively high
  power coupled to the discharge in order to get reproducible results with reasonable
  pretreatment times. Increase of the dc discharge power would inevitably lead to the
  erosion of the electrodes and pollution of the studied surfaces.
- In the experiments on molecules oxidation on plasma pretreated surfaces it was found
  that some molecules react on the metallic dc electrodes. In this case a dedicated
  discharge tube with rf excitation using external electrodes only has to be used.
- The length of the rf discharge column can be easily changed by moving the ring
  electrodes along the discharge tube. Therefore the studied surfaces may be exposed
directly to the discharge or to the flowing afterglow. This allows discrimination
between the roles of ions and neutral radicals in surface reactivity.

Our discharge system is not adapted for detailed electric diagnostics. Grounded surfaces in the
vicinity of the discharge column introduced uncontrolled stray capacitance and the
determination of the rf current flowing in the plasma is not possible. Therefore, the discharge
is characterized by the power absorbed in the plasma. Incident and reflected rf powers are
measured by an in-line power meter placed between the rf generator and the matchbox.
order to measure the power absorbed by plasma, losses in the matching circuit should be taken into account. This was done using the subtraction method \[69\]. First, incident \((P_i^0)\) and reflected \((P_r^0)\) powers as well as the voltage \((U_{RF}^0)\) on the electrodes are measured without plasma (at a pressure too high for the discharge ignition). Without the discharge the difference \(P_i^0 - P_r^0\) represents the losses on the active resistance of the matcher and electrical contacts and therefore it is proportional to \((U_{RF}^0)^2\). When the discharge is ignited, power dissipation in the plasma is calculated as follows:

\[
P_{pl} = (P_i^1 - P_i^0) - (P_i^0 - P_r^0) \left( \frac{U_{RF}^1}{U_{RF}^0} \right)^2
\]

(2.1)

Index “1” corresponds to the measurements with plasma ON, “0” – plasma OFF. Typically, the \(P_{pl}\) is in the range 10-30 W what corresponds to injected power density 0.06 – 0.2 W/cm\(^3\). It was found that \(P_{pl}\) accounts for about 50% of the value of \((P_i^1 - P_r^1)\). Therefore, power losses in the matcher cannot be neglected.

2.2 Diagnostics employed

In this work reactivity of different catalytic surfaces under plasma exposure is studied. We analyze primarily gas phase products of surface catalyzed reactions. Therefore, a number of gas analysis techniques are employed, namely tunable diode laser absorption spectroscopy (TDLAS), ultra-violet (UV) absorption spectroscopy and mass spectrometry (MS). Plasma ON phase is characterized by optical emission spectroscopy (OES) and the production of atomic oxygen in the discharge is studied using two photon absorption laser induced fluorescence (TALIF). Chemical analysis of the surface after plasma exposure is performed using x-ray photoelectron spectroscopy (XPS).

In this section the principles and the experimental implementation of these techniques will be described.

2.2.1 Tuneable diode laser absorption spectroscopy in mid-infrared range

2.2.1.1 Principles of laser absorption spectroscopy

Numerous molecules and radicals exhibit strong absorption features in mid-infrared range (\(\lambda=2.5-25 \mu m\)) corresponding to roto-vibrational transitions within the same electronic state. Availability of tunable lasers and sensitive fast detectors working in mid-IR make laser absorption spectroscopy a powerful tool for in-situ time resolved gas sensing \[70\]|\[71\].

The basic principle of the absorption technique is expressed in the Beer-Lambert law:

\[
\int \ln \left( \frac{I_\nu(L)}{I_\nu(0)} \right) \mathrm{d}v = - \int_0^L k_\nu N(z) \mathrm{d}z \mathrm{d}v = -k(N)L
\]

(2.2)
Experimental setup and diagnostic techniques

where \( I_v(0) \) and \( I_v(L) \) signify the intensity of the incident and transmitted laser radiation at frequency \( v \) passing through the absorbing medium having the length \( L \); \( N \) is the concentration of absorbing molecules per cm\(^3\). Spectral integration is performed over the complete absorption line profile. Spectrally integrated absorption cross section \( k \) can be expressed as follows:

\[
k = \frac{\hbar v_{ik}}{c} B_{ik} g_i e^{-\frac{E_i}{kT}} \left(1 - \frac{g_i n_k}{g_k n_i}\right)
\]

where \( B_{ik} \) and \( v_{ik} \) are the Einstein coefficient and the frequency of the observed transition, \( n_i \) \((n_k)\), \( g_i \) \((g_k)\) are the population and the statistical weight of the lower (upper) level, \( E_i \) is the energy of the lower level and \( Q_{rot}(T) \) is the rotational partition function. From equation (2.5) it follows that the concentration averaged over the absorbing length is actually measured.

In this work, laser absorption measurements are performed directly in the discharge tube. Thus, the absorbing volume has a length of 60 cm, allowing for the detection limits of the order of \(10^{12}\) molecules cm\(^{-3}\) (depending, of course, on the measured species) with a single laser pass inside the reactor. Due to the homogeneity of the discharge along the tube axis, average quantities measured by laser absorption may be considered as a good approximation for the local values of species concentrations.

2.2.1.2 Advantages of laser absorption measurements

Combination of high sensitivity, high time resolution (down to few \(\mu\)s) and possibility of fast acquisition of a sequence of absorption spectra without signal accumulation make tunable laser absorption spectroscopy a unique tool for kinetic studies. It is the only gas sensing technique allowing time resolved in-situ measurements in a single plasma pulse.

2.2.1.3 Pitfalls of laser absorption measurements

When absorption spectroscopy with diode lasers is employed, individual roto-vibrational levels of absorbing molecules are probed \((n_i)\). In order to deduce the total concentration \( N \), the vibrational and rotational distributions of absorbing molecules have to be taken into account. In thermal equilibrium, these distributions are always Boltzmann with the same temperature equal to the kinetic temperature of the gas \((T_g)\). In non-equilibrium conditions which are typical for low temperature plasmas the following ordering of the characteristic temperatures is usually established \( T_g = T_{rot} \leq T_{vibr} \). Even at low pressures (~1 mbar) fast rotational-translational relaxation leads to the equilibrium between rotational and translational degrees of freedom. Formation of non-equilibrium vibrational distributions is observed when vibrations are efficiently excited and the vibrational-translational relaxation is slow.

In order to perform correct measurements during plasma ON phase, the knowledge of the gas temperature is required. An additional complication arises from the fact that temperature
gradients are established between the axis of the discharge and the reactor walls. At constant gas pressure, temperature gradients result in the gradients of the neutral gas density what makes accurate absorption measurements a very difficult task.

In the present study in order to get rid of the undesirable distortions we combine the pulsed discharge technique with time resolved laser absorption measurements. In Figure 2.4 a schematic of a typical behaviour of the laser absorption signal in the presence of gas cooling and vibrational relaxation effects is shown. For correct interpretation of absorption measurements, in every particular case the analysis of the characteristic times of different processes (chemical reactions, gas cooling, vibrational relaxation) should be performed.

![Figure 2.4 A typical behaviour of the absorption signal in a pulsed discharge in the presence of gas cooling and vibrational relaxation effects.](image)

### 2.2.1.4 Diode laser spectrometer

A commercial laser spectrometer (LaserComponents) is used for in-situ monitoring of species in the reactor. A schematic of the laser system is shown in Figure 2.5. The main components of the spectrometer are:

- A **cold head** in which four PbSe diodes cooled by a closed-cycle helium refrigerator are installed. The diodes are kept at a pressure of $10^{-7}$ mbar and cooled down to 10K. Typical operating temperature of the diodes lies in the range 50-120K and it is adjusted by a resistive heating of the copper support on which the diodes are mounted.
- The temperature of the lasers and the driving current flowing through the diodes are adjusted by a PC operated **controller**.
- Typically, led salt diodes are multimode, whereas for quantitative absorption measurements a single mode operation is required. A grating **monochromator** is used to select the desired emission mode of the laser.
- After passing through the reactor the intensity of the laser radiation is measured by a liquid nitrogen cooled **detector** (JudsonJ15D16).
- The detector signal is amplified and then transferred to the PC via a 2 MHz acquisition card (NI PCI 6111). Then the signals are analysed by the **TDL Wintel**
Experimental setup and diagnostic techniques

software that performs fitting of the absorption spectra for concentration determination.

Figure 2. 5 Schematic of the tuneable laser system.

Chirped laser radiation is emitted when a current ramp (~300-600 mA) is applied to the diode. Coarse tuning of the laser frequency is performed by the temperature adjustment (4 cm\(^{-1}\)/K) and fine tuning is achieved by setting the current (less than 0.1 cm\(^{-1}\)/mA). Typical tuning range of each laser is of the order of 20 cm\(^{-1}\) and output laser power is 0.1-1 mW. Commercially available lasers cover the spectral range of 660 – 3250 cm\(^{-1}\). In order to achieve the best detection limits the diodes are selected to match with the most intense absorption features of the species of interest. Therefore, usually for each molecule a specific diode has to be used.

In Figure 2. 6 an example of a diode laser operation for NO detection around 1900 cm\(^{-1}\) is shown. The laser is tuned over approximately 0.2 cm\(^{-1}\) during the current ramp of a total duration of 380 \(\mu\)s. The 20 \(\mu\)s off phase is used to estimate the baseline of the detector. The total pulse repetition frequency is 2.5 kHz (the duty cycle ratio is 95%) what set the limit for the time resolution of the measurements. Several successive laser pulses may be averaged by the TDL Wintel software in order to improve the signal to noise ratio. As a rule, improvement of the detection limits is always performed at the expense of the time resolution. In practice, for NO measurements a typical time resolution was set to 5-20 ms depending on the experimental conditions.

The transmission spectrum of a germanium Fabry-Perot etalon with a known 0.047 cm\(^{-1}\) fringe spacing allows conversion of the time scale of the current ramp (upper panel) into the frequency scale of the absorption spectra (lower panel). The TDL Wintel software performs fitting and integration of the absorption line and the values of the concentration are automatically calculated using the molecular parameters from the HITRAN database [72].
2.2.1.5 Three-channel quantum cascade laser spectrometer

Quantum cascade laser (QCL) is a new type of semiconductor lasers that was theoretically predicted in 1970s in USSR [73] and implemented in 1994 in Bell Laboratories [74]. The laser active region of QCL comprises a periodic series of thin layers of different materials (a so-called super-lattice). A single electron moving through the QCL active region emits a photon every time it travels the distance equal to the period of the super-lattice. Therefore, photons are emitted in a cascade-like manner what gave the name to this type of lasers.

Compared to classical TDLAS quantum cascade laser absorption spectroscopy (QCLAS) has a number of advantages:

- QCLs do not require cryogenic cooling and can operate at (-30..+30) °C with thermoelectric cooling. This reduces significantly the size and the cost of the laser system. Compact size permits combination of several lasers in one system for simultaneous multi species detection.
- Due to the cascade photon emission mechanism the quantum efficiency and hence the output power of QCLs is much higher. This allows utilisation of fast thermoelectrically cooled detectors.
- QCLs emit one single mode and therefore can be used without any mode selectors.
- The pulse repetition frequency of QCLs may reach few hundred kilohertz allowing for μs time resolution.
Regardless their invention about 20 years ago, only recently QCLs have been recognized as a promising tool for plasma diagnostics \[71\]. The group of Prof. Roepke at INP Greifswald are among the first who started design and production of dedicated QCL spectrometers for species concentration measurements in plasmas. A 3-channel TRIPLE Q \[75\] system developed at INP Greifswald is used in this work. The schematic of the TRIPLE Q spectrometer and its optical layout is shown in Figure 2. 7. Compared to led salt diodes QCLs have even smaller tuning range (~7 cm\(^{-1}\)), therefore with three laser system 3 different species can be simultaneously measured. Overlapping of absorption features of some species (CO and N\(_2\)O @ 2200 cm\(^{-1}\), C\(_2\)H\(_2\) and CH\(_4\) @1300 cm\(^{-1}\)) allowed detection of 5 and more different molecules in some cases.

Figure 2. 7 Principle scheme of the TRIPLE Q spectrometer a) control signals  b) optical arrangement (OAP – off-axis parabolic mirror).

QCLs are housed in temperature-stabilised laser heads and operated by pulsed laser drivers (Q-MACS Basic, neoplas control). The divergent laser radiation is collimated using off-axis parabolic mirrors (OAP) and combined in a single laser beam by a telescopic system. This beam is then directed three times through the discharge tube and finally focused onto a fast detector (IRDM-600, neoplas control). The detector module contains a temperature controller specifically adjusted to the detector element (VIGO, PDI-2TE-10/12) and pre-amplifier (bandwidth: 600 MHz, rise time: 2 ns).

The QCLs are operated in a so-called *intra-pulse* mode, i.e. the laser frequency is scanned during a short (100-200 ns) current ramp. In

Figure 2. 8 an example of the absorption spectrum of CO\(_2\) around 2325 cm\(^{-1}\) is shown. The QCL chirp rate is about 0.02 cm\(^{-1}\)/ns and therefore it is tuned over the absorption features of CO\(_2\) in ~ 5 ns. Apart from the fast detector, a high-end digital oscilloscope (1 GHz bandwidth, 10 GS/s sampling rate) has to be used for acquisition of such rapidly changing signals. In the TRIPLE Q arrangement, the 3 lasers are triggered using a combination of pulse generators in such a way that laser pulses arrive on the same detector delayed in time.
Figure 2. 8 a sequence of 3 laser pulses is shown. The maximum time resolution achieved by the TRIPLE Q system is limited by the duty cycle ratio of the QCLs which should not exceed 2% according to the manufacturer specification. Therefore with 100 ns pulse duration, 200 kHz repetition rate (5 μs time resolution) may be reached. For time resolved measurements a train of consecutive pulses is saved in the oscilloscope memory and then analysed on a PC.

![Absorption spectrum of CO$_2$ and etalon](image)

Due to the fast chirp rate of the QCLs, a number of non-linear effects in absorption of laser radiation may be observed [76,77]. Manifestation of the *rapid passage effect* in the overshoot of the absorption signals of CO$_2$ can be seen on Figure 2. 8 a). Rapid passage effect is established when the interaction time between the chirped radiation and a pair of molecular levels is shorter than the relaxation time of the upper level [71]; it vanishes at higher pressures when collisional quenching becomes fast enough. Deformation of absorption lines at low pressure (~10 mbar) makes a direct application of the Beer-Lambert law impossible in QCLAS. Calibration procedure is thus required. In this work, we are interested in the kinetics of small stable molecules having distinct absorption features in mid-IR (NO, NO$_2$, N$_2$O, CO, CO$_2$, C$_2$H$_2$). Therefore, following the procedure described in [71],[78] the intensity of single distorted absorption lines as a function of species concentration is performed by introducing a known amount of molecules in the reactor. Absorption signals are integrated until the point where absorbance turns negative. In Figure 2. 9 the absorption line integration procedure and the result of the calibration for CO$_2$ are shown. Similar procedure is done for CO, C$_2$H$_2$, N$_2$O, NO, NO$_2$. 

![Absorption spectrum with etalon and QCLs](image)
Experimental setup and diagnostic techniques

Figure 2. 9 a) Absorbance ($\ln \left( \frac{I_0}{I} \right)$) for different concentrations of CO$_2$. b) Calibration curve: points – experiment, line – approximation by a third order polynomial.

Table 2. 2 shows a complete list of lasers and detection limits for corresponding species.

<table>
<thead>
<tr>
<th>Molecule</th>
<th>Laser type</th>
<th>Spectral position (cm$^{-1}$)</th>
<th>Detection limit (molecules cm$^{-3}$)</th>
</tr>
</thead>
<tbody>
<tr>
<td>NO</td>
<td>PbSe diode</td>
<td>1900</td>
<td>$10^{12}$</td>
</tr>
<tr>
<td>NO</td>
<td>QCL</td>
<td>1897</td>
<td>$10^{13}$</td>
</tr>
<tr>
<td>NO$_2$</td>
<td>PbSe diode</td>
<td>1629</td>
<td>$10^{12}$</td>
</tr>
<tr>
<td>NO$_2$</td>
<td>QCL</td>
<td>1612</td>
<td>$10^{13}$</td>
</tr>
<tr>
<td>N$_2$O</td>
<td>QCL</td>
<td>2208</td>
<td>$10^{12}$</td>
</tr>
<tr>
<td>C$_2$H$_2$</td>
<td>QCL</td>
<td>1370</td>
<td>$10^{13}$</td>
</tr>
<tr>
<td>CO</td>
<td>QCL</td>
<td>2209</td>
<td>$10^{13}$</td>
</tr>
<tr>
<td>CO$_2$</td>
<td>QCL</td>
<td>2325</td>
<td>$10^{12}$</td>
</tr>
</tbody>
</table>

Table 2. 2 The list of tuneable lasers used in this work.

2.2.2 Time resolved emission and absorption spectroscopy in UV-Vis range.

Optical emission spectroscopy (OES) and broad band absorption spectroscopy are among the most well established techniques for plasma diagnostics. With the advent of multi-element intensified light detectors (iCCD) optical diagnostics of kinetic processes in pulsed discharges with time resolution in the nanosecond scale became a routine and very powerful tool. In this work we use a grating monochromator (Andor Shamrok SR-303i) coupled with a fast intensified CCD camera (Andor iStar) for gas temperature measurements in N$_2$/O$_2$ pulsed DC discharge from the rotational structure of the N$_2$ 2$^+$ system emission. The same spectrometer is used in combination with a broad band UV source for time resolved ozone concentration measurements.
2.2.2.1 Optical emission spectroscopy for gas temperature determination

In the previous sections it was shown that the knowledge of the gas temperature is crucial for correct interpretation of laser absorption measurements in pulsed plasmas. Sometimes variation of laser absorption signals in time may be used for temperature estimation as in \cite{78,79}. However, an independent method for $T_g$ measurements is desirable; one possibility is the analysis of the rotational structure of the $N_2$ 2$^+$ system ($N_2(C^3\Pi \rightarrow N_2(B^3\Pi)$) \cite{80}.

Determination of the kinetic gas temperature from the rotational structure of molecular emission in plasmas is a well known technique that has been applied to the bands of $H_2$ \cite{81}, $O_2$ \cite{82}, $N_2$ \cite{83}, $N_2^+$ \cite{84}, $OH$ \cite{85}, $NO$ \cite{86} and many other molecules and radicals. As we have discussed above, the rotational temperature of the ground state of all the stable species in plasmas is equal to the temperature of the gas even in low pressure conditions. Typically, few collisions are enough to equilibrate rotational and translational temperatures \cite{87}. Therefore, if a molecule has a lifetime in plasma which is longer than the rotational-translational relaxation ($R$-$T$) time $T_g$ and $T_{rot}$ will be in equilibrium. Molecular emission in plasmas originate from the excited electronic states, which have a radiative lifetime ranging from a few tens nanoseconds (for radiative states) up to seconds (for metastable states). If before the emission of a photon an electronically excited state hasn’t suffered enough $R$-$T$ collisions, the structure of the emission will retain the information about how this state was excited. As a rule, at elevated pressures the rotational distribution of electronically excited states has the same temperature as the temperature of the gas. Recently, a spectacular exception to this rule has been discovered in $H_2O$ containing plasmas \cite{88}. It has been shown that even at atmospheric pressure the rotational distribution of $OH(A)$ is not an image of the kinetic gas temperature but it reflects the formation processes. An extremely fast quenching of $OH(A)$ by water molecules has been proposed to explain this effect. Thus, even at atmospheric pressure the creation and loss processes of molecular excited states have to be carefully analyzed for correct $T_g$ determination.

At low pressures the $R$-$T$ relaxation times become of the same order and even greater than the radiative lifetimes. For example, in $N_2$ at 1 mbar the $\tau_{RT} \sim 8 \cdot 10^{-7}$ s while the radiative lifetime of $N_2(C^3\Pi)$ is $\tau_{rad} \approx 4 \cdot 10^{-8}$ s. Therefore, the rotational structure of the $N_2$ 2$^+$ system at 1 mbar is an image of the excitation processes. It has been shown in \cite{83} that even in low pressure conditions the temperature of the gas may be deduced from the rotational structure of the 2$^+$ system if the radiating state is excited predominantly by direct electronic impact. It is argued that light-weight electrons are not able to transfer a significant rotational momentum to a heavy $N_2$ molecule during the excitation process.

$$N_2(X,v',J') + e \rightarrow N_2(C,v'',J'') + e \quad (2.4)$$

Therefore, transitions with a small change of angular momentum are dominant and the rotational distribution of the lower state is copied to the radiative state upon the excitation. Other population processes such as pooling or cascades from higher electronic states lead to
Experimental setup and diagnostic techniques

complex non-Boltzmann distributions of the rotational levels of \( \text{N}_2(\text{C}^3\text{\Pi}) \) and make spectroscopic determination of \( T_g \) impossible. Thus, the validity of the spectroscopic technique should be carefully checked in every particular case.

2.2.2.2 OES setup and data treatment.

Depending on the spectral resolution of the optical system two strategies for spectroscopic data analysis may be used:

- If individual roto-vibrational lines are resolved, \( T_{\text{rot}}^C \) is deduced from a Boltzmann plot of the relative populations of the rotational levels of \( \text{N}_2(\text{C}^3\text{\Pi}) \)[83][89].
- If the rotational structure is not resolved, the experimental spectra are compared with synthetic ones calculated for different \( T_{\text{rot}}^C \) and then the best-fit value of \( T_{\text{rot}}^C \) is deduced.

In our case the second possibility is employed and spectral modeling is performed using Specair [90] software package. The schematic of the experimental setup is shown in Figure 2. 10. The spectra are acquired using a 303 mm focal length spectrograph (Andor Shamrok SR-303i) with an 1800 l/mm holographic grating and an entrance slit of 100 \( \mu \text{m} \). The spectral window that can be recorded without moving the grating is 20 nm and the spectral resolution is 0.2 nm. The most intense \( 2^+ (0-0) \) band at 337 nm is used.

![Figure 2. 10 Spectroscopic setup for \( T_{\text{rot}}^C \) determination in the pulses DC discharge.](image)

Discharge emission is collected by a 60 mm focal length fused silica lens. Time resolved measurements in the pulsed DC discharge are performed by setting the delay of the iCCD gate with respect to the beginning of the discharge. In order to measure the \( T_g \) kinetics in the post-discharge, plasma-induced fluorescence (PIF) technique is employed [21]. Short additional discharge pulses are applied after the end of the main pulse in order to re-excite the \( 2^+ \) emission. Figure 2. 11 illustrates the principle of time-resolved measurements during the main discharge pulse and in the afterglow.
Chapter II

Observation of the discharge emission perpendicular to the tube axis in front of its midpoint is required for PIF measurements. When the gas temperature is decreased after the end of the main pulse, a simultaneous contraction of the volume of the afterglow column takes place due to the constant pressure condition; a fresh cold gas is then pushed in the reactor. Therefore, in the afterglow of the main pulse the gas in the reactor is stratified and when it is re-excited by the secondary pulses emission from the “hot” part only should be collected. The main disadvantage of the radial observation compared to the axial one is that the light from different radial positions is collected and an effective average value of the temperature is measured.

A tubular heater shown in Figure 2.10 is used for experimental validation of the spectroscopic gas temperature determination technique in the conditions of this work. The discharge tube is heated at 300 – 700 K and the gas (pure N\textsubscript{2} or N\textsubscript{2}/O\textsubscript{2}=4/1 at 1.33 mbar) is excited by short (30 \(\mu\)s) discharge pulses; no significant perturbation of the gas temperature could occur on such a short timescale. Using Specair a set of synthetic spectra is calculated for \(T^{C}_{rot}\) in the range 300 – 700 K with 10 K step. Then the best fit value of \(T^{C}_{rot}\) is found using the least-squares method. The uncertainty of the fitting procedure is estimated to be \(\pm 30\) K.

![Figure 2.12](image-url)  
**Figure 2.12** Fitting of experimental spectra using Specair for two different temperatures of the reactor walls. The uncertainty of the \(T^{C}_{rot}\) determination is estimated to be \(\pm 30\) K.
Experimental setup and diagnostic techniques

In Figure 2. 13 values of $T_{rot}^C$ are compared with the experimentally measured temperatures of the discharge tube walls. One can see that a good general agreement is obtained, especially for $T_{wall} > 400$ K. For lower temperatures an overestimation by about 50 K can be seen. Nevertheless, we conclude that in the conditions of our pulsed DC discharge at mbar pressure $T_{rot}^C$ gives a good estimation of the neutral gas temperature.

![Figure 2. 13 Comparison between the rotational temperature of N$_2$(C) obtained using the Specair fitting and the temperature of the reactor walls. The gas mixture in the reactor is pure nitrogen or air at 1.33 mbar, discharge pulse duration is 30 μs.](image)

2.2.2.3 Time resolved measurements of ozone concentration

The same spectroscopic system is employed for time resolved in-situ measurements of ozone concentration by absorption in Hartley band centred at 253.7 nm. This time a 600 l/mm grating is used allowing for a spectral interval of 70 nm to be recorded by the iCCD. Fused silica windows are fixed on each end of the tube and a deuterium tungsten halogen lamp (Ocean Optics DH-2000) is used as a broad-band UV source. Measurements are performed in the afterglow of a pulsed discharge and ozone kinetics is studied by setting the iCCD gate with respect to the discharge end. For every given delay absorption spectra are averaged over 100 discharge pulses.

The absorption cross section of ozone is taken from [91] and [O$_3$] is deduced from the fitting of experimental spectra. In Figure 2. 14 an example of the fit for [O$_3$]=2.65·10$^{14}$ cm$^{-3}$ is shown. Minimum detectable absorbance in this experiment is ~0.001 which corresponds to the O$_3$ detection limit of the order of 10$^{12}$ cm$^{-3}$. 
2.2.3 TALIF measurements of atomic oxygen.

Laser induced fluorescence techniques are widely employed for time and space resolved measurements of absolute species concentrations in plasmas [92][93][94][95]. For LIF detection of atomic ground states (O, N, H, etc) VUV photons are required, what present a big complication from the experimental view point. Consequently, a non-linear two photon absorption laser induced fluorescence (TALIF) technique is usually used. The efficiency of 2-photon absorption is relatively small and excitation with focused laser radiation should be performed in most cases. This implies a good space resolution which is limited by the dimensions of the focus. Absolute calibration of TALIF measurements using noble gases has been proposed in [93].

2.2.3.1 Principles and calibration of O TALIF measurements.

The scheme of the 2-photon excitation and subsequent emission for O and Xe atoms is shown in Figure 2. 15. Calibration is based on the reference measurements with a known concentration of Xe. TALIF signals of both O and Xe should be measured with the same spatial and temporal intensity distribution of the laser radiation. This condition is best satisfied when the 2-photon transitions are spectrally as close as possible what determines the choice of the calibration partner.

In normal conditions the intensity of the fluorescence scales as a square of the excitation laser intensity. However, a number of non-linear effects [96] (step-wise ionization, depletion of the ground state population and stimulated emission) may significantly alter the normal behaviour.
Experimental setup and diagnostic techniques

when the laser intensity is increased. Therefore, for calibration the laser power should be kept as low as possible.

\[ n_0 = s \frac{Y_{Xe}}{\gamma_0} \frac{A_{ik}(Xe)}{A_i(Xe) + Q(Xe)} \frac{A_i(O) + Q(O) \sigma^2(Xe)}{\sigma^2(O)} \frac{I_F(O)}{I_F(Xe)} n_{Xe} \]  \hspace{1cm} (2.5)

where \( s \) is the statistical factor accounting for the splitting of the O ground state, \( \gamma \) is the relative detection efficiency of the optical system at the corresponding fluorescence wavelength. \( A_{ik}, A_i \) and \( Q \) stand for the Einstein coefficient of the fluorescence transition, spontaneous emission and quenching rate of the excited state. \( \sigma^2 \) is the 2-photon excitation cross section and \( I_F \) is the temporally and spectrally integrated fluorescence intensity. All the required atomic data can be found in the literature [92].

2.2.3.2 Laser setup

The schematic of the laser setup is shown in Figure 2. 16. Tuneable laser radiation at 225 nm is generated by frequency doubling the 450 nm output of a dye laser (Sirah, Coumarin 2 dye) pumped by the third harmonic of a pulsed Nd:YAG laser (Quanta-Ray). Up to 1.5 mJ with pulse duration of 5 ns at a repetition rate of 10 Hz are obtained. The laser energy is monitored by a pyroelectric detector equipped with a signal amplifier. The laser beam is focused into the discharge tube by an \( f = 300 \) mm fused silica lens. Oxygen and xenon fluorescence signals are collected by an \( f = 60 \) mm lens on a Hamamatsu R3896 photomultiplier equipped with an interference filter centred at 840 nm. The PMT signal is digitalized by an oscilloscope.
Chapter II

(LeCroy Weverunner, 1GHz) and analyzed on a PC by a LabView routine. Time resolved fluorescence signals of Xe (0.13 mbar) and O are shown in Figure 2. 17.

![Schematic of the TALIF setup.](image)

Figure 2. 16 Schematic of the TALIF setup.

![Time-resolved fluorescence signals of Xe and O.](image)

Figure 2. 17 Time-resolved fluorescence signals of Xe and O.

Two types of TALIF measurements are typically performed. When the absolute concentration of atomic oxygen is measured, the frequency of the laser is scanned over the two-photon excitation resonance and time-integrated fluorescence signals are recorded for each spectral position of the laser. Two-photon excitation line profiles of O and Xe recorded in such way are shown in Figure 2. 18. The value of $I_F$ is obtained by spectral integration of the lines. Using the described technique the absolute calibration of TALIF measurements is performed with the laser energy of 17 $\mu$J/pulse. According to literature data [92] (where similar laser focusing optics was used) we expect that at 17 $\mu$J/pulse both Xe and O TAIF signals are in normal excitation regime and saturation effects are negligible.
Experimental setup and diagnostic techniques

Once the calibration is performed, the relative measurements of the O density with respect to the calibration conditions are done with higher laser energy (typically 100-200 μJ/pulse). This allows better detection limits due to the increase of the fluorescence intensity. In [92] it is shown that the saturation effects in two-photon excitation of O start to play a role starting from the laser energy of the order of 150 μJ/pulse in conditions similar to ours. Anyhow, the relative measurements may be performed even when the saturation effects are important. The essential is that the TALIF intensity is linearly proportional to the concentration of O, which holds true in a broad range of laser energies [94]. The relative error of absolute O concentration measurements was estimated to be 30%.

For kinetic measurements of [O], the wavelength of the laser is set to the maximum of the excitation line profile. Then the time integrated intensity of the fluorescence is measured with variable delay between the discharge beginning/end and the laser pulse. This technique allows, for example, measurements of the O lifetime in the afterglow of a pulsed DC discharge in O2.

2.2.4 Mass spectrometric gas analysis

One of the disadvantages of the laser absorption technique described in the previous sections is that the species that can be monitored are exclusively molecules having dipole allowed transitions in mid-IR. In addition the number of simultaneously detected molecules is limited due to the narrow tuning range of the lasers. In order to get information about the complete gas composition in the reactor including atomic and homonuclear gases, a quadrupole mass spectrometer (QMS) is used in this work.

A quadrupole residual gas analyzed Pfeiffer PrismaPlus 0-100 a.m.u. equipped with an open ion source and a secondary electrons multiplier is mounted on a separate vacuum vessel.
pumped down to $10^{-9}$ mbar by a turbo molecular pump. Using this simple system, species having the mass difference $\Delta m = 1$ a.m.u. can be easily distinguished. The optimum operating pressure of the MS is $10^{-6} - 10^{-5}$ mbar; a leak valve (UDV 040) is used in order to introduce the gases from the reactor into the MS chamber. For absolute measurements of stable species concentrations a calibration of the MS is performed using gas mixtures having a known composition. Concentrations are always measured with respect to the number density of the carrier gas (Ar, N$_2$ or O$_2$). The limit of detection for different species depends strongly on the carrier gas and mutual mass interferences, typically it is found in the range 10-100 ppm.

In Figure 2.19 mass spectra and a calibration graph for C$_2$H$_2$ are shown. After the correction of the MS background the calibration is described by a straight line going through the origin.

![Mass spectra of C$_2$H$_2$ in Ar for (0.01 – 1)% C$_2$H$_2$](image1.png)

![Calibration graph showing the number density ratio [C$_2$H$_2$]/[Ar] as a function of the ratio of MS signals at m=26 and 40 a.m.u respectively.](image2.png)

Figure 2.19 a) Mass spectra of C$_2$H$_2$ in Ar for (0.01 – 1)% C$_2$H$_2$ b) calibration graph showing the number density ratio [C$_2$H$_2$]/[Ar] as a function of the ratio of MS signals at m=26 and 40 a.m.u respectively.

Time resolution of the mass spectrometric measurements is limited by the time of the gas sampling through a 3 mm i.d. tube that connects the reactor with the inlet valve of the MS, which was of the order of 10 s. However, for investigation of processes that take place in the gas phase and on the surface, much better effective time resolution can be achieved by using a pulsed dc discharge. Typically in our experiments, we apply a short (few milliseconds long) discharge pulse to a gas mixture in static conditions and then perform measurements with the mass spectrometer. This approach doesn’t allow a distinction between processes that take place during plasma ON and in the post discharge. But we will see that it permits to follow the kinetics of adsorption and desorption of atoms on the surface under plasma exposure.

### 2.2.5 XPS surface diagnostics

X-ray photoelectron spectroscopy (XPS) is a quantitative technique for probing the elemental composition and the bonding of different materials. XPS spectra are obtained by irradiating a material with a beam of monochromatic x-rays. The kinetic energy and the flux of electrons that escape from the material surface layer are measured in ultra high vacuum conditions.
Experimental setup and diagnostic techniques

In this work we use the XPS facility of the Rhur University of Bochum for the analysis of silica surface exposed to different low pressure plasmas. XPS analysis is performed using a Versaprobe spectrometer from Physical Electronics (PHI 5000 VersaProbe) with monochromatic Al Kα (1486.6 eV) radiation and spectral resolution of 0.35 eV. In order to avoid positive charge build up in case of non-conducting samples, a low energy electron an $\text{Ar}^+$ beams are directed on the analysed surface. The detection limit of the XPS system is typically of the order of 0.1 at. % and the depth of the probed surface layer is \( \sim 2 \text{ nm} \).

2.2.6 Summary on used diagnostics

In this study we employ essentially diagnostics for probing gas phase species which are summarized in Table 2.3.

<table>
<thead>
<tr>
<th>Technique</th>
<th>Species</th>
<th>Time resolution</th>
<th>Detection limit [cm(^{-3})]</th>
<th>In-situ</th>
</tr>
</thead>
<tbody>
<tr>
<td>TDLAS</td>
<td>NO, NO(_2)</td>
<td>5 ms</td>
<td>10(^{12})</td>
<td>Yes</td>
</tr>
<tr>
<td>QCLAS</td>
<td>C(_2)H(_2), CO, CO(_2), N(_2)O</td>
<td>5 µs</td>
<td>10(^{12}) - 10(^{13})</td>
<td>Yes</td>
</tr>
<tr>
<td>UV-abs</td>
<td>O(_3)</td>
<td>2 ms</td>
<td>10(^{12})</td>
<td>Yes</td>
</tr>
<tr>
<td>TALIF</td>
<td>O</td>
<td>200 ns</td>
<td>10(^{13})-10(^{14})</td>
<td>Yes</td>
</tr>
<tr>
<td>QMS</td>
<td>all stable m=1 – 100 amu</td>
<td>(\sim) few ms</td>
<td>10(^{13})-10(^{14})</td>
<td>No</td>
</tr>
</tbody>
</table>

Table 2.3 Summary on used diagnostics
3. Chapter III: Adsorption and reactivity of N atoms on silica surface under plasma exposure

3.1 Introduction

At present the information on the mechanisms of interaction between nitrogen atoms and silica-like surfaces is obtained from the studies of N losses on the surface. Regardless a great number of works devoted to the investigation of atomic recombination there is still a lot of uncertainty. Recombination probabilities of atomic nitrogen on silica-like surfaces measured by different authors span over 5 orders of magnitude $\gamma_N = 5 \cdot 10^8 - 2 \cdot 10^3$ [56][97]! Even the kinetic order of the recombination reaction is not well established, in different studies the first [5] [98] or the second [99] [100] order in N density is proposed. The role of plasma exposure is also barely understood, it is only known that treatment of the surface by N$_2$ plasma enhances the value of $\gamma_N$ by about an order of magnitude [97] [101].

The approach developed in this chapter is complementary to the recombination studies. We investigate stable N atoms that are adsorbed on the surface. According to existing models of surface recombination[5][26], chemisorbed N atoms are the main sites for N recombination on silica-like surfaces. Therefore, by characterizing the coverage and the reactivity of N$_{ads}$ we can get an insight in the mechanism of atomic recombination on the surface.

Speaking more generally, our aim in this chapter is to understand how N$_{ads}$ participate in the production of molecules on silica-like surfaces in contact with N$_2$/O$_2$ plasmas and afterglows. We will investigate therefore formation of N$_2$ on the surface in recombination process N$_{ads} + N$ and formation of NO in reaction N$_{ads} + O$.

3.1.1 Experimental procedures

Here we employ the experimental approach outlined in Chapter 1 that consists in the pretreatment of silica surface by N$_2$ plasma followed by the study of grafted N species. Typically, the pretreatment is performed using a rf discharge in flowing nitrogen. Standard discharge parameters during the pretreatment are shown in Table 3.1. In the same table standard conditions for treatment with O$_2$ and Ar plasmas are listed.
Adsorption and reactivity of N atoms

<table>
<thead>
<tr>
<th></th>
<th>N₂</th>
<th>O₂</th>
<th>Ar</th>
</tr>
</thead>
<tbody>
<tr>
<td>Pressure (mbar)</td>
<td>0.53</td>
<td>0.53</td>
<td>0.27</td>
</tr>
<tr>
<td>Gas flow (sccm)</td>
<td>10</td>
<td>10</td>
<td>10</td>
</tr>
<tr>
<td>P_{pl} (W)</td>
<td>17</td>
<td>16</td>
<td>13</td>
</tr>
</tbody>
</table>

Table 3.1 Standard discharge conditions for N₂, O₂ and Ar plasma pretreatments.

After the pretreatment we probe the surface trying to answer the following questions:

- What is the coverage of adsorbed N atoms?
- What is their role in surface recombination of N?
- What is their role in production of NO on the surface?

Three types of experimental techniques were employed:

- **XPS analysis.** Small silica samples were placed on the inner surface of the discharge tube and pretreated in standard conditions for different time intervals. Pretreated samples were removed from the reactor and analyzed *ex-situ* using x-ray photoelectron spectrometer at Ruhr University Bochum. The samples are made of the same material as silica discharge tube and they experience the same plasma pretreatment. Therefore, with this experiment we investigate the modification of the chemical composition of the inner surface of silica discharge tube after different plasma exposures and determine the number of N atoms grafted to the surface.

- **Reactivity of N_{ads} under \textsuperscript{30}N₂ plasma exposure.** XPS diagnostics gives insight into the density and binding configuration of adsorbed species, but not about their ability to produce molecules on the surface. To investigate the reactivity of N_{ads} we should look at the products of surface catalyzed reactions. In the first instance silica surface pretreated by \textsuperscript{28}N₂ plasma was exposed to a discharge in heavy nitrogen isotope \textsuperscript{30}N₂. Molecules \textsuperscript{14}N\textsuperscript{15}N produced on the surface and detected in the gas phase by a mass spectrometer carry information about surface recombination processes in N₂ plasma. By measuring the absolute density of \textsuperscript{14}N\textsuperscript{15}N in the gas phase we determine the initial coverage of \textsuperscript{15}N_{ads}.

- **Reactivity of N_{ads} under O₂ plasma exposure.** The pretreated surface containing N_{ads} was exposed to a pulsed discharge in O₂. Production of NO molecules from surface recombination (O+N_{ads})\textsubscript{wall} was monitored using laser absorption spectroscopy. This experiment provides two types of information: (i) first, NO production is an alternative way to probe the density and reactivity of N atoms adsorbed on SiO₂ under N₂ plasma exposure (ii) second, kinetics of NO formation in recombination between O and N_{ads} gives an insight in the mechanism of NO production on the surface in N₂/O₂ plasmas.
3.2 Determination of the coverage of $N_{\text{ads}}$: XPS study

3.2.1 Dynamics of N adsorption on SiO$_2$

Small (10mm × 10mm × 5 mm) silica samples were placed on the inner surface of silica discharge tube. First they were cleaned by rf O$_2$ plasma at $p=0.53$ mbar and $P_{\text{pl}}=16$ W and then by Ar plasma at $p=0.26$ mbar and $P_{\text{pl}}=13$ W. As we will see later, after this cleaning procedure the surface is free from adsorbed nitrogen and oxygen atoms. This is the standard initial condition for surface pretreatment with N$_2$ plasma. Clean samples were treated during 1–360 min by a flowing capacitive rf discharge in N$_2$ in standard conditions.

For each sample a low resolution survey XPS spectrum was taken to determine the most important elements. Survey spectra of just cleaned sample and samples treated during 1, 25 and 360 minutes are shown in Figure 3. 1. One can see the peaks corresponding to silicon Si(2s, 2p) and oxygen O(1s) coming from SiO$_2$ structure. Appearance of carbon C(1s) is due to the pollution during the exposure to the ambient air before analysis and nitrogen N(1s) appears due to N$_2$ plasma exposure.

![Figure 3.1 Survey XPS spectra of SiO$_2$ samples just cleaned and treated by N$_2$ plasma in standard conditions during 1, 25 and 360 minutes.](image)

For relative concentration measurements high resolution XPS spectra (0.35 eV resolution) of the main peaks were recorded. Figure 3. 2 shows high resolution spectra of Si2p, O1s, N1s and C1s in the sample that was treated by N$_2$ plasma during 25 minutes. Spectra were analysed using Unifit software and the relative concentrations of species were obtained from integrated peak areas using known sensitivity of the XPS spectrometer.
Adsorption and reactivity of N atoms

Figure 3.2 High resolution XPS spectra of silica sample treated during 25 min by N₂ plasma in standard conditions. Four panels show the main peaks – Si(2p), O(1s), N(1s) and C(1s). Blue curves represent the result of fitting using Unifit software. Concentrations of elements in relative atomic percent are inscribed on the graphs.

One can see that N(1s) consists of two peaks at 398.7 eV and 403.7 eV. Similar double-peak structure of N(1s) has been previously observed in [17][102] in nitried SiO₂ thin films. The peak at 398.7 eV is usually assigned to Si3≡N configuration in which every N atom is bonded with three silicon atoms, such as in Si₃N₄ [17][102]. According to [102] the second peak at 403.7 eV may be assigned to Si-NO₂ binding configuration; but in [103] this peak was attributed to free molecular-like N₂ in the SiO₂ lattice. Whatever is the exact binding structure of nitrogen on the surface, spectra shown in Figure 3.2 prove that N atoms are not simply chemisorbed on SiO₂, but nitridation of silica surface takes place under N₂ plasma exposure. Nitridation of SiO₂ thin films in N₂ plasma is a known phenomenon from microelectronics technology [17] but it is completely overlooked in studies of atomic recombination on the surface.

Figure 3.3 shows the evolution of relative atomic concentrations of Si, O and N as a function of the pretreatment duration. After 1 minute of N₂ plasma treatment no detectable incorporation of N is observed and the measured composition of the sample is the same as in
pure SiO$_2$ ([Si]/[O]=1/2) within the experimental uncertainty. For longer pretreatment times the concentration of nitrogen increases and the composition of the surface layer can be approximately described by the formula SiO$_2$$_{2x}$N$_x$. This means that nitrogen atoms replace oxygen on the surface while the concentration of silicon stays constant. After 6 hours of plasma exposure $x\approx1$, i.e. approximately 50% of O atoms in the layer probed by XPS are replaced by N. According to [17], the escape depth of photoelectrons in SiO$_2$ is $\lambda_{SiO2}=24.2$ Å. This means that the measured composition is an average over several atomic layers and it is quite probable that the outmost layer may be composed of pure Si$_3$N$_4$ containing no oxygen at all.

One can see that the rate of nitridation varies a lot during the plasma exposure. Within the first 25 minutes the same amount of N is incorporated in the surface as during the following 330 minutes. This may be explained by a fast nitridation of the superficial layer followed by much slower penetration of N deeper under the surface.

Using the data from [17] the absolute surface density of N in the silicon oxynitride layer may be estimated based on the XPS measurements. With the known concentration of atomic oxygen in SiO$_2$ ([O]=4.4·10$^{22}$ cm$^{-3}$) and the escape depth of photoelectrons $\lambda_{SiO2}=24.2$ Å the surface density of oxygen atoms in the layer probed by x-rays was estimated to be $[O]=1.06·10^{16}$ cm$^{-2}$. This allowed the absolute calibration of the atomic concentrations measured by XPS. The right hand axis in Figure 3. 3 represents absolute atomic concentrations obtained in this way.

It should be noted that absolute calibration is justified only for smooth surfaces and it may give some error for real rough samples.

---

Figure 3. 3 Relative atomic concentrations of O, Si and N in SiO$_2$ sample after different duration of N$_2$ plasma treatment. The right axis gives an estimation of the absolute surface densities of species (for more details see the text).
Adsorption and reactivity of N atoms

3.2.2 Species responsible for nitridation: ions or neutrals?

In order to estimate the relative role of ions/neutrals in the nitridation process a silica sample was placed in the flowing post discharge zone. The gas transit time between the end of the discharge zone and the position of the sample was ~ 50 ms. This time is shorter than the typical lifetime of N with respect to surface recombination on silica (~200 ms) [5]. Therefore, significant fraction of atomic nitrogen is still remaining in the position where SiO\textsubscript{2} sample is placed. Vibrationally excited N\textsubscript{2} molecules having the lifetime of the order of 100 ms in our conditions may also be present.

After 75 minutes of the post discharge exposure the measured concentration of N in the sample was only 0.2 at % while under direct plasma exposure the same duration of the pretreatment gave [N] = 18 at %. Therefore, bombardment with ions and short lived excited species is mainly responsible for nitridation of SiO\textsubscript{2}. Nitrogen atoms alone are inefficient for nitridation. This result is in agreement with observations of [17], where it was shown that the density of N atoms in the N\textsubscript{2} plasma nitrided SiO\textsubscript{2} is proportional to the number of incident nitrogen ions.

Silica samples were pre-treated in the positive column of the rf discharge, far from electrode zones. Thus, only low energy ions (with energies of the order of ~10 eV) are expected to arrive on the surface [44]. However, even in such mild conditions ion bombardment has a strong impact on the surface. This is confirmed by observed nitridation of SiO\textsubscript{2}.

Another striking observation was made in a SiO\textsubscript{2} sample just treated by Ar plasma. In the XPS spectrum of this sample shown in Figure 3. 1 a peak around 240 eV can be seen, which is assigned to Ar(2p) [104]. Argon atoms do not form chemical bond with SiO\textsubscript{2}, what means that they are implanted in the sample under Ar plasma exposure. Implantation of noble gases under ion beam bombardment is well documented, but for ion energies in the range of keV [105]. Observation of Ar implantation confirms previous conclusion about the important role of ion bombardment of SiO\textsubscript{2} surface in the conditions of this study.

3.2.3 Reactivity of SiO\textsubscript{x}N\textsubscript{y} under plasma exposure

Here using XPS diagnostics we investigate stability and reactivity of silicon oxynitride layer under plasma exposure. First, silica samples were pre-treated in standard conditions by N\textsubscript{2} plasma during 75 minutes. On the second step the samples were exposed to oxygen or argon plasma in standard conditions (see Table 3.1) for various time duration. The results of XPS measurements of relative atomic concentration of nitrogen after different sequences are summarized in Table 3. 2. One can see that 1 hour of O\textsubscript{2} or Ar plasma is enough to remove SiO\textsubscript{x}N\textsubscript{y} layer almost completely. Concentrations ~0.4 – 0.5 at % measured after long cleaning periods are close to the detection limit of the XPS spectrometer.
### Table 3

<table>
<thead>
<tr>
<th>Gas</th>
<th>Duration</th>
<th>[N] at %</th>
</tr>
</thead>
<tbody>
<tr>
<td>just pre-treated by N₂ plasma</td>
<td>18</td>
<td></td>
</tr>
<tr>
<td>O₂</td>
<td>1 min</td>
<td>4.4</td>
</tr>
<tr>
<td>O₂</td>
<td>60 min</td>
<td>0.4</td>
</tr>
<tr>
<td>O₂</td>
<td>120 min</td>
<td>0.4</td>
</tr>
<tr>
<td>Ar</td>
<td>60 min</td>
<td>0.5</td>
</tr>
</tbody>
</table>

Table 3. Concentration of atomic N in silica samples treated by N₂ plasma during 75 minutes followed by O₂ or Ar plasma exposure for different time intervals.

Figure 3.4 shows high resolution XPS spectra of N(1s) in samples that were exposed to O₂ plasma during 1 and 60 minutes after 75 minutes of N₂ plasma pretreatment. According to the absolute calibration shown in Figure 3.3 during 1 minute of O₂ plasma exposure about $2 \cdot 10^{15}$ nitrogen atoms per cm$^{-2}$ are removed from the surface. This proves that N atoms that form SiO$_2$N$_y$ layer are reactive when exposed to O₂ or argon plasma.

![Figure 3.4 XPS spectra of N(1s) doublet in SiO$_2$ samples pre-treated by N$_2$ plasma during 75 min (——) followed by 1 min (——) and 60 min (——) of O$_2$ plasma.](image)

It is interesting to note that the peak at 398.7 eV disappears much faster than the one at 403.7 eV. After 60 minutes of O₂ only this high energy peak is observed. Therefore, N atoms corresponding to the low energy peak are more reactive. This observation is coherent with the assignment of the peaks that was made above. Superficial nitrogen that forms Si$_3$N$_4$ on the surface (398.7 eV peak) is more reactive than molecular-like nitrogen trapped in the SiO$_2$ lattice (403.7 eV peak).
**Adsorption and reactivity of N atoms**

The mechanism of SiO$_2$N$_y$ layer removal under Ar plasma exposure is not clear. It may be due to argon ion bombardment or due to reactions with oxygen atoms coming from trace (~1 ppm) amounts of O$_2$ and H$_2$O in argon gas.

We have seen that SiO$_2$N$_y$ formed by N$_2$ plasma pretreatment is reactive under O$_2$ plasma exposure. It is interesting to check what happens if both N$_2$ and O$_2$ are present in the discharge simultaneously. A pretreatment of silica sample by air (N$_2$/O$_2$ = 80/20) plasma during 75 min at p=0.53 mbar and $P_{pl}$=16W was performed. The concentration of N measured in this case was rather low $[N]=0.5$ at % and only high energy peak at 403.7 eV was observed. Therefore, the presence of oxygen in plasma inhibits formation of the Si$_3$N$_4$ layer on SiO$_2$ surface. However, some minor incorporation of molecular-like N$_2$ still takes place due to the bombardment by nitrogen ions.

### 3.2.4 Conclusions on XPS study

In this section we have applied ex-situ XPS diagnostics in order to investigate the state of the surface of silica discharge tube after different plasma exposures. We have found that:

- Under N$_2$ plasma exposure nitridation of SiO$_2$ takes place. Nitrogen atoms replace oxygen atoms on the SiO$_2$ surface and SiO$_x$N$_y$ layer is formed. The surface density of N atoms in SiO$_x$N$_y$ layer after 60 min of N$_2$ plasma pretreatment is $3\cdot10^{15}$ cm$^{-2}$, i.e. of the order of one full monolayer,

- The nitridation is driven by ion bombardment and it doesn’t take place when SiO$_2$ is exposed to a neutral flow containing N atoms (or at least it is much less efficient). At present we cannot specify the exact role of ions; bombardment with N$_2^+$ ions may either directly lead to nitridation of SiO$_2$ or just activate the incorporation of N atoms. To distinguish between these pathways experiments with independent ion and atomic beams should be performed.

- Silicon oxynitride layer is removed when it is exposed to O$_2$ or Ar plasma. Nitrogen atoms that are more reactive under O$_2$ plasma contribute to the characteristic peak at 398.7 eV in the XPS spectrum which is usually assigned to Si$_3$N$_4$ structure.

Our results demonstrate that the simplified vision of recombination of N atoms on a “static” SiO$_2$ surface is not applicable in the case of direct N$_2$ plasma exposure. In reality the outmost surface layer is continuously modified due to bombardment with ions and N atoms. Nitrogen atoms are not chemisorbed on sparse active sites, but form a SiO$_x$N$_y$ layer that after long exposure time may contain equal amounts of N and O atoms.

Generally speaking, in the case of SiO$_x$N$_y$ formation the term “chemisorption” has to be clarified. Can we consider N atoms in the SiO$_x$N$_y$ layer as chemisorbed? On the one hand, the answer is positive, because these atoms are chemically bonded with the atoms of the surface. On the other hand it is known from the literature [17] that on SiO$_2$ the thickness of the layer nitrided by N$_2$ plasma may reach 2-3 nm. It would be unjustified to use the term “chemisorbed” for N atoms implanted in the material; by definition chemisorption takes place on the surface, but not in the material bulk.
Probably, the most appropriate term that should be used in this case is sorption which includes surface adsorption and incorporation of atoms. Nevertheless, we could not find in the literature any example of the use of this term in relation to surface reactivity in plasmas. In order to avoid any misleading of the readers we will continue to use the word adsorption but keeping in mind that it may also infer incorporation of N atoms within 2-3 nm layer on the SiO$_2$ surface. We will use terms grafted or adsorbed N atoms to describe all the stable nitrogen atoms present on the silica surface treated by N$_2$ plasma.

3.3 Reactivity of N$_{ads}$: Isotopic study

In the previous section we have evidenced adsorption of nitrogen atoms on SiO$_2$ using XPS diagnostics. Do these atoms participate in surface-catalyzed reactions in N$_2$ plasma? To answer this question, N$_{ads}$ should be characterized from the viewpoint of their reactivity. XPS diagnostics is not sensitive to the reactivity of adsorbed species; therefore, in addition to a classical surface diagnostics a different technique capable of probing the reactivity of N$_{ads}$ has to be applied. In this section we develop a new experimental approach that uses the isotopic exchange $^{14}$N$\leftrightarrow^{15}$N on the surface under plasma exposure. With this method we detect in the gas phase the products of surface reactions catalyzed by adsorbed N atoms and thus get information about the reactivity of N$_{ads}$.

3.3.1 Experimental details

The employed experimental procedure is shown schematically in Figure 3. 5. First, the silica discharge tube was pre-treated by $^{28}$N$_2$ plasma in standard conditions. Then the reactor was pumped during 10 minutes to remove gas phase $^{28}$N$_2$ and to let the wall cool down to the room temperature. Then the tube was filled with $^{30}$N$_2$ (Sigma-Aldrich, 98 at % $^{15}$N) at 0.53 mbar and an rf discharge (probe discharge) with standard parameters was started in closed reactor for various time duration. Grafted $^{14}$N atoms react under $^{30}$N$_2$ plasma exposure leading to appearance of $^{29}$N$_2$ and $^{28}$N$_2$ in the gas phase. Mass spectrometer was used to detect these products in the probe discharge. The response time of the gas inlet system of the mass spectrometer was not enough to follow production of molecules in-situ in real time. Therefore, the kinetic measurements were performed by stopping the probe discharge after a certain exposure time.

![Figure 3. 5 Experimental procedure of the isotopic study.](image)
Adsorption and reactivity of N atoms

Two types of experiments were performed:

- **Investigation of adsorption kinetics**: the pretreatment duration was varied while the length of the probe discharge was fixed. Before each experiment the tube was cleaned by argon plasma in order to have the same state of the surface in the beginning of N\(_2\) plasma pretreatment.

- **Investigation of the reactivity of grafted nitrogen**: the pretreatment duration was fixed, while the probe discharge duration was varied. Typically, we used rf discharge for pretreatment and probing the reactivity of \(^{14}\text{N}_{\text{ads}}\). For more precise dosing of atomic nitrogen in some experiments we used dc discharge with pulse duration of 5 ms.

With the mass spectrometer relative concentrations of three nitrogen isotopologues (\(^{30}\text{N}_2\), \(^{29}\text{N}_2\), \(^{28}\text{N}_2\)) were determined. An example of mass-spectrometric measurements is shown in Figure 3. Normalized by the total intensity of three mass peaks spectra are taken after different probe \(^{30}\text{N}_2\) discharge durations in the reactor pretreated by \(^{28}\text{N}_2\) plasma. One can see peaks corresponding to \(^{28}\text{N}_2\) and \(^{29}\text{N}_2\) that appear due to surface reactions with \(^{14}\text{N}_{\text{ads}}\). Nitrogen molecules are continuously dissociated and re-associated in the probe discharge what results in a statistical distribution of \(^{14}\text{N}\) over \(^{29}\text{N}_2\) and \(^{28}\text{N}_2\). Both m=28 and m=29 peaks were integrated to determine the number of \(^{14}\text{N}_{\text{ads}}\) that were picked up from the surface under plasma exposure.

\[\text{Figure 3.6} \text{ Normalized mass spectra measured after different }^{30}\text{N}_2\text{ probe discharge durations in the reactor pretreated by }^{28}\text{N}_2\text{ plasma}\]

Absolute concentrations of gas phase species were obtained based on relative QMS measurements using the known gas pressure in the reactor. Every \(^{14}\text{N}\) atom measured in the gas phase is picked up from the surface. This allows determination of the surface density of \(^{14}\text{N}\) from gas phase measurements using volume to surface ratio of the reactor:
Chapter III

\[ [^{14}N]_{surf} = [^{14}N]_{gas} \frac{V}{S} \]  

(3.1)

where \( S = 314 \text{ cm}^2 \) is the area of the pretreated part of the discharge tube (the length of the rf discharge column was 50 cm and the total length of the tube was 60 cm). And \( V = 306 \text{ cm}^3 \) is the total volume of the reactor between two closing pneumatic valves. In (3.1) the roughness of the tube material is not taken into account and \([^{14}N]_{surf}\) is related to the geometric and not to the real surface area.

The sensitivity of the diagnostics was limited by the stability of relative MS signals and by eventual leaks in the system (\(^{14}\text{N}\) coming from the leak distorts the measurements of \(^{14}\text{N}\) coming from the surface). It was estimated to be \(2 \cdot 10^{13} \text{ } ^{14}\text{N} \text{ atoms per cm}^2\).

3.3.2 Characterization of the discharge: measurements of \(\text{N}_2\) dissociation degree

For quantitative investigation of surface reactions in \(\text{N}_2\) plasma the number of molecules produced on the surface has to be compared with incoming radical fluxes. It is important, therefore, to characterize the discharge that is used for surface treatment or probing. We have measured the degree of dissociation of \(\text{N}_2\) molecules in pulsed dc discharge and in pulsed rf discharge using the isotopic exchange technique. The idea of this technique is based on a simple fact: if a discharge is ignited in a mixture containing \(^{28}\text{N}_2\) and \(^{30}\text{N}_2\), due to dissociation and re-association of molecules, \(^{29}\text{N}_2\) will be produced and the rate of \(^{29}\text{N}_2\) production will depend on the rate of dissociation of initial molecules.

3.3.2.1 Dissociation of \(\text{N}_2\) in pulsed dc discharge

A mixture containing approximately 50/50 \(^{28}\text{N}_2 ^{30}\text{N}_2\) was introduced in the reactor at 0.53 mbar in static conditions. Then dc discharge pulses with the current \(i = 100 \text{ mA}\) and duration \(\tau = 5 \text{ ms}\) were applied. Relative concentrations of \(^{28}\text{N}_2\), \(^{29}\text{N}_2\) and \(^{30}\text{N}_2\) were measured with the mass spectrometer. Figure 3. 7 shows the evolution of measured concentrations as a function of the number of applied discharge pulses. One can see that \(^{29}\text{N}_2\) is produced at the expense of \(^{28}\text{N}_2\) and \(^{30}\text{N}_2\) and after 200 pulses a stationary state is reached. The cumulated discharge duration after 200 pulses is only 1 second, it is sufficiently short to neglect the nitridation of \(\text{SiO}_2\). Therefore, losses of N atoms due to adsorption on the surface may be ignored in the overall mass balance.
Adsorption and reactivity of N atoms

Figure 3. 7 Concentrations of three nitrogen isotopologues as a function of the number of applied dc discharge pulses. DC discharge parameters were p=0.53 mbar, i=100 mA, τ=5 ms, static conditions. Solid lines are calculated assuming that 2.8% of N\textsubscript{2} molecules are dissociated per pulse. Dashed lines are calculated with δ =2.4% and δ =3.1%, they demonstrate the relative accuracy of the δ determination method of the order of 10%.

There are two processes that can contribute to observed isotopic exchange:

- Dissociation of N\textsubscript{2} followed by surface recombination of N atoms. Gas phase recombination in our conditions is slow.
- Exchange reactions between atoms and molecules in the gas phase, for example:

\[
^{14}N + ^{30}N_2 \rightarrow ^{29}N_2 + ^{15}N \quad (3. 2)
\]

However, in [106] it was shown that process (3. 2) and similar reactions are very slow due to a high dissociation energy of N\textsubscript{2}. Therefore, dissociation followed by surface recombination is the only relevant mechanism of isotopic exchange. This condition is prerequisite for validity of the method.

In order to deduce the dissociation rate of N\textsubscript{2} in the discharge from measurements shown in Figure 3. 7 a numerical model was applied. For simplicity, we supposed that all the isotopologues of nitrogen are dissociated in the discharge with an identical rate and then produced $^{14}$N and $^{15}$N atoms recombine randomly on the surface. Let $\delta_1$ be the fraction of N\textsubscript{2} molecules dissociated in the reactor during the discharge pulse. Concentrations of produced atoms are given by the following expressions:
The mixing of isotopes due to dissociation and re-association after a certain number of discharge pulses doesn’t change the values of $a$ and $b$ because the total number of atoms of each type is conserved. Concentrations of $N_2$ isotopologues formed as a result of random recombination of produced atoms can be calculated as follows:

$$\left[ ^{14}N \right]_{\text{pulse}} = \delta_1 \left( 2\left[ ^{28}N_2 \right] + \left[ ^{29}N_2 \right] \right) \equiv a$$

$$\left[ ^{15}N \right]_{\text{pulse}} = \delta_1 \left( 2\left[ ^{30}N_2 \right] + \left[ ^{29}N_2 \right] \right) \equiv b$$

(3.3)

Therefore, the evolution of concentrations of three isotopologues of $N_2$ as a function of the pulse number $i$ can be described by a recurrent system:

$$\Delta \left[ ^{28}N_2 \right] = \frac{a^2}{2(a + b)}$$

$$\Delta \left[ ^{29}N_2 \right] = \frac{ab}{(a + b)}$$

$$\Delta \left[ ^{30}N_2 \right] = \frac{b^2}{2(a + b)}$$

(3.4)

Using (3.5) the evolution of concentrations of three nitrogen isotopologues was calculated numerically with initial concentrations taken from the experiment. The only unknown parameter in the model was the fraction of $N_2$ molecules dissociated per discharge pulse ($\delta_1$). The value of $\delta_1$ was varied to reach an agreement with the experiment. In our experiments the volume of the discharge column ($V_{\text{disch}} = 166 \text{ cm}^3$) is smaller than the volume of the reactor ($V_{\text{reactor}} = 306 \text{ cm}^3$). Dissociation takes place only in the plasma column; therefore in order to obtain the fraction of dissociated molecules in the discharge ($\delta$), the best-fit value of $\delta_1$ should be corrected $\delta = \delta_1 \cdot V_{\text{reactor}} / V_{\text{disch}}$. In the following discussion we will use the value of $\delta$ to describe $N_2$ dissociation in plasma.

In Figure 3.7 results of the model calculation are compared with the experiment. An excellent agreement is obtained with $\delta = 2.8\%$. Calculations with $\delta = 2.4\%$ and $\delta = 3.1\%$ demonstrate the accuracy of the technique. The relative error of $\delta$ determination was estimated to be 10%. Obtained result is in a good agreement with the theoretical calculations performed by V. Guerra and C. Pintassilgo. For the conditions of this work in the modelling it was found $\delta = 3.5\%$. This proves the validity of our new method for $N_2$ dissociation measurements.

Measurements with different initial concentrations of $^{28}N_2$ and $^{30}N_2$ were performed. In Figure 3.8 results of measurements and calculations for $^{28}N_2 / ^{30}N_2 = 87/13$ and $^{28}N_2 / ^{30}N_2 = 13/87$ are shown. With the same value $\delta = 2.8\%$ all the results are well reproduced by the model. This
Adsorption and reactivity of N atoms

proves the validity of our assumption concerning the identity of different nitrogen isotopes from the viewpoint of dissociation and surface recombination. If there was a difference in dissociation and/or recombination rates of different nitrogen isotopes, results with different initial mixture compositions wouldn’t be reproduced by our simple model with the same value of $\delta$.

![Graph](image)

Figure 3.8 Concentrations of three nitrogen isotopologues as a function of the number of applied dc discharge pulses. DC discharge parameters were $p=0.53$ mbar, $i=100$ mA, $\tau=5$ ms. Initial composition of the mixture was a) $^{28}\text{N}_2/^{30}\text{N}_2=87/13$ b) $^{28}\text{N}_2/^{30}\text{N}_2=13/87$. Solid line is the result of calculation with $\delta=2.8\%$

The advantage of the isotopic exchange technique is that it allows direct determination of the dissociation rate of N$_2$ in the discharge. Usually in the experiments the density of atomic nitrogen [N] in the gas phase is measured. But [N] depends on the balance between dissociation of N$_2$ and losses of N. When the losses take place on the surface and the value of $\gamma_N$ is not known, the dissociation rate cannot be determined from measured value of [N].

It is interesting to note that this method wouldn’t work for oxygen. In O$_2$ isotopic exchange between atoms and molecules in the gas phase is very efficient [107] and one oxygen atom can trigger a chain of exchange reactions like $^{16}\text{O} + ^{18}\text{O}^{18}\text{O} \rightarrow ^{18}\text{O} + ^{18}\text{O}^{16}\text{O}$, $^{18}\text{O} + ^{16}\text{O}^{16}\text{O} \rightarrow ^{16}\text{O} + ^{18}\text{O}^{16}\text{O}$ and so on. Therefore, statistical distribution of isotopologues is reached very fast and the initial dissociation degree cannot be deduced. The difference between O$_2$ and N$_2$ may be explained by the attractive potential in O – O$_2$ collisions due to the existence of a stable complex O$_3$. Similar stable molecule N$_3$ doesn’t exist.

3.3.2.2 Dissociation in pulsed rf discharge

The same procedure was applied to measure the rate of N$_2$ dissociation in an rf discharge at $p=0.53$ mbar in standard conditions. The reactor was filled with a mixture $^{28}\text{N}_2/^{30}\text{N}_2\approx50/50$ and $\tau=40$ ms discharge pulses were applied. Figure 3.9 shows the results of measurements and calculations with $\delta=7.4\%$. Therefore, $1.95 \cdot 10^{15}$ cm$^{-3}$ N atoms are produced during 40 ms rf discharge pulse. This gives the rate of atomic nitrogen production in N$_2$ rf discharge in standard pretreatment conditions $d[N]/dt = (5\pm1) \cdot 10^{16}$ cm$^{-3}$s$^{-1}$. 
3.3.2.3 Estimation of atomic nitrogen exposure on the surface

The flux of nitrogen atoms on the surface can be easily calculated if the concentration of atomic nitrogen is known: \( f_N = \frac{1}{4} [N]v_N \) where \( v_N \) is the thermal velocity of atoms. Above we have determined the dissociation rate in two types of probe discharges used in this study. But atomic concentration depends on the balance between dissociation of \( N_2 \) and losses of \( N \) atoms and in case of pulsed discharge it is also changing with time. Therefore, the number of collisions of \( N \) atoms with the surface per unit time or per probe discharge pulse is difficult to determine from our measurements.

However, we can introduce another quantity to characterize the exposure of \( N \) atoms on the surface – the flux of \( N \) atoms lost on the surface (due to recombination and adsorption), which can be expressed using the effective atomic loss probability \( \beta \): \( f_{\text{lost}}^N = \frac{1}{4} [N]v_N \beta \). Due to the fact that volume recombination is negligible at low pressure used in this study, the number of produced nitrogen atoms is always balanced by the number of \( N \) lost on the surface. In stationary conditions, this balance is established at any moment of time. In pulsed discharges, all atoms eventually end up on the surface after the end of the discharge pulse. Therefore, the balance is valid in time-integrated sense.

From the dissociation fractions determined above we find that:

- In the pulsed dc discharge (\( p=0.53 \) mbar, \( i=100 \) mA, \( \tau=5 \) ms) the atomic exposure on the surface is \( 2 \cdot 10^{14} \) lost \( N \) atoms per \( \text{cm}^2 \) per pulse.
Adsorption and reactivity of N atoms

- In the continuous rf discharge (p=0.53 mbar, $P_{pl}$=17 W) the atomic exposure on the surface is $2.5\cdot10^{16}$ lost N atoms per cm$^2$ per second.

It should be noted that atomic exposure is determined with respect to the geometric surface of the discharge tube without taking into account surface roughness. We have shown that dissociation rate doesn’t depend on the isotopologue, hence obtained values are applicable to probe discharges in $^{28}\text{N}_2$ as well as in $^{30}\text{N}_2$.

Now, when our discharges are characterized we can apply them for probing surface reactivity of SiO$_2$ under N$_2$ plasma exposure.

3.3.3 $^{14}\text{N}$ adsorption on SiO$_2$ under $^{28}\text{N}_2$ plasma exposure

First, we investigate the adsorption of $^{14}\text{N}$ on SiO$_2$ under plasma exposure. The following experimental parameters were used for cleaning, pretreatment and probing of silica discharge tube:

- Cleaning: Ar plasma $3.6\cdot10^3$ s (standard flowing rf discharge).
- Pretreatment: $^{28}\text{N}_2$ plasma 0.1 – $3.6\cdot10^3$ s (standard flowing rf discharge).
- Probing: $^{30}\text{N}_2$ 600 s (standard static rf discharge).

The wall temperature increased in the course of the pretreatment reaching $T_w \sim 380$ K after approximately 100 s of plasma exposure. For short pretreatment times (< 10 s) the wall temperature was equal to $T_w \sim 300$ K.

A question may arise if all the $^{14}\text{N}_{\text{ads}}$ are probed by 600 s $^{30}\text{N}_2$ discharge? To check if there are still some $^{14}\text{N}_{\text{ads}}$ left on the surface after the probe discharge, the reactor was refilled with fresh $^{30}\text{N}_2$ and a discharge was repeated again. This procedure showed that the exchange during the first probe discharge is complete within 10% if the $^{28}\text{N}_2$ pretreatment duration is 600 s and shorter. However for longer pretreatments, 600 s of $^{30}\text{N}_2$ discharge is clearly not enough to probe all the $^{14}\text{N}_{\text{ads}}$. For example, after 60 min pretreatment 3 successive fillings with $^{30}\text{N}_2$ were required to exchange all the $^{14}\text{N}_{\text{ads}}$. Obtained result is rather logical because:

- With increasing the duration of $^{28}\text{N}_2$ pretreatment $^{14}\text{N}$ atoms penetrate deeper in the material and longer exposure time is required for their extraction during the probe discharge in $^{30}\text{N}_2$.
- When the concentration of $^{14}\text{N}$ atoms in the probe discharge becomes relatively high they may be re-adsorbed on the surface leading to an equilibrium distribution between the surface and the gas phase.

Figure 3. 10 shows the density of $^{14}\text{N}_{\text{ads}}$ as a function of the duration of $^{28}\text{N}_2$ plasma treatment. Due to a better sensitivity of the isotopic diagnostics compared to XPS we were able to follow adsorption kinetics for pretreatment duration as short as 100 ms. For 60 min pretreatment the concentration of $^{14}\text{N}_{\text{ads}}$ was obtained using three successive probe discharges in $^{30}\text{N}_2$. Looking at Figure 3. 10 we can conclude:
Nitrogen atoms are indeed grafted to the surface of SiO$_2$ under $^{28}$N$_2$ plasma exposure. These atoms are reactive in the sense that they may be removed from the surface by the probe discharge in $^{30}$N$_2$.

![Figure 3.](image)

**Figure 3.** surface density of $^{14}$N$_{ads}$ as a function of the duration of $^{28}$N$_2$ plasma pretreatment. Probe $^{30}$N$_2$ discharge duration 600 s. ◦ results of XPS measurements from Figure 3. 3. Data points are fitted with a power function $N_{ads} = 5 \cdot 10^{13} + 6 \cdot 10^{13} \cdot t^{0.55}$.

The $^{14}$N$_{ads}$ coverage found after 60 min pretreatment [$^{14}$N$_{ads}$]$_{isotopes} = 6 \cdot 10^{15}$ cm$^{-2}$ is two times higher than the result of XPS measurements after 75 min pretreatment [$N_{ads}$]$_{XPS} \approx 3 \cdot 10^{15}$ cm$^{-2}$. As it was mentioned before, with isotopic exchange technique we obtain the $^{14}$N$_{ads}$ coverage with respect to the geometric surface of the tube. XPS measurements give surface concentrations related to real surface of the sample. The roughness factor of silica is ~ 2 [5] what may explain the 2-fold difference between two diagnostics. Obtained agreement is encouraging and it confirms the validity of both techniques for determination of the density of $^{14}$N$_{ads}$ on the surface of the discharge tube.

**Adsorption kinetics**

Data points shown in Figure 3. 10 can be well approximated by a power function: $N_{ads} = 5 \cdot 10^{13} + 6 \cdot 10^{13} \cdot t^{0.55}$ where t is the pretreatment time. We have found that during the first second of plasma exposure the rate of adsorption is maximal and it reaches $\approx 10^{14}$ atoms cm$^{-2}$ s$^{-1}$. After 100 s of pretreatment adsorption slows down by two orders of magnitude. This may be explained by fast top-surface nitridation followed by much slower penetration of N atoms deeper in the bulk.

It is interesting to compare the rate of $^{14}$N adsorption with the fluxes of atoms and ions on the surface. In § 3.3.2.3 the flux of recombining N atoms was measured to be $2.5 \cdot 10^{16}$ atoms cm$^{-2}$.
Adsorption and reactivity of N atoms

$2s^{-1}$ which is 2 orders of magnitude higher than the maximum rate of adsorption. Therefore, adsorption of N is a slow process in comparison with surface recombination.

An order of magnitude estimation of the ion flux can be done assuming that $n_e \sim 10^9$ cm$^{-3}$ and $T_e \sim 3$ eV which is reasonable for the conditions of this study according to [108]. Calculation using standard expression for collisionless sheath gives [44]:

$$j_+ \approx n_+ \frac{kT_e}{M_+} \approx 3 \cdot 10^{14} \text{ions cm}^{-2} \text{s}^{-1}$$

(3.6)

Therefore, the initial rate of N adsorption is comparable with the flux of ions on the surface. Similar ordering between the number of incident ions and the density of N grafted to the surface was obtained in plasma nitridation of thin SiO$_2$ films [17]. However, as it was mentioned in § 3.2.2 we are unable to determine the exact role of ions because in N$_2$ plasma the surface is exposed to atomic and ion fluxes simultaneously.

Do ions remove N$_{ads}$ under continuous N$_2$ plasma exposure?

We have seen that ion bombardment is essential for the formation of SiO$_x$N$_y$ layer. But what is the role of ions for the conditions on the surface of this layer? In [57] Cartry evidence the possibility of desorption of oxygen atoms adsorbed on SiO$_2$ by ion bombardment in O$_2$ dc discharge at 0.3 torr. Our case is similar to one described in [57] with the only difference that the surface is SiO$_x$N$_y$ and the discharge is in N$_2$. In order to see if ion bombardment liberates adsorption sites two pretreatment procedures have been compared:

- Standard pretreatment with rf discharge in N$_2$ during 60 min.
- Standard pretreatment followed by 100 short dc pulses in N$_2$ (0.53 mbar, i=100 mA, $\tau$=5 ms).

Using (3.6) we have estimated the number of N$_2^+$ ions incident on the surface during the dc pulse to be $\approx 3 \cdot 10^{13}$ cm$^{-2}$. Which is one order of magnitude smaller than the number of N atoms lost on the surface (measured in § 3.3.2.3 to be $3 \cdot 10^{14}$ cm$^{-2}$ per discharge pulse). Hence, with the dc pulses the surface is exposed mostly to the atomic flux. If there are some free adsorption sites left on the surface after rf treatment, they can be occupied by N atoms. But we have found that addition of dc pulses doesn’t change the number of N adsorbed on the surface. This proves that under standard pretreatment conditions eventual desorption of $^{14}$N$_{ads}$ by ion bombardment is less efficient than re-adsorption of atomic nitrogen and all the adsorption sites are normally occupied.

$^{14}$N adsorption: role of O$_2$ admixture in the discharge

With XPS measurements we have seen that addition of 20% O$_2$ into N$_2$ discharge inhibits formation of SiO$_x$N$_y$ on silica surface. This effect was explained by removal of N$_{ads}$ in reactions with O atoms. Using isotopic exchange technique we have investigated pretreatment of silica surface by rf discharge in a mixture containing 0.1 % of oxygen in N$_2$. Even such a
small addition of O\textsubscript{2} in the discharge results in \sim 10 fold reduction of the density of grafted \textsuperscript{14}N! The surface density \([\text{\textsuperscript{14}N}}_{\text{ads}}] = 4 \cdot 10^{14} \text{ cm}^{-2}\) was measured in this case. This example shows how strongly the state of the surface in contact with N\textsubscript{2}/O\textsubscript{2} plasmas is dependent on the gas composition.

*Is adsorption of nitrogen atoms isotope - dependent?*

It was interesting to check if both nitrogen isotopes are adsorbed on silica surface in the same manner. A series of experiments with \textsuperscript{30}N\textsubscript{2} plasma pretreatment was performed. In this case discharge was ignited in a closed reactor without a gas flow. Measured concentrations \([\text{\textsuperscript{15}N}}_{\text{ads}}]\) were systematically \sim 2 times lower than \([\text{\textsuperscript{14}N}}_{\text{ads}}]\) after the same pretreatment time in \textsuperscript{28}N\textsubscript{2}. This could be in principle interpreted as an isotope-dependent adsorption of nitrogen atoms on SiO\textsubscript{2}. However as we have mentioned above, adsorption of N atoms on SiO\textsubscript{2} is very sensitive to the presence of oxygen additions in N\textsubscript{2}. Therefore, more plausible explanation for this effect would be a higher level of impurities (such as O\textsubscript{2} or H\textsubscript{2}O) in the \textsuperscript{30}N\textsubscript{2} gas used.

### 3.3.4 Reactivity of grafted \textsuperscript{14}N atoms under \textsuperscript{30}N\textsubscript{2} plasma exposure

XPS and isotopic exchange diagnostics have both shown that the surface of SiO\textsubscript{2} pretreated by low pressure N\textsubscript{2} plasma is saturated with N atoms. We know that these atoms can be removed from the surface by \textsuperscript{30}N\textsubscript{2} plasma, i.e. they are reactive under plasma exposure. Our objective now is to understand if these adsorbed nitrogen atoms play a role of active sites for recombination of N on the surface. In other words, if adsorbed atoms that we have detected in our experiments are those “chemisorbed” atoms that are so widely used in the models?

We use a probe discharge in \textsuperscript{30}N\textsubscript{2} to send a controlled amount of \textsuperscript{15}N atoms on the surface previously pretreated by \textsuperscript{28}N\textsubscript{2} plasma. Comparison between the number of lost \textsuperscript{15}N and the number of \textsuperscript{14}N picked up from the surface will give the answer to formulated questions.

#### 3.3.4.1 Evidence for a distribution of reactivity of N\textsubscript{ads}

In order to investigate the reactivity of \textsuperscript{14}N\textsubscript{ads}, silica surface was pretreated by \textsuperscript{28}N\textsubscript{2} plasma during 60 minutes in standard conditions and then probed by \textsuperscript{30}N\textsubscript{2} discharge with duration varied in the range \(5 \cdot 10^{-2} – 10^{3} \text{ s}\) in closed reactor. Figure 3. 11 shows the evolution of the number of adsorbed atoms picked up from the surface as a function of the probe discharge duration \((\text{\textsuperscript{14}N}}_{\text{des}})\).

One can note that for long probe discharge durations the concentration of \textsuperscript{14}N atoms in the gas phase becomes non-negligible in comparison with the concentration of \textsuperscript{15}N. For example after \(t \text{probe} = 10^{3} \text{ s}\), relative atomic concentration of \textsuperscript{14}N is 25\%. This means that \textsuperscript{14}N from the gas phase may be re-adsorbed on the surface and thus the value of \textsuperscript{14}N\textsubscript{des} is underestimated. Accurate correction of the measurements for the re-absorption effect is difficult. As we will see, different groups of N atoms on the surface have different characteristic times of isotopic exchange with the gas phase under plasma exposure. If equilibrium between the plasma and the reactor wall is attained, the relative concentration of \textsuperscript{14}N should be the same in the gas
Adsorption and reactivity of N atoms

phase and in the probed part of the SiO$_x$N$_y$ layer. Therefore, the underestimation of the value of $^{14}$N$_{\text{des}}$ for $t_{\text{probe}} = 10^3$ s is ~ 25%. For $t_{\text{probe}} \leq 10^2$ s this correction is always smaller than 10% and it can be neglected.

Figure 3. Evolution of the density of $^{14}$N$_{\text{des}}$ atoms picked up from the surface as a function of the probe rf discharge duration in $^{30}$N$_2$. Silica discharge tube was pre-treated by $^{28}$N$_2$ plasma during 60 minutes. Multi-exponential fit with $a - \sum_{i=1,3} a_i e^{-t/\tau_i}$ is shown by a solid line. Three components of the fit are shown by dashed lines.

We can see that the value of $^{14}$N$_{\text{des}}$ gradually increases when the duration of probe discharge is varied by 4 orders of magnitude. This observation points to the presence on the surface of different groups of $^{14}$N$_{\text{ads}}$ that have different probability to react and to be desorbed in the gas phase during the probe discharge. If all the adsorbed atoms had the same reactivity, the evolution of $^{14}$N$_{\text{des}}$ would be described by single-exponential time dependence $[N_{\text{des}}] = a(1 - e^{-t/\tau})$. But in order to reproduce experimental data we had to use a combination of three exponential functions $[N_{\text{des}}] = a - \sum_{i=1,3} a_i e^{-t/\tau_i}$ with following parameters:

<table>
<thead>
<tr>
<th>$i$</th>
<th>$a_i$ [cm$^{-2}$]</th>
<th>$\tau_i$ [s]</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>5.5·10$^{14}$</td>
<td>0.42</td>
</tr>
<tr>
<td>2</td>
<td>1.1·10$^{15}$</td>
<td>6.7</td>
</tr>
<tr>
<td>3</td>
<td>3.6·10$^{15}$</td>
<td>316</td>
</tr>
</tbody>
</table>

Table 3. Parameters of multi-exponential fit of the data shown in Figure 3. 11.

Different reactivity of groups of atoms with $i=1$ and $i=2$ may be related to the difference in their binding energy [54]. The total coverage of the most reactive $N_{\text{ads}} a_1 + a_2$ is of the order
of one monolayer. It would be reasonable to suggest that these atoms occupy the outmost layer on the surface of SiO\textsubscript{x}N\textsubscript{y} and they are directly exposed to the plasma. When the surface is pretreated by an rf discharge in N\textsubscript{2} in standard conditions, these superficial atoms are continuously replaced with the characteristic turnover time \( \approx 7 \) s.

According to [17] in plasma nitried SiO\textsubscript{2} thin films, N atoms are incorporated within a \( \approx 3 \) nm thick surface layer. Atoms belonging to the third group may be distributed in the SiO\textsubscript{x}N\textsubscript{y} layer beneath the surface what would explain their slow desorption rate.

It is evident that only the most reactive N\textsubscript{ads} significantly contribute to the recombination of nitrogen atoms on the surface in the discharge.

3.3.4.2 \textit{Do N\textsubscript{ads} participate in surface recombination of N atoms?}

Up to now we haven’t yet discussed the mechanism of \(^{14}\text{N}\) removal from the surface under \(^{30}\text{N}_2\) plasma exposure. Several processes may take place simultaneously:

- Recombination with \(^{15}\text{N}\):

\[ ^{15}\text{N} + ^{14}\text{N}_{\text{ads}} \rightarrow ^{29}\text{N}_2 \]  \hspace{1cm} (3. 7)

- Ion bombardment

- Desorption by photons and fluxes of excited species

At present we don’t have any evidence of the contribution of photons and excited molecules, but we are confident that ions play an important role. The fact that nitridation of SiO\textsubscript{2} takes place only under direct plasma exposure proves that ion bombardment in our conditions may significantly modify the outmost surface layer. Therefore, desorption of \(^{14}\text{N}_{\text{ads}}\) by ions cannot be ruled out.

In the first instance we will assume that atomic recombination is the only relevant reaction for N\textsubscript{ads} removal and we will neglect all the other processes. This will allow an estimation of the upper limit for the efficiency of recombination between adsorbed \(^{14}\text{N}_{\text{ads}}\) and impinging \(^{15}\text{N}\).

In order to see the effect of the most active \(^{14}\text{N}_{\text{ads}}\) that react in the very beginning of the probe discharge, the exposure to the flux of \(^{15}\text{N}\) should be as small as possible. Our pulsed rf discharge was not adapted for working with short single discharge pulses. For this reason we used a dc probe discharge with pulse duration \( \tau = 5 \) ms and current \( i = 100 \) mA at \( p = 0.53 \) mbar. According to the measurements presented in § 3.3.2.3, in every dc pulse the number \(^{15}\text{N}\) atoms lost per cm\(^2\) of the tube surface is \( 2 \cdot 10^{14} \). As we have estimated in § 0, the number of incident N\textsubscript{2}\textsuperscript{+} ions in the same conditions is about one order of magnitude smaller.

Silica discharge tube was pretreated by \(^{28}\text{N}_2\) plasma in standard conditions during 60 min and then probe pulsed discharge in \(^{30}\text{N}_2\) was applied. In Figure 3. 12, the number of \(^{14}\text{N}_{\text{ads}}\) picked up from the surface (\( \phi_{14N} \)) is plotted as a function of the number of \(^{15}\text{N}\) lost (\( \phi_{15N} \)). Results obtained with dc and rf probe discharges (from Figure 3. 11) are compared.
Adsorption and reactivity of N atoms

Figure 3. The density of $^{14}$N$_{ads}$ atoms picked up from the surface as a function of the number of lost $^{15}$N. Results obtained with dc and rf probe discharges are shown. Dashed line depicts $\phi_{14N} = 0.1 \cdot \phi_{15N}$, i.e. 1 out of 10 $^{15}$N atoms is lost in recombination with $^{14}$N$_{ads}$.

One can see that for $\phi_{15N} < 10^{15}$ cm$^{-2}$, the number of desorbed $^{14}$N atoms is directly proportional to the number of lost $^{15}$N and $\phi_{14N} = 0.1 \cdot \phi_{15N}$. This means that only 1 out of 10 $^{15}$N is lost in recombination with $^{14}$N$_{ads}$. If we assume that one more $^{15}$N atom is consumed to occupy the place of removed $^{14}$N$_{ads}$ we obtain that the maximum contribution of strongly bonding sites (i.e. sites where stable $^{14}$N are adsorbed) into surface recombination of $^{15}$N is only 20%.

Where recombine remaining 80% of $^{15}$N? Two hypotheses may be proposed:

i. Recombination of $^{15}$N takes place on weakly bonding active sites.

ii. Only a small fraction $^{14}$N$_{ads}$ are active for recombination of $^{15}$N. Upon the exposure of the surface to pulsed discharge in $^{30}$N$_2$, there is a fast turnover of $^{15}$N on these active sites that doesn’t lead to the production of $^{29}$N$_2$. The detection limit of mass spectrometer is equivalent to $\sim 2 \cdot 10^{13}$ atoms per cm$^2$. If the coverage of active atoms is of the order of $10^{13}$ cm$^{-2}$ their contribution to the production of $^{29}$N$_2$ on the surface in experiments shown in Figure 3. 12 cannot be measured.

Physically both hypotheses mean that on the surface there exists a distribution of binding energy and/or reactivity of adsorbed N atoms.
3.3.5 Conclusions on the isotopic study

In this section we have developed isotope exchange technique for investigation of interaction between SiO₂ surface and low pressure N₂ plasma. This technique allowed us to characterize the coverage and reactivity of Nₐds on SiO₂. Let us outline the main results:

- It has been confirmed that a SiOₓNᵧ layer is formed on SiO₂ under plasma exposure. We were able to follow dynamics of SiOₓ nitridation and the concentration of ¹⁴N atoms on the surface after 60 minutes of ²⁸N₂ plasma treatment [¹⁴Nₐds] = 6·10¹⁵ cm⁻² was found to be in a good agreement with previous XPS measurements.
- Formation of SiOₓNᵧ layer is very sensitive to the presence of O₂ admixtures in N₂ plasma. Addition of 0.1% of O₂ into N₂ reduces the number of grafted N atoms by a factor of 10.
- ¹⁴Nₐds exhibit a distribution of reactivity when pretreated surface is exposed to ³⁰N₂ plasma.
- Recombination with ¹⁴Nₐds accounts at maximum for 20% of surface losses of nitrogen atoms on SiOₓNᵧ.
- We suppose that 80% of heterogeneous losses of N takes place on either weakly bonding active sites or with participation of a small fraction of Nₐds.

In order to choose between these two hypotheses the limit of detection of Nₐds should be improved. In the following section we will develop a technique capable of detecting coverage of Nₐds of the order of 10¹² cm⁻².

3.4 Recombination of Nₐds with O atoms

We have seen that ¹⁴Nₐds can recombine with ¹⁵N producing ²⁹N₂. In this section we will investigate recombination reaction Nₐds + O → NO. Thus, after the pretreatment of silica surface by N₂ plasma we ignite in the reactor a discharge in pure oxygen. Nitric oxide (NO) molecules produced on the surface are detected in-situ using tuneable laser diagnostics with millisecond time resolution. High sensitivity and time resolution of TDLAS open a possibility to follow kinetics of recombination process and to separate production of NO during the probe discharge pulse and in the afterglow. Detection of NO production on the surface is an alternative way to probe the reactivity of Nₐds, so we will be interested in the mechanism of NO formation as well as in the properties of reactive Nₐds.

3.4.1 Experimental details

Experimental procedure consists in several steps, schematically shown in Figure 3.13. First the silica discharge tube was pretreated by N₂ plasma in standard conditions (see Table 3.1) during 60 minutes. Then the reactor was pumped out during 10 minutes in order to remove gas phase N₂ and let the surface cool down to the room temperature. On the next step the discharge tube was filled with pure O₂ and a single discharge pulse (dc or rf) was ignited in
Adsorption and reactivity of N atoms

closed reactor. Production of NO was monitored \textit{in-situ} using TDL spectrometer with typical time resolution of 10 ms. It is essential that in experiments with pretreated surface the complete time evolution of NO concentration was measured in a single probe discharge. In our conditions no data accumulation is possible because the next probe pulse can be applied only after 70 minutes when the surface is pretreated again.

![Figure 3.13 Experimental procedure used for investigation of NO formation on the surface.](image)

Within the same emission mode of the laser we were able to detect absorption features of two isotopologues of nitric oxide - \textsuperscript{14}NO and \textsuperscript{15}NO with approximately the same line strengths. Therefore, kinetics of both species was followed simultaneously. Figure 3.14 shows an absorption spectrum of a gas mixture containing both isotopologues of NO.

The detection limit of NO measurements using TDLAS was \( \sim 10^{12} \text{ cm}^{-3} \). In terms of surface coverage of N atoms (if we assume that NO is produced from recombination of N\textsubscript{ads} and O) this correspond to \( \sim 5\cdot10^{11} \text{ cm}^{-2} \), i.e. less than \( 10^{-3} \) of a monolayer. Hence using NO production as a probe, we can detect much smaller surface coverage of N\textsubscript{ads} in comparison with XPS and isotopic exchange technique.

The absolute concentration of O atoms in the probed O\textsubscript{2} discharge is measured using TALIF.

![Figure 3.14 Absorption spectrum of a mixture containing \textsuperscript{14}NO and \textsuperscript{15}NO recorder with TDL spectrometer.](image)
3.4.2 Kinetics of NO production on the surface

Figure 3. 15 shows time evolution of NO concentration measured in a probe discharge pulse (i=100 mA, τ=10 ms) at three different O\textsubscript{2} pressures, p = 0.53, 1.3 and 5.3 mbar. First of all we see that NO production on the surface is possible. We use pure O\textsubscript{2} so NO can come only from reactions on the surface.

Figure 3. 15 NO production in probe dc discharge pulses (i=100 mA, τ=10 ms) at different pressures of O\textsubscript{2} p=0.53, 1.3, 5.3 mbar. Silica discharge tube was pretreated by N\textsubscript{2} plasma in standard conditions during 60 minutes. Zoom on the first 100 ms of the acquisition is also shown, t=0 corresponds to the beginning of the probe pulse.

Measurements of NO can provide information about the mechanism of recombination reaction (O+N\textsubscript{ads}→NO only if two conditions are satisfied:

- (O+N\textsubscript{ads})→NO is indeed the main channel of NO production in the probe discharge.
- Losses and conversion of NO are negligible.

Below we will show that in experiments shown in Figure 3. 15 both conditions are fulfilled.

3.4.2.1 Proof of recombination mechanism $N\textsubscript{ads} + O \rightarrow NO$

In principle, NO can be produced on the surface in reactions with ions and electronically excited species. But the lifetime of these species is short and they can contribute to NO production only during the probe discharge. In Figure 3. 15, concentration of nitric oxide just after the end of plasma pulse is less than 10% of the maximum measured NO concentration. Therefore, we can neglect the reactivity of short-lived species as a source of NO in this experiment.

Production of NO persists during ~ 200 ms in the post discharge. Among all active oxygen species only $O_{2}(a^{1}\Delta)$ and O atoms have comparable lifetimes in our conditions [109]. But
Adsorption and reactivity of N atoms

molecular singlet oxygen has very low excitation energy (~1eV) and it would be reasonable to suggest that it is much less reactive than O. This means that atomic oxygen is the only relevant reaction partner for NO production.

We have also tested a possible role of adsorbed N₂ molecules for production of NO. When the reactor was pretreated with neutral N₂ flow, no formation of NO was detected in the probe discharge. Therefore, adsorbed nitrogen molecules have no contribution to NO production on the surface in our conditions.

We conclude that in experiments shown in Figure 3, NO is produced mainly from recombination between N_ads and atomic oxygen.

3.4.2.2 Kinetics of NOx in the probe discharge

If we want to use NO as a marker of surface reactions, it should not be destroyed or converted after being produced on the surface. It is known that in N₂/O₂ containing plasmas different nitrogen oxides are formed in the gas phase and on the surface [43][32]. In our oxygen-rich conditions NO₂ is the most plausible product of NO conversion. Let’s consider the most important reactions that may influence kinetics of NO in the afterglow of the probe discharge.

<table>
<thead>
<tr>
<th>Reaction</th>
<th>Rate constant</th>
<th>Ref</th>
</tr>
</thead>
<tbody>
<tr>
<td>R1 O+N_ads→NO</td>
<td>//</td>
<td></td>
</tr>
<tr>
<td>R2 NO₂+O→NO+O₂</td>
<td>( k_2 = 9.3 \times 10^{-12} \text{ cm}^3 \text{ s}^{-1} )</td>
<td>[16]</td>
</tr>
<tr>
<td>R3 NO+O+M → NO₂+M</td>
<td>( k_3 = 8.6 \times 10^{-32} \text{ cm}^6 \text{ s}^{-1} )</td>
<td>[16]</td>
</tr>
<tr>
<td>R4 NO+O₃ → NO₂+O₂</td>
<td>( k_4 = 1.8 \times 10^{-12} e^{-1370/ T} \text{ cm}^3 \text{ s}^{-1} )</td>
<td>[16]</td>
</tr>
<tr>
<td>R5 NO+O_ads→ NO₂</td>
<td>//</td>
<td></td>
</tr>
</tbody>
</table>

Table 3.4 Relevant NO production and loss mechanisms in the afterglow of the probe discharge.

We see that NO can be converted into NO₂ in reactions R3-R5, but the reverse reaction R2 is rather fast and in it tends to recover NO₂ into NO. The probability of reaction R5 just after the end of the probe discharge when atomic oxygen is still present in the gas phase is not known. In the next chapter we will see that on Pyrex surface in the late post-discharge this reaction has a probability \( \gamma \sim 10^{-6} \), i.e. it is rather slow. Let’s make an estimation of the efficiency of NO conversion in NO₂ for O₂ pressure 1.3 mbar. In § 4.5.2 we show that at \( p=1.3 \) mbar concentration of O₃ produced in the discharge is smaller than \( 10^{13} \) cm⁻³, thus reaction R4 can be neglected. If we neglect R5, the balance between production and losses of NO₂ in reactions R2 and R3 in quasi steady is independent of the concentration of O:

\[
\frac{[NO_2]}{[NO]} = \frac{k_3 [M]}{k_2} \sim 10^{-4} \tag{3.8}
\]

Therefore, while the concentration of atomic oxygen is not too small, concentration of NO₂ is negligible because it is destroyed in reaction R2. When all oxygen atoms recombine on the surface, reactions R4 and R5 may become important. This is clearly seen in Figure 3.15 for
p=5.3 mbar; 500 ms after the end of the probe discharge [NO] starts to decrease. This may be explained by reaction R4 with ozone which is efficiently produced at elevated O$_2$ pressure. As we will show in § 4.5.2, concentration of ozone reaches $\sim 10^{14}$ cm$^{-3}$ at 5 mbar in similar conditions.

Here we conclude that in experiments shown in Figure 3. 15 NO conversion in NO$_2$ may be neglected (at least for $t<500$ ms in the afterglow of the probe discharge).

3.4.2.3 Estimation of the coverage of N$_{ads}$ that produce NO

We have proven that NO is produced from recombination between N$_{ads}$ and O and every NO molecules measured in the gas phase corresponds to one N$_{ads}$ picked up from the surface due to negligible losses of NO. This allows estimation of the coverage of N$_{ads}$ that took part in recombination using volume (V) to surface (S) ratio of the discharge tube

$$[N_{ads}] = [NO] \frac{V}{S} \quad (3.9)$$

But what is the maximum amount of N$_{ads}$ that can react with O?

In Figure 3. 15 we can see that the maximum concentration of produced NO increases with increasing the pressure from 0.53 to 1.3 mbar and then it stays the same for O$_2$ pressure 5.3 mbar. In order to understand this behaviour we have measured NO production with different probe pulse durations at p = 1.3 mbar. In addition the concentration of atomic oxygen at the end of the probe discharge was measured using TALIF.

Table 3. 5 shows results of the measurements of the concentration of atomic oxygen and corresponding number of O atoms lost per cm$^2$ of the tube surface per probe discharge pulse. The probe pulse duration is much shorter than the typical lifetime of atomic oxygen in our conditions (see § 4.5.2); therefore, the number of lost O atoms is simply proportional to the concentration of atomic oxygen at the end of the pulse $[O_{lost}] = [O] \frac{V}{S}$.

<table>
<thead>
<tr>
<th>Conditions</th>
<th>p mbar</th>
<th>[O] cm$^{-3}$</th>
<th>[O$_{lost}$] cm$^{-2}$</th>
</tr>
</thead>
<tbody>
<tr>
<td>i=100 mA, $\tau$=0.5 ms</td>
<td>1.3</td>
<td>$1 \cdot 10^{14}$</td>
<td>$5 \cdot 10^{15}$</td>
</tr>
<tr>
<td>i=100 mA, $\tau$=2 ms</td>
<td>1.3</td>
<td>$4.5 \cdot 10^{14}$</td>
<td>$2.2 \cdot 10^{14}$</td>
</tr>
<tr>
<td>i=100 mA, $\tau$=10 ms</td>
<td>0.53</td>
<td>$9 \cdot 10^{14}$</td>
<td>$4.5 \cdot 10^{14}$</td>
</tr>
<tr>
<td>i=100 mA, $\tau$=10 ms</td>
<td>1.3</td>
<td>$2 \cdot 10^{15}$</td>
<td>$1 \cdot 10^{15}$</td>
</tr>
<tr>
<td>i=100 mA, $\tau$=10 ms</td>
<td>5.3</td>
<td>$6 \cdot 10^{15}$</td>
<td>$3 \cdot 10^{15}$</td>
</tr>
</tbody>
</table>

Table 3. 5 Concentration of atomic oxygen at the end of the probe discharge measured using TALIF and corresponding exposure of the surface to atomic oxygen measured in atoms lost per cm$^2$ of the tube surface.

In Figure 3. 16 the maximum concentration of formed nitric oxide [NO]$_{max}$ is plotted as a function of [O$_{lost}$]: [NO]$_{max}$ is proportional to [O$_{lost}$] for [O$_{lost}$] $\leq 5 \cdot 10^{14}$ cm$^{-2}$ and then it
Adsorption and reactivity of N atoms

reaches saturation. These measurements show that for low values of [O\text{lost}], NO production is limited by the amount of available atomic oxygen. Saturation can be explained by the limited number of reactive N\text{ads} on the surface. We have seen in § 3.4.2.2 that losses of NO are not increased with increasing the density of atomic oxygen; hence, saturation of [NO]\text{max} is not related to the conversion of NO into NO\text{2}.

![Figure 3. 16 Maximum concentration of NO produced on the surface as a function of the number of O atoms lost on the surface of after the probe discharge. Surface pretreatment conditions are the same as in Figure 3. 15.](image)

Comparison between the number of O lost on the surface and the amount of produced NO clearly shows that recombination with N\text{ads} is not the main loss mechanism of atomic oxygen on the surface. From the initial linear part of the dependence shown in Figure 3. 16 we deduce that only \(~5\%\) of O atoms recombine with the production of NO.

Saturation level [NO]\text{max} = 7\cdot10^{13} \text{ cm}^{-3} corresponds to the total coverage of N\text{ads} after the pretreatment [N\text{ads}]=3.5\cdot10^{13} \text{ cm}^{-2}. Obtained coverage is two orders of magnitude smaller than the density of N\text{ads} measured with XPS or isotopic exchange. This means that only a small fraction of nitrogen atoms on the surface can participate in NO formation under the flux of atomic oxygen in the post-discharge. In order to distinguish these very reactive atoms from the rest of N\text{ads}, in the following discussion we will denote them N\text{ads}^*.

We don’t know exactly what differs N\text{ads}^* from other adsorbed N atoms on the surface. Probably, they have smaller binding energy what determines their reactivity towards O.
Chapter III

3.4.2.4  NO production on the surface under continuous O$_2$ plasma exposure

Results discussed so far are obtained in a temporal post discharge where O atoms are the only active species. Now we will investigate how NO is produced when the pretreated surface it is exposed to a continuous O$_2$ plasma where ion and atom fluxes are present simultaneously. In Figure 3.17 a) kinetics of NO production in a probe rf discharge in standard conditions is shown. We can see that NO is rapidly formed when rf discharge is ignited and then a slight increase of the NO concentration is observed during the following 60 seconds. In Figure 3.17 b) results obtained using dc and rf probe discharges are compared. Surprisingly, characteristic production time and absolute concentration of NO are identical in both cases.

![Diagram showing NO production kinetics](image)

Figure 3.17 Production of NO in an O$_2$ rf discharge in standard conditions. Silica discharge tube was pretreated by N$_2$ plasma during 60 minutes. For comparison results obtained using a dc probe discharge at 1.3 mbar are shown. Right panel shows a comparison between rf and dc probes during the first 3 seconds of plasma exposure.

According to our XPS measurements shown in Figure 3.4, after 1 min of O$_2$ plasma exposure in standard conditions about $2 \cdot 10^{15}$ nitrogen atoms per cm$^2$ are removed from the surface. Concentration of NO measured after 1 minute of rf probe discharge corresponds to only $4 \cdot 10^{13}$ of N$_{ads}$ per cm$^2$. Therefore, the balance of nitrogen atoms based on NO measurements in the continuous rf probe discharge is incomplete.

Mass spectrometric measurements have shown that in addition to NO significant amount of N$_2$ is produced. After 1 minute of probe discharge we have found [N$_2$]=$1 \cdot 10^{15}$ cm$^{-3}$, that corresponds to $2 \cdot 10^{15}$ cm$^{-2}$ nitrogen atoms picked up from the surface. This result agrees well with XPS and isotopic exchange measurements presented in §3.2.3 and §3.3.3. Thus, most of N$_{ads}$ that react under continuous O$_2$ plasma exposure end up in the form of N$_2$; NO represents only a small fraction of the N atoms balance in the probe discharge.

Table 3.6 shows a list of gas phase reactions that may explain observed production of N$_2$. In continuous rf probe discharge NO molecules are dissociated by electron impact (R6). Produced N atoms may either re-associate on the surface into NO or react further with NO in very efficient reaction R7 that forms N$_2$. Nitrogen molecules in turn participate in the production of NO in gas phase reactions R8-R10. Concentrations of NO and N$_2$ that are
Adsorption and reactivity of N atoms

established in the probe discharge arise from the balance between processes of NO destruction and production.

<table>
<thead>
<tr>
<th>Reaction</th>
<th>Rate constant</th>
<th>Ref</th>
</tr>
</thead>
<tbody>
<tr>
<td>R6 $e + NO \rightarrow N + O$</td>
<td>//</td>
<td></td>
</tr>
<tr>
<td>R7 $N + NO \rightarrow N_2 + O$</td>
<td>$k_6=1.8 \cdot 10^{-11}$ cm$^3$s$^{-1}$</td>
<td>[63]</td>
</tr>
<tr>
<td>R8 $N_2(A) + O \rightarrow NO + N(^2D)$</td>
<td>$k_7=7 \cdot 10^{-12}$ cm$^3$s$^{-1}$</td>
<td>[63]</td>
</tr>
<tr>
<td>R9 $N_2(^{1}D) + O \rightarrow NO + N(^4S)$</td>
<td>$k_8=10^{11}$ cm$^3$s$^{-1}$</td>
<td>[63]</td>
</tr>
<tr>
<td>R10 $N(^2D) + O_2 \rightarrow NO + O$</td>
<td>$k_9=5.2 \cdot 10^{-12}$ cm$^3$s$^{-1}$</td>
<td>[63]</td>
</tr>
</tbody>
</table>

Table 3. 6 Gas phase reactions relevant to NO kinetics during the probe discharge.

We conclude that under continuous O$_2$ plasma exposure NO is not a good marker for probing surface reactivity because it is rapidly transformed into N$_2$. Remarkable coincidence of results obtained using dc and rf probe discharge shown in Figure 3, 17 is accidental and should not be misinterpreted. In the dc pulsed discharge saturation of NO concentration is reached when O atoms recombine with all the available N$_{ads}$ while in the rf discharge saturation originates from the balance between production and destruction of NO.

3.4.3 Investigation of adsorption and reactivity of N using measurements of NO production on the surface

Based on the results obtained with pulsed and continuous O$_2$ probe discharges we can distinguish two types of N atoms on silica surface pretreated by N$_2$ plasma.

- N$_{ads}$ that are available for recombination with O atoms in the afterglow of a pulsed O$_2$ discharge. The coverage of these atoms [N$_{ads}^*$] = 3.5·10$^{13}$ cm$^{-2}$.
- The rest of N$_{ads}$ atoms in SiO$_x$N$_y$ layer. These atoms are less reactive and they can be removed from the surface under continuous O$_2$ plasma exposure where ion and atomic fluxes are present simultaneously. The coverage of these atoms [N$_{ads}$] ~ 5·10$^{15}$ cm$^{-2}$ after 60 minutes of standard N$_2$ rf discharge pretreatment.

N$_{ads}^*$ are active for recombination with O atoms. What if N$_{ads}^*$ efficiently recombine with N? In § 3.3.4.2 we have suggested that recombination of nitrogen atoms on the surface may take place on a small fraction of strongly bonded but reactive N$_{ads}$. The coverage of N$_{ads}^*$ is comparable with the detection limit of mass spectrometric diagnostics, so they could have been missed in experiments shown in Figure 3, 12. Measurements of NO production on the surface allows for much better detection limits of adsorbed nitrogen atoms. Below using NO as a probe, we investigate adsorption kinetics and reactivity of N$_{ads}^*$ trying to understand if they indeed play a role of active sites for recombination of N on the surface.

3.4.3.1 Kinetics of adsorption

Silica discharge tube was first cleaned by argon plasma in standard conditions during 60 min and then exposed to N$_2$ rf discharge for time duration in the range 10$^{-2}$ – 10$^4$ s. Then the
density of \( N_{\text{ads}}^* \) was probed by a pulsed dc discharge in O\(_2\) in closed reactor (\( p=5.3 \) mbar, \( i=100 \) mA, \( \tau=10 \) ms). Figure 3. 18 shows the evolution of the coverage of \( N_{\text{ads}}^* \) as a function of the pretreatment duration. The upper abscissa axis represents the number of N atoms lost on the surface during the pretreatment (see the estimation made in §3.3.2.3).

![Graph demonstrating the evolution of \( N_{\text{ads}}^* \) coverage as a function of pretreatment time.](image)

Figure 3. 18 The density of \( N_{\text{ads}}^* \) grafted to the surface of silica discharge tube as a function of \( N_2 \) plasma pretreatment duration. The upper abscissa axis represents the number of N atoms lost on the surface during the \( N_2 \) plasma pretreatment.

One can see that the coverage of \( N_{\text{ads}}^* \) increases when the duration of \( N_2 \) plasma is increased and it reaches saturation at \( t \sim 10^3 \) s. Comparison between the density of grafted atoms and the number of N lost on the surface shows that most of N atoms produced in the discharge during the pretreatment recombine without being adsorbed as \( N_{\text{ads}}^* \). In other words, building up of the coverage \( N_{\text{ads}}^* \) is a slow process compared to the recombination of N on the surface. It is interesting to note that the time required to reach a saturating coverage of \( N_{\text{ads}}^* \) is equal to the time of formation of a \( \text{SiO}_x\text{N}_y \) layer containing \( 2 \cdot 10^{15} \) nitrogen atoms per cm\(^2\).

In order to check if nitrogen atoms alone can be adsorbed on silica surface, pretreatment by a flowing afterglow was studied. First, the reactor was cleaned by a discharge in argon as before and then \( N_2 \) plasma pretreatment was performed by a half of the standard length (25 cm long) discharge column placed either in the upstream or in the downstream configuration during 60 minutes (see Figure 3. 19). Nitrogen pressure and flow were the same as in standard conditions. After this sequence a dc probe discharge (\( p=5.3 \) mbar, \( i=100 \) mA, \( \tau=10 \) ms) in O\(_2\) was applied.

Figure 3. 19 shows NO production in the probe discharge after upstream, downstream and standard (full length) \( N_2 \) plasma pretreatment. One can note that half size pretreatment yields
Adsorption and reactivity of N atoms

approximately two times less production of nitric oxide and that both upstream and downstream configurations result in almost the same amount of NO. If the adsorption sites for N$_{ads}$ on SiO$_2$ were available after argon plasma cleaning, N atoms produced in the upstream configuration would be transported by the gas flow and adsorbed in the downstream region. But this adsorption is not observed within the uncertainty of the measurements which was $\sim 2 \cdot 10^{12}$ N atoms per cm$^2$.

This means that adsorption of neutral nitrogen atoms on neat SiO$_2$ is very weak. Significant amount of N$_{ads}$ is grafted to the surface only under direct N$_2$ plasma exposure and as we have seen adsorption is slow so a SiO$_x$N$_y$ layer has enough time to be formed. In other words, N$_{ads}$ represent a reactive superficial nitrogen atoms on the SiO$_x$N$_y$ layer formed on SiO$_2$ under N$_2$ plasma exposure.

![Figure 3. 19 Comparison of NO production in the probe discharge after three different pretreatment configurations.](image)

3.4.3.2 Are N$_{ads}$ active for recombination of N on the surface?

Once the SiO$_x$N$_y$ layer is formed and the coverage of N$_{ads}$ has reached the saturation, do these reactive atoms participate in surface recombination of N? To answer this question we use again isotopic exchange under $^{30}$N$_2$ plasma exposure. But in order to improve the sensitivity instead of measuring $^{29}$N$_2$ produced on the surface we detect isotopologues of NO in the probe discharge in O$_2$.

![Figure 3. 20 Experimental procedure for investigation of isotopic exchange with TDLAS diagnostics.](image)
Chapter III

Schematics of the experimental procedure is shown in Figure 3. First, silica discharge tube was pretreated by N\textsubscript{2} plasma in standard conditions during 60 minutes. Then it was pumped and filled with \textsuperscript{30}N\textsubscript{2} at p=0.53 mbar and pulsed dc discharge was applied in closed reactor (i=100 mA, \(\tau\)=5 ms). Then the reactor was pumped again and filled with O\textsubscript{2} at 5.3 mbar and a single probe pulse (i=100 mA, \(\tau\)=10 ms) was applied. Production of \textsuperscript{15}NO and \textsuperscript{14}NO in the probe discharge was detected \textit{in-situ} using TDL spectrometer. Surface coverage of \textsuperscript{14}N\textsubscript{ads} and \textsuperscript{15}N\textsubscript{ads} was calculated based on the maximum measured concentrations of \textsuperscript{15}NO and \textsuperscript{14}NO.

Figure 3. 21 a) shows an example of simultaneous time resolved measurements of \textsuperscript{15}NO and \textsuperscript{14}NO production on the surface in the probe discharge. In panel b) the coverage of \textsuperscript{14}N\textsubscript{ads} and \textsuperscript{15}N\textsubscript{ads} as a function of the number of discharge pulses in \textsuperscript{30}N\textsubscript{2} is shown. One can see that atoms \textsuperscript{14}N are replaced by \textsuperscript{15}N while the total coverage stays constant. The rate of \textsuperscript{14}N\leftrightarrow\textsuperscript{15}N exchange should be compared with the number of \textsuperscript{15}N lost on the surface (see the estimation made in § 3.3.2.3). The fastest exchange rate was observed during the first discharge pulses in \textsuperscript{30}N\textsubscript{2}. After five dc pulses in \textsuperscript{30}N\textsubscript{2} the coverage of \textsuperscript{14}N\textsubscript{ads} replaced by \textsuperscript{15}N\textsubscript{ads} is 1.2 \times 10^{13} \text{ cm}^{-2} but the number of \textsuperscript{15}N lost on the surface is 10^{15} \text{ cm}^{-2}. This means that only a small fraction of \textsuperscript{15}N (approximately 2\%) recombine with \textsuperscript{14}N\textsubscript{ads}. This experiments show that even the most reactive N\textsubscript{ads} on the surface – \textsuperscript{14}N\textsubscript{ads} are not efficient for surface recombination of \textsuperscript{15}N.

Even using diagnostics capable of detecting surface coverage of N\textsubscript{ads} of the order of 10^{12} \text{ cm}^{-2} we haven’t found N\textsubscript{ads} that are active for N recombination on the surface. We think that hypothesis (i) proposed in § 3.3.4.2 is more plausible, recombination of nitrogen atoms on the surface takes place on weakly bonding active sites. Atoms adsorbed on these sites are not stable, they leave the surface shortly after the end of plasma exposure that is why they are not detected in the probe discharge.

Figure 3. 21 a) Time resolved measurements of \textsuperscript{14}NO and \textsuperscript{15}NO in a 10 ms, 100 mA probe discharge in O\textsubscript{2} at p=5.3 mbar after standard pretreatment with \textsuperscript{30}N\textsubscript{2} rf discharge followed by 50 dc discharge pulses in \textsuperscript{30}N\textsubscript{2} b) Coverage of \textsuperscript{14}N\textsubscript{ads} and \textsuperscript{15}N\textsubscript{ads} as a function of the number of dc pulses in \textsuperscript{30}N\textsubscript{2} measured using TDLAS.
Adsorption and reactivity of N atoms

3.5 Discussion and conclusions

To the best of our knowledge nitrogen atoms chemisorbed on the surface of SiO$_2$ have never been observed experimentally. Thus, our starting point was the model description of atomic recombination of Kim&Boudart [5] and similar [22][26][110]. We expected that after N$_2$ plasma exposure the surface of silica would be covered with chemisorbed N atoms having the density of the order of $10^{13}$ - $10^{14}$ cm$^{-2}$. According to [5] chemisorbed atoms effectively recombine with N coming from the gas phase and play the role of the main active sites for atomic recombination on the surface.

The real picture of interaction between N$_2$ plasma and silica surface turned out to be more complex. Here are the main results of this chapter.

Adsorption of N

- Under N$_2$ plasma exposure silicon oxynitride layer is formed on the surface of silica discharge tube. In our standard pretreatment conditions the density of N$_{ads}$ is increasing as a square root of the pretreatment duration; $[N_{ads}](1s) = 1\cdot10^{14}$ cm$^{-2}$ and $[N_{ads}](3600s) = 6\cdot10^{15}$ cm$^{-2}$.
- Nitridation is driven by ion bombardment and it takes place only under direct N$_2$ plasma exposure. When silica surface is exposed to a flowing post-discharge nitridation is negligible. Therefore, material of the surface in discharge and flowing post-discharge zones is completely different (SiO$_x$N$_y$ in plasma zone and SiO$_2$ in the post-discharge zone). This may partially explain the enhancement of $\gamma_N$ under direct plasma exposure reported in [101].
- Formation of SiO$_x$N$_y$ layer is very sensitive to the presence of O$_2$ admixtures in N$_2$ plasma. Addition of 0.1% of O$_2$ into N$_2$ reduces the number of grafted N atoms by a factor of 10. Therefore, condition of the reactor surface is strongly dependent on the composition of the gas mixture.

Reactivity of N$_{ads}$

- Under N$_2$ plasma exposure, N$_{ads}$ are continuously replaced. We have found two groups of N$_{ads}$: i) first with a characteristic turnover time ~ 10 s in our standard rf discharge conditions ii) second having the characteristic replacement time ~ 300 s. The first group was assigned to N on the outmost surface layer and the second one to N distributed in the SiO$_x$N$_y$ layer. Our results demonstrate that under direct N$_2$ plasma exposure the surface is not static, it is continuously modified due to the exposure to ion and atomic fluxes.
- Nitrogen atoms on the surface of SiO$_x$N$_y$ exhibit a distribution of reactivity. We have found a small fraction of N$_{ads}$ (having a coverage $[N^\ast_{ads}]=3.5\cdot10^{13}$ cm$^{-2}$) that readily recombine with atomic oxygen producing NO molecules.
• N_ads participate in recombination of N on the surface, but recombination with these atoms cannot explain the rate of N losses on the surface. We suppose therefore that recombination of N atoms takes place on weakly bonding active sites.

What is the nature of these weakly bonded atoms that are active for recombination? They may be either (i) physisorbed or (ii) chemisorbed but with a relatively small binding energy.

Models of surface recombination [5][26] predict that at room temperature the coverage of physisorbed atoms on silica-like surfaces is small and LH recombination between two physisorbed atoms or ER recombination between physisorbed and gas phase atoms is negligible. We think that hypothesis (ii) is more plausible. According to the estimation made in § 1.1.1.2 atoms with binding energy smaller than approximately 1 eV are weakly chemisorbed. Existence $N^{\text{weak}}$ signifies that on the surface there exists a distribution of chemisorption sites with different adsorption energies. Real silica surface is not perfectly smooth and homogeneous, as one can clearly see on a microscope image of quartz shown in Figure 3.22 (the image is taken from [20]). Therefore different adsorption configurations of N may exist leading to the presence of relatively weakly bonded chemisorbed species that efficiently participate in surface recombination.

Recently, distribution of binding energies of O atoms on different surfaces has been demonstrated in spinning wall experiments of Donnelly et al. [54]. Similarly to the results of this section, authors [54] show that stable strongly bonded O atoms are not efficient for LH recombination on the surface of the rotating substrate. According to [54], O_ads that participate in surface recombination have the lifetime on the surface of the order of few milliseconds.

![Figure 3.22 Microscope image of quartz published in [20].](image)

It is interesting to note that even ideal crystalline SiO$_2$ surface may possess different types of adsorption sites. A recent ab-initio study of O and N adsorption on β–cristobalite [40] has revealed adsorption configurations with binding energies in the range 0.2 – 6 eV. Therefore, distribution of binding energy of atoms on real surfaces is a general phenomenon and it should be taken into account in the modelling of surface atomic recombination.
Adsorption and reactivity of N atoms

Based on the observations made in this chapter we conclude that the mechanism of N recombination on the surface of SiO$_2$ under plasma exposure differs from simplified picture used in mesoscopic models. Three types of N atoms on SiO$_2$ surface exposed to N$_2$ plasma can be distinguished:

- Atoms incorporated in SiO$_{x}$N$_{y}$. These atoms are distributed in the 2-3 nm thick surface layer, they compose the material of the surface and their contribution to recombination of N is negligible.
- Stable N atoms on the surface of SiO$_{x}$N$_{y}$. Reactions with these atoms account for maximum 20% of atomic nitrogen losses on the surface. Among these atoms we have found a small fraction of reactive N$_{ads}^*$ that produce NO in reactions with atomic oxygen.
- Weakly bonded N atoms with binding energy inferior to $\approx$1 eV. Surface recombination proceeds mainly via reactions of these unstable atoms.

Schematically different groups of N atoms are shown in Figure 3. 23. In the first figure the spatial distribution of N on the surface is shown. In the second case we tentatively arrange different groups as a function of their binding energy on the surface.

Figure 3. 23 Schematic representation of different group of N atoms on silica surface.
3.5.1 Summary and conclusions on used diagnostics

In this section we have employed three different techniques in order to probe the coverage and reactivity of nitrogen atoms on SiO$_2$ pretreated by N$_2$ plasma. Apart from XPS which is a classical diagnostics for surface analysis, two other methods were developed and validated in this work. Here we list the main advantages and limitations of the used experimental techniques.

XPS:
- ✔ Real surface diagnostics – gives information about binding configurations of species on the surface.
- ✔ Absolute measurements of surface concentrations are possible.
- ✗ Not sensitive to the reactivity of adsorbed species.
- ✗ Ex-situ. Samples may be modified when exposed to air.
- ✗ Bad sensitivity ($[N_{ads}] \approx 10^{14} \text{ cm}^{-2}$).

Isotopic exchange:
- ✔ Gives information about reactivity of adsorbed N atoms.
- ✔ Absolute measurements of surface concentrations are possible.
- ✔ Rather sensitive, detection limit is of the order of $10^{13} \text{ cm}^{-2}$.
- ✔ In-situ.
- ✗ It is not possible to follow the kinetics of surface reactions in real time.

Titration with NO:
- ✔ Gives information about reactivity of adsorbed N atoms.
- ✔ Very sensitive, detection limit $10^{12} \text{ cm}^{-2}$.
- ✔ In-situ.
- ✔ Time-resolved measurements of the kinetics of surface recombination.
- ✗ Absolute measurements of surface concentrations are difficult because produced NO further reacts on the surface and in the gas phase.

Table 3. 7 summarizes the characteristics of the diagnostics used to probe the coverage and reactivity of N on the surface.

<table>
<thead>
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<th>binding config.</th>
<th>sensitive to react.</th>
<th>abs. coverage</th>
<th>in-situ</th>
<th>detection limits</th>
<th>time resolution</th>
</tr>
</thead>
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<td>✗</td>
<td>✔</td>
<td>✗</td>
<td>$10^{14} \text{ cm}^{-2}$</td>
<td>$10^2 \text{ s}$</td>
</tr>
<tr>
<td>Isotopic exchange</td>
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<td>✔</td>
<td>✔</td>
<td>✔</td>
<td>$10^{13} \text{ cm}^{-2}$</td>
<td>0.1 s</td>
</tr>
<tr>
<td>NO production</td>
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<td>✗</td>
<td>✔</td>
<td>$10^{12} \text{ cm}^{-2}$</td>
<td>$10^{-3} \text{ s}$</td>
</tr>
</tbody>
</table>

Table 3. 7 Summary on the diagnostics used to probe the coverage and reactivity of N on the surface.
Adsorption and reactivity of N atoms
4. Chapter IV: Adsorption and reactivity of oxygen atoms on oxide surfaces under plasma exposure

4.1 Introduction

Fundamentally, interaction between O atoms and silica-like surfaces is analogous to the case of N-SiO$_2$ that we have studied in the previous chapter. For example, in Kim&Boudart [5] model parameters (activation energy, active site density, etc.) found for O and N recombination on silica are identical. Similarly to $\gamma_N$, the values of $\gamma_O$ published in the literature exhibit a strong scatter [21][46]. According to [21][110] the value $\gamma_O$ on the surface in direct contact with the plasma is systematically higher than on unexposed surface.

In spite of named similarities, several particular features of interaction between O$_2$ plasma and silica-like (and more generally oxide) surfaces can be outlined:

- Oxide materials such as silica, Pyrex or TiO$_2$ are already composed of atomic oxygen. Therefore, under O$_2$ plasma exposure the chemical nature of oxide materials will not be changed in contrast to oxynitride formation observed in experiments with N$_2$ plasma.
- We have found that N$_{ads}$ are particularly stable and weakly reactive. Several test experiments have been done (not mentioned in the previous chapter) showing that N$_{ads}$ do not react with stable molecules such as NO, NO$_2$, N$_2$O, CO$_2$, CO, C$_2$H$_2$. Atomic oxygen is a strong oxidizing agent, in [8] it has been shown that stable O adsorbed on catalyst materials under plasma exposure are capable of oxidizing CO into CO$_2$. Therefore, in case of O$_{ads}$ we will specially focus on the reactivity of O$_{ads}$ towards stable molecules.
- In recombination of atomic oxygen on the surface two channels are possible: (O+O)$_w$→O$_2$ and (O+O$_2$)$_w$→O$_3$. The second mechanism is usually overlooked, but recently it has been shown that it may be an important source of ozone as well as an efficient loss mechanism of atomic oxygen in O$_2$ plasmas [107][111]. As it was discussed in § 1.1.3, the bond strength of O in ozone $D$(O-O$_2$)=1.04 eV and only O with binding energy smaller than 1.04 eV may participate in O$_3$ formation on the surface. Therefore, formation of ozone takes place in reactions of O$_{weak}$.

Our aim in this chapter is to understand how oxygen atoms are adsorbed on oxide surfaces under O$_2$ plasma exposure and to evaluate their role in surface-catalyzed reactions of stable molecules and radicals.
Adsorption and reactivity of O atoms

4.1.1 Experimental procedures

In this study we use the approach described in Chapter 1 that consists in the pretreatment of the surface by O₂ plasma followed by the study of grafted O species. Three different materials are investigated: silica, Pyrex and TiO₂. The pretreatment is performed using a flowing rf discharge in O₂ in standard conditions (see Table 3.1). Then we probe the pretreated surface in order to answer the following questions:

- What is the coverage of O_{ads}?
- What is their role in surface recombination of O?
- How O_{ads} participate in surface oxidation of stable molecules such as NO and C₂H₂?

It should be noted, that we work with oxide catalysts that already contain oxygen atoms. This makes difficult the detection of adsorbed O species by surface analysis techniques (such as XPS). Therefore, the following experiments have been performed:

- Reactivity of O_{ads} under 36O₂ plasma exposure: the surface pretreated by rf discharge in 32O₂ is exposed to plasma in 36O₂. Molecules 18O₁₆O produced on the surface are then detected using the mass spectrometer. Procedure with inverted order is also employed – first 36O₂ plasma pretreatment and then 32O₂ probe discharge.
- Reactivity of O_{ads} in the post discharge: a controlled amount of probe molecules (NO, NO₂, C₂H₂) is introduced in the pretreated reactor in static conditions. Then the kinetics of surface reactions is followed using laser absorption spectroscopy or mass-spectrometry.
- In order to get insight in the reactivity of O^{weak} we investigate ozone formation on the surface in a pulsed dc discharge in O₂. Time resolved measurements of O and O₃ concentrations are performed using TALIF and UV absorption spectroscopy.

4.2 Chemisorption of O on silica-like surfaces: isotopic study

In experiments with heavy nitrogen isotopes we have seen that isotopic exchange on the surface under plasma exposure allows characterization of the coverage and reactivity of adsorbed atoms and their role for surface atomic recombination. In this section we use ¹⁶O→¹⁸O exchange coupled with mass spectrometric diagnostics in order to investigate adsorption and reactivity of O atoms on the surface of silica and Pyrex.

4.2.1 Experimental details

Typical experimental procedure is shown in Figure 4. 1. First, the discharge tube made of silica or Pyrex was cleaned by an rf discharge in argon during 30 min in standard conditions (see Table 3.1). Then 30O₂ gas (Icon Isotope Services 99 at. % of ¹⁸O) was introduced in the reactor at p=0.53 mbar and standard rf discharge (see Table 3.1) was started in static
conditions for time duration in the range $10^1 - 10^3$ s. Then the reactor was pumped and an identical rf discharge in $^{32}\text{O}_2$ at $p=0.53$ mbar was applied in order to probe adsorbed $^{18}\text{O}$ left on the surface after the first step. Oxygen gas was sampled to the quadrupole mass spectrometer (QMS) after each plasma step.

Figure 4.1 Schematics of the experimental procedure.

In oxygen, exchange reactions like $^{18}\text{O} +^{16}\text{O}^{16}\text{O} \leftrightarrow ^{16}\text{O} +^{18}\text{O}^{16}\text{O}$ are very fast [107]. Thus in the discharge, a statistical isotopic distribution of three $\text{O}_2$ isotopologues is always established. The signals at $m=32$, 34 and 36 a.m.u. were measured with the QMS in order to determine the number of oxygen atoms that were picked up from the surface. Figure 4.2 shows an example of the mass-spectrometric measurements performed on the “Step 1”. Mass peaks at $m=32$ and $m=34$ a.m.u. appear with increasing the duration of the discharge in $^{36}\text{O}_2$.

Figure 4.2 Mass spectra obtained after various duration of rf discharge in $^{36}\text{O}_2$ in Pyrex discharge tube. Reactor was initially cleaned by argon plasma during 30 min.

Relative measurements of the isotopic composition were converted in absolute gas phase concentrations using the known value of the gas pressure. The coverage of $\text{O}_{\text{ads}}$ was
Adsorption and reactivity of O atoms

determined using the surface to volume ratio of the reactor as in § 3.3.1. The detection limit of O$_{ads}$ was estimated to be approximately $10^{13}$ cm$^{-2}$.

4.2.2 Do O atoms of the material participate in surface reactivity?

First we investigate the Step 1 shown in Figure 4.1. As we will see in the following sections, after argon plasma cleaning the surface is free from adsorbed oxygen atoms. The appearance of $^{16}$O in the gas phase under $^{36}$O$_2$ plasma exposure may be ascribed only to the reactivity of oxygen from the crystalline network of silica or Pyrex. In Figure 4.3 the surface density of $^{16}$O atoms picked-up from the surface is shown as a function of the duration of $^{36}$O$_2$ plasma exposure in the range 0.1 – 480 s.

![Figure 4.3 Evolution of the density of $^{16}$O atoms picked up from the surface as a function of the probe discharge duration in $^{36}$O$_2$. Silica and Pyrex discharge tubes were pre-treated by Ar plasma during 30 minutes.](image)

The coverage of $^{16}$O atoms that were picked up from the surface reaches $(5-6) \cdot 10^{15}$ cm$^{-2}$ after 480 s of $^{36}$O$_2$ plasma exposure. The coverage of $^{16}$O$_{des}$ is measured with respect to the geometric surface area of the tube without taking into account surface roughness. According to literature data [26][27] obtained value of $^{16}$O$_{des}$ is comparable to one full monolayer on silica-like surface. The initial rate of $^{16}$O desorption is $5 \cdot 10^{14}$ atoms s$^{-1}$ cm$^{-2}$ and it decreases to $5 \cdot 10^{12}$ atoms s$^{-1}$ cm$^{-2}$ after 400 s of $^{36}$O$_2$ plasma exposure. This may be explained by a fast removal of superficial oxygen followed by much slower extraction of atoms from sub-surface layers. It is interesting to note that results obtained with silica and Pyrex are almost identical. This means that the density and binding of O atoms in these materials are similar.

In the $^{36}$O$_2$ discharge, $^{16}$O atoms removed from the surface are replaced by $^{18}$O. This was verified on the “Step 2” of the experiment. After the $^{36}$O$_2$ plasma exposure, the reactor was refilled with $^{32}$O$_2$ and a 240 s rf discharge was applied is static conditions. In Figure 4.4, the
coverage of $^{18}$O desorbed from silica surface during $^{32}$O$_2$ discharge is plotted as a function of the $^{36}$O$_2$ discharge duration. For comparison the coverage of $^{16}$O desorbed from the surface during the Step 1 is also shown.

![Figure 4.4](image)

Figure 4.4 Evolution of the coverage of $^{16}$O desorbed from the surface of silica discharge tube under $^{36}$O$_2$ plasma exposure (Step 1) as in Figure 4.3. On the second step $^{18}$O was desorbed from the surface by a discharge in $^{32}$O$_2$ during 240 s.

One can see that the coverage of desorbed $^{18}$O atoms is always smaller than the amount of desorbed $^{16}$O. From the first glance this result seems counterintuitive because we would expect that $^{36}$O$_2$ plasma grafts some extra $^{18}$O atoms to the surface compared to Ar cleaning performed before the Step 1. Observed effect can be explained by the diffusion of $^{18}$O into the bulk of SiO$_2$ atoms that diffuse inside the material are no longer accessible to the probe discharge in $^{32}$O$_2$. The diffusion of O in the SiO$_2$ network has been observed experimentally at moderate temperatures in [112]. Local surface heating and ion bombardment under direct $^{36}$O$_2$ plasma exposure may further promote the diffusion of $^{18}$O from the surface.

In addition for relatively long $^{36}$O$_2$ pretreatment times, 240 s of $^{32}$O$_2$ probe discharge may be not enough to desorb all the available $^{18}$O. That explains the saturation of $^{18}$O desorption shown in Figure 4.4 while $^{16}$O is still increasing with increasing the $^{36}$O$_2$ exposure time.

Our results demonstrate that under direct O$_2$ plasma exposure oxygen atoms of silica-like materials are continuously exchanged. Therefore, the surface is constantly re-structured and it cannot be considered as a static system.

It is interesting to compare the kinetics of $^{16}$O desorption from silica surface under $^{36}$O$_2$ plasma (shown in Figure 4.4) with the analogous measurements of $^{14}$N desorption performed in $^{30}$N$_2$ discharge after $^{28}$N$_2$ plasma pretreatment of silica surface (from Figure 3.11). Surprisingly, the kinetic curves superimposed in Figure 4.5 are almost identical regardless the difference in the plasma forming gas and the chemical nature of the surface. The only
Adsorption and reactivity of O atoms

parameters which were kept the same in two experiments are the gas pressure and the injected power.

![Graph showing desorption of O atoms under plasma exposure](image)

Figure 4.5 Comparison of the kinetics of desorption of atoms from the surface under plasma exposure. In the first case we observe desorption of $^{14}$N under $^{14}$N$_2$ plasma exposure from silica surface pretreated by $^{12}$N$_2$ discharge (data from Figure 3.11). In the second case we observe desorption of $^{16}$O from silica under $^{36}$O$_2$ plasma exposure (data from Figure 4.4).

Observed result points to the similarity of the mechanism of removal of atoms from the surface in both cases. With the same power injected in the discharge, the dissociation rate in nitrogen is much lower than in oxygen. In [113] authors show that the energy cost of N$_2$ dissociation in electrical discharges ($\sim$100 eV per produced atom) is typically 10 times higher than in the case of O$_2$ ($\sim$10 eV per produced atom). This is explained by higher dissociation threshold in N$_2$. Therefore, atomic fluxes on the surface in the experiments shown in Figure 4.5 are expected to be quite different. On the contrary, ion flux on the surface is proportional to the density of electrons which is controlled by the injected power. Therefore, ion fluxes in O$_2$ and N$_2$ should be comparable. We suppose that ion bombardment plays an important role in the observed isotopic exchange of N and O atoms on the surface.

We don’t know yet if ions themselves participate in the exchange of surface atoms or there is a synergetic effect between the ions and neutral atoms. Experiments in which the surface is exposed to independent atomic and ion beams should be performed in order to separate different contributions.

4.2.3 $^{16}$O adsorption on the surface under $^{32}$O$_2$ plasma exposure

In this experiment we investigate if O atoms can be grafted to the surface under O$_2$ plasma exposure. Experimental procedure is shown schematically in Figure 4.6. The surface is probed by a rf discharge in $^{36}$O$_2$ in standard conditions and we compare desorption of $^{16}$O
from the surface after argon plasma cleaning (“Step 1” in Figure 4.1) and after $^{32}\text{O}_2$ plasma pretreatment during 20 minutes in standard conditions.

![Experimental procedure](image)

Figure 4. 6 Experimental procedure.

In Figure 4. 7 desorption kinetics of $^{16}\text{O}$ after argon and $^{32}\text{O}_2$ plasma pretreatment are compared. One can see that for both silica and Pyrex $^{32}\text{O}_2$ pretreatment yields somewhat higher desorption of $^{16}\text{O}$. This indicates that some extra $^{16}\text{O}$ were grafted to the surface by $^{32}\text{O}_2$ plasma. The desorption curves almost coincide during the first 60 s of $^{36}\text{O}_2$ plasma exposure for silica and 20 s for Pyrex.

![Comparison of $^{16}\text{O}$ desorption](image)

Figure 4. 7 Comparison of $^{16}\text{O}$ desorption from silica (left panel) and Pyrex surface (right panel) under $^{36}\text{O}_2$ plasma exposure after argon plasma pretreatment and $^{32}\text{O}_2$ plasma pretreatment.

If adsorbed oxygen atoms were active for surface recombination, we would expect to observe a fast desorption of $^{16}\text{O}$ in the beginning of $^{36}\text{O}_2$ probe discharge corresponding to grafted $^{16}\text{O}$; followed by a parallel evolution of two curves due to the exchange of $^{16}\text{O}$ belonging to the material. Two possible hypotheses may be proposed in order to explain the slow increase of the difference between the desorption curves shown in Figure 4. 7 a) and b):

- $^{16}\text{O}$ grafted to the surface by $^{32}\text{O}_2$ plasma are weakly reactive.
- After argon cleaning the state of the surface is modified so a direct comparison between Ar and $^{32}\text{O}_2$ pretreatments is not meaningful. In fact, when we compare the results obtained after two different surface pretreatments we suppose that the effect of argon plasma is just “cleaning” and removal of adsorbed O. In [114] it is shown that argon plasma exposure leads to a modification of SiO$_2$ structure and creation of loose
Adsorption and reactivity of O atoms

and broken bonds. Therefore, argon plasma treatment may coarsen the surface and increase the number of $^{16}$O immediately available for exchange under $^{36}$O$_2$ plasma exposure. Therefore, the difference between $^{16}$O desorption after Ar and $^{32}$O$_2$ pretreatments is not ascribed exclusively to the presence of adsorbed $^{16}$O.

More work is required in order to verify which hypothesis is correct. In order to probe the reactivity of adsorbed O atoms it would be desirable to get rid from the reactivity of O of the material. For this, ion bombardment on the surface in the probe discharge should be reduced. Therefore, pulsed probe discharge as in § 3.3.4.2 should be used.

4.2.4 Conclusions on the isotopic study

In this section we have applied the isotopic exchange technique in order to investigate interaction between low pressure O$_2$ plasma and silica-like surfaces (silica, Pyrex). We have found that:

- Under direct O$_2$ plasma exposure, oxygen atoms that compose the outmost layer of studied materials are exchanged with O atoms and ions from the gas phase. The surface density of O atoms that can be exchanged during $5\cdot10^2$ s in our standard pretreatment conditions is of the order of one monolayer $(5-6)\cdot10^{15}$ cm$^{-2}$. Our results show that under O$_2$ plasma exposure the surface of silica-like materials can’t be considered as a static system, it is continuously modified due to ion and atomic exposures.
- Results obtained with silica and Pyrex are very close what indicates that the density and binding of oxygen atoms on the surface of these materials is similar.
- Due to the reactivity of O atoms of the material we were unable to detect unambiguously $^{16}$O atoms adsorbed on the surface after $^{32}$O$_2$ plasma treatment and evaluate their role in surface recombination of O. Experiment with short dc pulses in $^{36}$O$_2$ (similar to one done with $^{30}$N$_2$) should be performed in the future.

4.3 Adsorption of atomic oxygen on Pyrex and related reactivity towards NO

We have seen in the previous section that O atoms that compose the crystalline network of silica or Pyrex participate in surface reactivity under $^{36}$O$_2$ plasma exposure. Therefore, it is difficult to make a distinction between adsorbed O atoms and atoms of the material when the surface is probed by a continuous discharge.

Following the logic of the Chapter III we have tried to observe the formation of NO in surface recombination $(\text{N}+\text{O}_{\text{ads}})_{\text{wall}}$. But no nitric oxide production was observed in a pulsed dc discharge in N$_2$ after O$_2$ plasma pretreatment of the reactor. The main obstacle for detection of surface production of NO in a N$_2$ discharge is the fast reaction $\text{N}+\text{NO} \rightarrow \text{N}_2 + \text{O}$ that may completely destroy all the produced NO molecules.
Chapter IV

In this section we use an alternative way to probe O\textsubscript{ads} on Pyrex, namely we follow the oxidation of NO in the reaction:

\[ \text{O}_{\text{ads}} + \text{NO} \rightarrow \text{NO}_2 \quad (4.1) \]

Absolute measurements of NO and NO\textsubscript{2} give the information about the coverage and the reactivity of O\textsubscript{ads}.

What atoms on the surface are potentially detectable by titration with NO? As it was discussed in § 1.1.3, the reaction (NO + O\textsubscript{ads}) is thermodynamically favourable only if the binding energy of O\textsubscript{ads} on the surface is smaller than the bond strength: \( E_a(\text{O}_{\text{ads}}) < D(\text{O}-\text{NO}) = 3.1 \text{ eV}\). From the other hand we detect only sufficiently stable atoms having the lifetime on the surface of the order of \(10^3\) s. This determines the lower limit of the binding energy of probed O\textsubscript{ads} of the order of 1 eV (see § 1.1.1.2). Thus, only a fraction of adsorbed oxygen atoms with the binding energy lying in the range \(1 \text{ eV} \leq E_a \leq 3.1 \text{ eV}\) can be probed by titration with NO. According to the notation introduced in § 1.7, O\textsubscript{ads} that are reactive towards NO will be denoted O\textsubscript{ads}.'

4.3.1 Experimental details

The experimental procedure is shown schematically in Figure 4.8. First, the inner surface of the discharge tube was pretreated by a flowing rf discharge in O\textsubscript{2} in standard conditions during 60 minutes. Then the reactor was pumped for 10 minutes in order to remove molecular oxygen and let the surface cool down to room temperature. And finally a mixture containing 1\% of NO diluted in argon was rapidly injected in the reactor from the buffer volume at a pressure of 0.045 – 5.3 mbars using fast pneumatic valves. So the concentration of introduced NO was in the range \(10^{13} – 10^{15} \text{ cm}^{-3}\).

![Figure 4.8 Schematics of the experimental procedure.](image)

Trial experiments have shown that NO kinetics is significantly altered by the presence of any metallic parts in direct contact with the plasma. Therefore, the measurements were performed in a specially designed discharge tube having no dc electrodes and no removable sections. So, the discharge was in contact only with Pyrex surface.
Adsorption and reactivity of O atoms

Typically, time evolution of NO and NO\(_2\) concentrations was followed \textit{in-situ} using laser absorption spectroscopy. Concentration of both species were measured one by one in identical experiments using the TDLAS spectrometer capable of detecting one molecule at a time. The reproducibility of successive measurements was better than 10\%, therefore we could compare the kinetics of NO losses and NO\(_2\) production obtained in separate experiments (in identical conditions). Results obtained with TDLAS were confirmed by a series of measurements with a 2-channel QCL spectrometer in which the evolution of NO and NO\(_2\) concentrations was followed simultaneously.

The limit of NO\(_2\) detection with TDLAS was 10\(^{12}\) cm\(^{-3}\); if we assume that one NO\(_2\) correspond to one O\(_{\text{ads}}^*\) picked up from the surface, that corresponds to the surface density of O\(_{\text{ads}}^*\) \(\sim 5 \cdot 10^{11}\) cm\(^{-3}\). Therefore, titration with NO allows detection of the coverage of adsorbed oxygen species the order of 10\(^{-4}\) of a monolayer.

4.3.2 Evidence of NO oxidation by adsorbed O atoms

A series experiments with different initial concentration of injected NO was performed. In Figure 4. 9 TDLAS measurements of NO and NO\(_2\) concentrations in Pyrex reactor pretreated by O\(_2\) plasma are shown. One can see that NO is lost and NO\(_2\) is produced after the introduction of the 1\%NO-Ar mixture. The total concentration (NO+NO\(_2\)) represents the balance of N atoms in the system. When the amount of introduced nitric oxide is small (\(\leq 3 \cdot 10^{13}\) cm\(^{-3}\)), NO is converted completely into NO\(_2\). At higher initial concentrations of NO the balance of N atoms is incomplete; a decrease of the total concentration (NO+NO\(_2\)) with time can be seen.

Test experiments were performed in order to prove that the observed NO\(\rightarrow\)NO\(_2\) conversion is indeed catalyzed by O atoms adsorbed on Pyrex surface under O\(_2\) plasma exposure.

First, the discharge tube was cleaned by a flowing rf discharge in argon in standard conditions during 60 minutes and then NO was introduced in the reactor. No significant decrease of the NO concentration was observed, and the concentration of NO\(_2\) was always below the detection limit.

In the second test experiment we have verified if NO can be oxidized by adsorbed O\(_2\) molecules. The surface was exposed to a flow of molecular oxygen after 60 min long argon plasma cleaning. No losses of NO and no production of NO\(_2\) could be detected in this case.

Described experiments prove that:

- NO is not lost due to the adsorption neither on Pyrex discharge tube nor on the metallic vacuum connections between the reactor and the vacuum system.
- After argon discharge treatment there is no reactive O atoms on the surface of Pyrex. Therefore, possibility “activation” of O atoms of the material by argon plasma may be excluded.
- Adsorbed O\(_2\) do not contribute to NO\(\rightarrow\)NO\(_2\) conversion on the surface.
We can conclude that stable and at the same time reactive towards NO oxygen atoms are adsorbed on the surface of Pyrex under O₂ plasma exposure.

4.3.3 Determination of the surface coverage of adsorbed O atoms

The maximum detected concentration of NO₂ may be used to estimate the coverage of Oₐds. Assuming that the production of NO₂ stops when all the available Oₐds participate in the reaction and taking into account the surface to volume ratio of the discharge tube we have calculated the initial density \( [O_{ads}] = 2.5 \times 10^{14} \, \text{cm}^{-2} \). This value corresponds to the geometrical surface of the tube without taking into account surface roughness.

The non-conservation of the initial value of the concentration of (NO+NO₂) is probably due to the adsorption of NO₂ on the reactor walls or formation of other NOx that are not measured in this study. Thus, probably not all the Oₐds that react on the surface end up as NO₂ molecules in the gas phase. Therefore, obtained value should be considered as the lower boundary of the coverage of \([O_{ads}]\).
Adsorption and reactivity of O atoms

4.3.4 Evidence of a distribution of reactivity adsorbed O atoms

In Figure 4. 9 we can see that the characteristic time of \( \text{NO}_2 \) production increases with increasing the amount of introduced NO. It goes from about 60 s for initial concentration \([\text{NO}]=3 \cdot 10^{13} \text{ cm}^{-3}\) to 1500 s for \([\text{NO}]=1.3 \cdot 10^{15} \text{ cm}^{-3}\). This points to a complex kinetics of oxidation of NO on the surface. For high concentrations of injected NO we may expect poisoning of the surface by adsorbed reaction products (\( \text{NO}_2 \) for example), which is supported by observed decrease of the total concentration of \( (\text{NO}+\text{NO}_2) \). This complicates the analysis of the kinetics of \( \text{NO} \to \text{NO}_2 \) conversion.

According to our results shown in Figure 4. 9, when the initial density of NO is small (\(~3 \cdot 10^{13} \text{ cm}^{-3}\) a complete oxidation of NO into \( \text{NO}_2 \) is achieved. This means that the contribution of adsorbed by-products to the balance of N atoms and poisoning of the surface are negligible. Here we analyse the kinetics of NO oxidation on the surface by further reducing the number of injected NO molecules.

![Figure 4. 10 a) Time evolution of NO concentration in successive injections of 1%NO in Ar at p = 0.045 mbar after single \( \text{O}_2 \) plasma pretreatment of the surface. The reactor was evacuated after each introduction of the gas mixture. b) Characteristic frequency of NO losses \( \nu_{\text{NO}} \) is obtained by fitting the curves from the left panel with \( f=\exp(-t \cdot \nu_{\text{NO}}) \). An example of the fit is shown in the left panel.](image)

Figure 4. 10 shows the time evolution of NO concentration in successive injections of a 1\%NO/Ar gas mixture at 0.045 mbar after a single \( \text{O}_2 \) plasma pretreatment of Pyrex discharge tube. The right panel in Figure 4. 10 shows the characteristic frequency of NO losses calculated using single-exponential fit of curves from the left panel. One can see that the rate of NO oxidation on the surface drops by a factor of 10 between the 1\textsuperscript{st} and the 6\textsuperscript{th} injection of NO.

The number of \( \text{O}^\ast_{\text{ads}} \) that are used for NO oxidation in 6 successive injections is only \(~4 \cdot 10^{13} \text{ cm}^{-2}\), i.e. about 15\% of the estimated total coverage of \( \text{O}^\ast_{\text{ads}} \). A simple reduction of the density of available reactive oxygen atoms upon injections of NO cannot explain the 10 fold decrease of the \( \nu_{\text{NO}} \). Poisoning of the surface with adsorbed \( \text{NO}_2 \) has been also excluded. The only
plausible explanation for the observed reduction of the value of \( v_{NO} \) is the existence of different groups of adsorbed oxygen atoms that have different reactivity towards NO. Therefore similarly to \( N_{ads} \) on SiO\(_x\)N\(_y\), \( O_{ads}^* \) exhibit a distribution of reactivity. Probably, this distribution is related to a distribution of binding energies of adsorbed O atoms on a real inhomogeneous surface.

Based on the NO loss frequency shown in Figure 4. 10, the value of the effective loss probability of NO on pretreated surface can be estimated using the well known expression

\[
\gamma_{NO\rightarrow NO_2} = \frac{2v_{NO}r}{v_{th}}
\]

(3.10)

Where \( r \) is the tube radius and \( v_{th} \) is the average thermal velocity of molecules. This calculation gave a variation of \( \gamma_{NO\rightarrow NO_2} = 2\cdot10^{-7} - 2\cdot10^{-8} \) between the 1st and the 6th injection respectively. For comparison, the value of \( \gamma_{NO\rightarrow NO_2}=2\cdot10^{-7} \) on stainless steel surface in a hollow cathode discharge in air was found in [31].

4.3.5 Conclusions on the study of \( O_{ads} \) reactivity on Pyrex

In this section we have shown that:

- Stable and reactive towards NO oxygen atoms are grafted to Pyrex surface under continuous low pressure O\(_2\) plasma exposure. Reaction NO + \( O_{ads}^* \rightarrow NO_2 \) may be used to titrate \( O_{ads}^* \).

- An important finding is that like in the case of \( N_{ads} \), there exists a distribution of reactivity of \( O_{ads}^* \). We suggest that this distribution is related to the spectrum of binding energies of adsorbed atoms.

The lower limit of the density of \( O_{ads}^* \) was found to be \( [O_{ads}^*] = 2.5\cdot10^{14} \text{ cm}^{-2} \). We don’t know yet if these atoms are active for surface recombination of O. New experiments with \(^{18}\text{O}\) isotopes employing short dc discharge pulses should be performed in order to probe the reactivity of \( O_{ads}^* \) towards \(^{18}\text{O}\). Isotopic exchange \( ^{16}O_{ads}^* \leftrightarrow ^{18}O \) will be then probed by oxidation of \(^{16}\text{O}\) on the surface with the TDLAS detection of \(^{16}ON^{16}\text{O} \) and \(^{16}ON^{18}\text{O} \) products in the gas phase.

4.4 On the role of \( O_{ads} \) for VOC oxidation

In the previous sections we have proven that under O\(_2\) plasma exposure reactive oxygen atoms may be adsorbed and used for oxidation of stable molecules on silica-like surfaces. In this section we will investigate the reactivity of \( O_{ads} \) in connection with air pollution control. In the PhD work of O. Guaitella [64] it has been shown that introduction of high specific surface SiO\(_2\) or SiO\(_2\)/TiO\(_2\) catalysts in a DBD discharge improves the efficiency and
**Adsorption and reactivity of O atoms**

selectivity of $\text{C}_2\text{H}_2$ destruction. Stabilization of reactive atomic oxygen on the catalyst surface has been proposed as one of the possible explanations for observed synergetic effects. Similarly, other authors have demonstrated that O adsorbed on the catalyst surface under plasma exposure participate in the VOC destruction [13][115].

The aim of this section is to investigate the potential of $\text{O}_{\text{ads}}$ for oxidation of $\text{C}_2\text{H}_2$.

### 4.4.1 Context of the study: influence of the chemical nature of the surface on the reactivity of $\text{O}_{\text{ads}}$

The first experiment on $\text{C}_2\text{H}_2$ oxidation by catalytic materials pretreated by low pressure plasma was performed at LPP by Olivier Guaitella and Claudia Lazzaroni. Here we will summarize the main results of this work and give the interpretation that became possible after the study of the reactivity of $\text{O}_{\text{ads}}$ on Pyrex. The details of this work can be found in [116]. The catalysts used in this study were all made of silica fibres coated or not with $\text{SiO}_2$ and $\text{TiO}_2$ nano-particles:

- Silica fibers
- Fibres with 40g/m$^2$ of $\text{SiO}_2$ particles (referenced as “Si40”)
- Fibres with 20g/m$^2$ of $\text{SiO}_2$ particles and 20g/m$^2$ of $\text{TiO}_2$ particles (“Si20Ti20”)

Figure 4.11 shows a microscopic image of the Si20Ti20 material. With different magnification one can see the fibres and the impregnated particles. Strips of catalytic tissue were placed on the inner surface of the discharge tube and pretreated by a pulsed dc discharge in Ar, $\text{O}_2$, $\text{N}_2$ or synthetic air at a pressure 1.3 mbar for 30 minutes. Discharge current was 30 mA, frequency 25 Hz and pulse duration 4 ms. Then a mixture containing 950 ppm of $\text{C}_2\text{H}_2$ in air was injected in the reactor at $p=$1.3 mbar and the kinetics of $\text{C}_2\text{H}_2$ was monitored in-situ using laser absorption spectroscopy. In order to avoid photo catalytic degradation of $\text{C}_2\text{H}_2$ the reactor was covered from the external light.

![Microscopic image of Si20Ti20 material](image-url)

Figure 4.11 A microscopic image of Si20Ti20 material. With different magnification one can see fibres and impregnated particles.

In Figure 4.12 the time evolution of $\text{C}_2\text{H}_2$ concentration after different plasma pretreatment of Si40 and Si20Ti20 materials is shown. One can see that $[\text{C}_2\text{H}_2]$ with Si40 material stays constant for all pretreatments, same result was observed with empty Pyrex reactor and reactor filled with just silica fibres. Losses of $\text{C}_2\text{H}_2$ were observed only when material containing
Chapter IV

TiO\textsubscript{2} was pretreated by plasmas containing O\textsubscript{2}. In [116] it has been concluded that C\textsubscript{2}H\textsubscript{2} molecules can be destroyed by O atoms adsorbed on TiO\textsubscript{2}.

Figure 4. Evolution of C\textsubscript{2}H\textsubscript{2} concentration after different plasma pretreatment of a) Si40 material b) Si20Ti20 material.

Based on the results of previous sections we know that under O\textsubscript{2} plasma exposure adsorbed O atoms would be found on silica and Pyrex as well. However, these atoms are not reactive towards C\textsubscript{2}H\textsubscript{2}. In order to explain this difference of the reactivity of O atoms adsorbed on SiO\textsubscript{2} and TiO\textsubscript{2} it was suggested in [116] that the binding energy of O\textsubscript{ads} on these materials is different. This hypothesis is supported by recent \textit{ab-initio} study of O adsorption on TiO\textsubscript{2} rutile [117] and \textbeta-cristobalite SiO\textsubscript{2} [39]. Calculations have shown that the binding energy of O on SiO\textsubscript{2} (E\textsubscript{ads}=5.9 eV) is considerably higher than on TiO\textsubscript{2} (E\textsubscript{ads}=1-1.5 eV).

Comparison between different surfaces (TiO\textsubscript{2}, SiO\textsubscript{2}, Pyrex) and different target molecules (NO, C\textsubscript{2}H\textsubscript{2}) brings us to the conclusion that the reactivity of adsorbed oxygen atoms depends on both the nature of the \textit{surface} and reacting \textit{molecules}.

Experiments described above gave the first evidence of the specific reactivity of O\textsubscript{ads} on TiO\textsubscript{2}. The main problem of using tissue-like materials was a huge (almost 100 m\textsuperscript{2}) total surface of the catalyst inserted in the discharge tube. In addition TiO\textsubscript{2} particles were distributed inside the tissue as one can see in Figure 4. 11 and different particles received completely different plasma exposure. This made difficult the control of the state of the surface and the results were not reproducible. In addition, for understanding of the mechanism of C\textsubscript{2}H\textsubscript{2} removal by O\textsubscript{ads}, possible oxidation products such as CO\textsubscript{2} and CO should be measured. Therefore, a new experiment was set up.

4.4.2 C\textsubscript{2}H\textsubscript{2} oxidation by adsorbed oxygen atoms on TiO\textsubscript{2}

4.4.2.1 Experimental details

In this study TiO\textsubscript{2} catalyst was deposited on the inner surface of silica discharge tube using sol-gel technique as in [118]. The coating was impregnated with Degussa P25 TiO\textsubscript{2} particles containing anatase and rutile phases in a ratio of about 3:1 [119]. The specific surface of such
Adsorption and reactivity of O atoms

Impregnated coating (38 m²/g) was somewhat lower than of non-deposited P25 powder (48 m²/g). Typically, the mass of deposited catalyst was 0.1 g and hence the total surface area of TiO₂ in the reactor was about 4 m².

Figure 4. Schematics of the experimental procedure.

Schematically the experimental procedure is shown in Figure 4. 13. The surface was pretreated during 30 min by a rf capacitive discharge in O₂ at a pressure of 0.53 mbar, the discharge power was Pₚₒ=16 W. Then a mixture of 1% C₂H₂ in Ar was introduced in the reactor in static conditions. The reactor was covered from the external light in order to avoid photo catalytic degradation of C₂H₂. A 3-channel QCL spectrometer was used for simultaneous in-situ measurements of C₂H₂, CO₂ and CO.

4.4.2.2 Kinetics of C₂H₂ destruction on pretreated TiO₂ surface

Figure 4. 14 shows the time evolution of C₂H₂ and CO₂ concentrations after the introduction of a mixture containing 1% of C₂H₂ in argon at p=2.7 mbar. The number density of C₂H₂ decreases after the introduction and disappears almost completely after 30 min. Upon the removal of C₂H₂ only a small amount of CO₂ is produced (~2·10¹³ cm⁻³). The concentration of CO was always below the limit of detection (~10¹³ cm⁻³).

Observed losses of C₂H₂ may be explained by two mechanisms:

- Adsorption on TiO₂.
- Chemical reactions on the pretreated surface.

To check if C₂H₂ is simply adsorbed on TiO₂, a test experiment was performed. The surface was treated during 30 min by argon plasma and in this case no decrease of C₂H₂ concentration was observed. This proves that acetylene is not adsorbed on clean TiO₂ and the removal of C₂H₂ after O₂ plasma pretreatment is catalyzed by adsorbed O atoms.

In order to determine the maximum amount of C₂H₂ that can be removed by the pretreated catalyst, experiments with different pressures of injected acetylene were performed. The saturation was found at the total number ~ 2·10¹⁷ of C₂H₂ molecules in the reactor. Taking into account the surface area of TiO₂ (4 m²), this corresponds to approximately ~ 5·10¹² C₂H₂ molecules lost per cm². This value is much smaller than the density of Oₐds found on Pyrex (~2·10¹⁴ cm⁻²) after similar O₂ plasma treatment. The coverage of adsorbed oxygen atoms on TiO₂ after O₂ plasma pretreatment is not known; therefore we are unable to conclude if they...
are all reactive towards C$_2$H$_2$ or what we observe is only a small fraction of O$_{ads}$. Very low coverage of O$_{ads}$ reactive towards C$_2$H$_2$ points to the fact that only atoms adsorbed on some specific active sites are capable of oxidizing C$_2$H$_2$.

![Figure 4. Time evolution of C$_2$H$_2$ and CO$_2$ concentrations measured using QCLAS. A mixture of 1% C$_2$H$_2$ in Ar was introduced in the reactor at p=2.7 mbar in static conditions after O$_2$ plasma pretreatment of TiO$_2$.](image)

Production of CO$_2$ shown in Figure 4. 14 represents only 2% of the carbon balance. In order to check if some other products containing C are released upon the destruction of C$_2$H$_2$, mass spectrometric analysis of the gas phase was performed. Mass spectra of the initial mixture (1% C$_2$H$_2$ in Ar) and of the gas mixture in the reactor 30 min after the introduction are shown in Figure 4. 15. No new peaks could be detected in the range 1 – 100 a.m.u. (the graph shows only a zoom on 10 – 50 a.m.u.). Slight increase of peak intensities corresponding to N$_2$ and O$_2$ may be ascribed to the leak in the vacuum system. Being unable to detected important gas phase products of C$_2$H$_2$ oxidation on the surface, we conclude the major products of the reaction (O$_{ads} +$ C$_2$H$_2$)$_{TiO2}$ stay adsorbed on the surface.

### 4.4.2.3 Oxidation of adsorbed reaction intermediates

The products of C$_2$H$_2$ oxidation by O$_{ads}$ stay on the surface of TiO$_2$. We have tried to recover adsorbed species by activating the catalyst in closed reactor with simultaneous detection of C$_2$H$_2$, CO$_2$ and CO. Figure 4. 16 shows the evolution of C$_2$H$_2$ and CO$_2$ concentrations in the conditions of the experiment demonstrated in Figure 4. 14. Approximately 30 minutes after the introduction of C$_2$H$_2$, the reactor was pumped out, filled with argon at 1.3 mbar and the catalyst was activated in two possible ways:

- Heating at 200 °C or 350 °C.
- Exposure with UV lamps (we should not forget that TiO$_2$ is a photo-catalyst).
Adsorption and reactivity of O atoms

One can see that CO$_2$ is released upon heating or UV exposure but no desorption of C$_2$H$_2$ or CO is detected. The absence of C$_2$H$_2$ desorption when the catalyst is heated is yet another proof of the reactive adsorption mechanism. If acetylene was just molecularly adsorbed, we would expect to observe thermal desorption of C$_2$H$_2$.

---

**Figure 4.** Mass spectra of the initial mixture 1% C$_2$H$_2$ in Ar in the beginning and 30 min after the introduction in the reactor. TiO$_2$ surface was pretreated by O$_2$ plasma.

**Figure 4.** Time evolution of C$_2$H$_2$ and CO$_2$ concentrations measured using QCLAS. A mixture of 1% C$_2$H$_2$ in Ar was introduced at p=2.7 mbar in static conditions after O$_2$ plasma pretreatment. After 30 min, the reactor was pumped out and heated at 200°C or 350 °C under Ar atmosphere or exposed to UV light. Concentration of CO was always below the detection limit.
Our results demonstrate that reaction \((O_{ads} + C_2H_2)_{TiO_2}\) produces some adsorbed intermediates that can be thermally or photo-oxidized into \(CO_2\). In other words, oxidation of \(C_2H_2\) by adsorbed oxygen atoms at room temperature is incomplete and \(O_{ads}\) ensure only the first step of oxidation. At present we can only make some hypotheses based on the analogy with the mechanism of the gas phase reaction \(C_2H_2 + O\). Oxidation of \(C_2H_2\) into \(CO_2\) is a multistep process. It is known that there exist two major mechanisms of the first attack of \(C_2H_2\) by \(O\)\[120]:

\[
\begin{align*}
(i) & \quad C_2H_2 + O \rightarrow CO + CH_2 \\
(ii) & \quad C_2H_2 + O \rightarrow HCCO + H
\end{align*}
\]

It would be reasonable to suggest that oxidation of \(C_2H_2\) on the surface proceeds via similar bond breaking pathways. Reaction (i) is less probable because \(CO\) production wasn’t observed experimentally. Resulting fragments may stay adsorbed on the surface. In-situ analysis of adsorbed species (for example transmission FTIR) is required in order to get a deeper insight into the mechanism of \(C_2H_2\) oxidation by \(O_{ads}\) on \(TiO_2\).

4.4.3 Discussion and conclusions on the study of \(O_{ads}\) reactivity on \(TiO_2\)

In this section we have shown that in general the reactivity of \(O\) atoms adsorbed on oxide surfaces depends on both the nature of the surface and reacting molecules. For example, \(O\) atoms adsorbed on Pyrex and reactive towards \(NO\) are not useful for oxidation of \(C_2H_2\). Whereas \(O\) atoms adsorbed on \(TiO_2\) are capable of oxidizing \(C_2H_2\). Probably, the difference in the reactivity of \(O_{ads}\) is related to the difference in their binding energy: atoms that are less bonded to the surface are more reactive. In order to further compare the reactivity of \(O_{ads}\) on Pyrex and \(TiO_2\) it would be desirable to investigate \(NO\) oxidation on pretreated \(TiO_2\) surface. But we haven’t performed such experiments because it is known from the literature [121] that \(NO_2\) is adsorbed on \(TiO_2\) and analysis of \(NO\) oxidation kinetics is complicated in this case.

The maximum number of \(C_2H_2\) lost on the \(TiO_2\) surface pretreated by \(O_2\) plasma was \(~5\cdot10^{12}\) molecules per \(cm^2\). It was found that \(C_2H_2\) is oxidized only partially by \(O_{ads}\) leaving some reaction intermediates adsorbed on the surface. Further oxidation of these adsorbed species into \(CO_2\) can be reached by heating or UV activation of the catalyst.

Speaking about the role of \(O_{ads}\) in plasma-catalyst systems for \(VOC\) abatement, we have proven that \(O_{ads}\) can be used for oxidation of organic molecules. But we have employed low pressure discharge in order to graft stable \(O_{ads}\) to the surface. In real applications, atmospheric pressure discharges are used. It is evident that conditions on the surface and especially ion fluxes differ strongly at low and atmospheric pressure. Can we expect the adsorption of oxygen atoms on the catalyst surface in contact with atmospheric pressure discharge?

Recently, Kim et al. [115] have performed isotopic exchange experiments in an atmospheric pressure DBD reactor packed with \(TiO_2\). Authors used a procedure similar to the one that is shown in Figure 4. 1. The surface of \(TiO_2\) was first exposed to a discharge in the mixture \(He^{36}O_2\) and then \(^{16}O^{18}O\) production on the surface was observed when the discharge feed gas
Adsorption and reactivity of O atoms

was switched to He/$^{3}$O$_{2}$. This proves that O$_{ads}$ can be grafted to the surface of TiO$_{2}$ even under atmospheric pressure plasma exposure. Therefore our results are relevant to the real systems used for pollution control. And O$_{ads}$ identified in this study may be responsible for improved efficiency and selectivity of plasma-TiO$_{2}$ combination reported in the literature.

So far we have studied the properties of strongly bonded O$_{ads}$ on oxide surfaces, in the following section we will investigate the properties of weakly bonded atoms O$^{weak}$.

4.5 Investigation of ozone formation on surfaces

In Chapter 3 we have seen that strongly bonded N atoms on SiO$_{x}$N$_{y}$ are not the main sites for N recombination on the surface. Therefore, recombination of N atoms takes place on some weakly bonding active sites. We haven’t yet come to similar conclusions for O recombination on silica-like surfaces. But it would be reasonable to suggest that weakly bonded O may participate in surface recombination of oxygen atoms.

Our aim is to get insight into the reactivity of O$^{weak}$ species on silica surface. Experimental procedures employed so far are appropriate for investigation of adsorbed atoms having the lifetime on the surface of the order of several minutes and more. In order to follow the recombination of unstable adsorbed atoms, fast in-situ diagnostics is required. For example, the spinning wall technique developed by Donnelly et al.[54] is suitable for investigation of adsorbed atoms with the lifetime of the order of 1 ms.

In case of O recombination on the surface one of the possible pathways is the production of ozone:

$$(O + O_{2})_{wall} \rightarrow O_{3}$$  (4.2)

As we have discussed in § 1.1.3, ozone may be produced only in reactions of atoms having the binding energy on the surface inferior to 1.04 eV. Therefore, detection of O$_{3}$ produced on the walls may provide an insight onto the reactivity of O$^{weak}$.

It is interesting to note that reaction (4.2) is very efficient at LN2 temperature. For example in [122], reaction (4.2) has been used for collection of atomic oxygen in the post-discharge of a dc glow discharge in O$_{2}$ on a LN2 trap. Concentration of produced ozone was used as a measure of the dissociation fraction of O$_{2}$ in the discharge. However, reaction (4.2) is completely overlooked in atomic oxygen recombination studies not only at intermediate but also at low surface temperatures [28]. Only recently, ozone formation on the surface has attracted a considerable interest [107] due to an unusual isotopic effect of heterogeneous O$_{3}$ production in comparison to the gas phase mechanism. Lately, Lopaev et al. [111] have also found that reaction (4.2) is an important O$_{3}$ production pathway in O$_{2}$ dc discharge at intermediate pressures (10 – 50 torr).
4.5.1 Experimental details

So far ozone production on silica surface has been reported in continuous $\text{O}_2$ discharges at pressures $p=1–65$ mbar [107] [111]. In cw discharges, due to the presence of electrons and high concentrations of excited species ozone formation is balanced by fast destruction processes what strongly complicates ozone kinetics. In this study we use pulsed dc discharge with short pulse duration of the order of 1 ms. The discharge creates some initial concentration of active species and ozone production takes place in the afterglow. Thus, much smaller number of processes has to be taken into account. In addition, valuable information which is accessible with pulsed discharge technique is the time evolution of species concentrations.

Experiments have been performed in silica discharge tube. In some experiments in order to enhance the role of surface reactions a material made of silica fibres (Si40 material presented in § 4.4.2.1) was placed on the inner surface of the discharge tube. Time resolved measurements of absolute concentrations of $\text{O}$ and $\text{O}_3$ were performed using TALIF and broad-band UV absorption.

4.5.2 Ozone production in bare silica tube

The first step required for ozone production in plasmas is the dissociation of molecular oxygen. The number of $\text{O}_2$ dissociations increases with increasing the energy injected in the discharge and one may expect that ozone production will also increase. However, as it was shown in [109] with increasing the injected energy, ozone destruction in reactions with atomic oxygen, $\text{O}_2(a^1\Delta)$ and $\text{O}_2(b^1\Sigma)$ metastables and due to heating of the gas also increases. This leads to a complex dependence of the resulting concentration of $\text{O}_3$ on the energy injected in the gas. Therefore, an optimum energy input should be found in order to maximize production of $\text{O}_3$.

First, we have performed UV absorption measurements of ozone production in a pulsed discharge in flowing $\text{O}_2$ at a pressure $p=6.7$ mbar. Residence time of the gas in the reactor was equal to 2 second. Pulse repetition frequency was 0.25 Hz so complete gas renewal between discharge pulses was achieved. The amplitude of the applied high voltage was kept constant $U_{\text{HV}}=8.3$ kV. Pulse duration was varied between 0.5 and 10 ms. The concentration of ozone was measured 300 ms after the end of the discharge pulse. As it will be shown later, this delay corresponds to the steady state of $\text{O}_3$ concentration in the post discharge. Energy injected in the gas was calculated from current-voltage waveforms taking into account the cathode fall voltage $U_{\text{cath}} \approx 300$ V[68]. Figure 4. 17 shows current and voltage waveforms of 10 ms discharge pulse in $\text{O}_2$ at $p=6.7$ mbar.
Adsorption and reactivity of O atoms

Figure 4. 17 Current and voltage waveforms, 10 ms discharge pulse in O₂ at p=6.7 mbar.

In Figure 4. 18, the dependence of ozone concentration on the injected energy is shown. One can see that [O₃] increases for E≤0.5 J/pulse and then it starts to decrease. In order to maximize ozone production, for further experiments we have selected E=0.16 J/pulse.

Figure 4. 18 Dependence of O₃ concentration on the energy injected per discharge pulse. Measurements are performed 300 ms after the end of the discharge pulse at p=6.7 mbar.

When the working point was selected, the measurements of ozone production kinetics in the pressure range p=1.3 – 6.7 mbar have been performed while keeping injected energy close to E≈0.16 J/pulse. Applied high voltage was kept U_{HV}=8.3 kV and discharge pulse duration was varied in the range τ=0.5-2 ms. Chosen discharge parameters are listed in Table 4. 1 (see below).
In Figure 4. 19 the kinetics of ozone production is shown. One can see that ozone is formed in the post discharge with the characteristic time is in the range $\tau_{O_3}=60 – 100$ ms. At $p=1.3$ mbar maximum measured concentration of $O_3$ was $7 \cdot 10^{12}$ cm$^{-3}$ which is close to the limit of detection of UV absorption technique ($2 \cdot 10^{12}$ cm$^{-3}$). With a 5 fold increase of the pressure, the maximum ozone concentration increases by a factor of about 30.

Kinetics of ozone is coupled to the kinetics of O atoms. Figure 4. 20 shows the results of TALIF measurements of the absolute concentration of atomic oxygen at the end of the discharge pulse and kinetics of O losses in the post discharge. Discharge conditions were identical to those used for ozone measurements shown Figure 4. 19. Concentration of atomic oxygen is found in the range $[O]=(4-10) \cdot 10^{14}$ cm$^{-3}$. One can see that $[O]$ in the post discharge follows a single-exponential decay with characteristic time $\tau_O= 70 – 140$ ms. Similar to the characteristic ozone production time $\tau_{O_3}$, the value of $\tau_O$ decreases with increasing $O_2$ pressure.

![Figure 4. 19 Kinetics of ozone production in pulsed dc discharge at $p=1.3 – 6.7$ mbar, $t=0$ corresponds to the end of the discharge pulse. Energy injected in plasma was in the range $0.14 – 0.22$ J/pulse. The characteristic time of ozone production was obtained by fitting experimental data with $f=a(1-\exp(-t/\tau_{O_3}))$.](image-url)
Adsorption and reactivity of O atoms

Figure 4. 20 a) Absolute concentration of atomic oxygen measured by TALIF at p=1.3 – 6.7 mbar. Energy injected in plasma was in the range 0.14 – 0.22 J/pulse. b) TALIF measurements of the lifetime of atomic oxygen in the same conditions.

<table>
<thead>
<tr>
<th>p (mbar)</th>
<th>t (ms)</th>
<th>E (J/pulse)</th>
<th>[O₃] (cm⁻³)</th>
<th>[O] (cm⁻³)</th>
</tr>
</thead>
<tbody>
<tr>
<td>1.3</td>
<td>2</td>
<td>0.18</td>
<td>7·10¹²</td>
<td>4·10¹⁴</td>
</tr>
<tr>
<td>2.7</td>
<td>1</td>
<td>0.22</td>
<td>3.7·10¹³</td>
<td>1·10¹⁵</td>
</tr>
<tr>
<td>4</td>
<td>0.5</td>
<td>0.14</td>
<td>9·10¹³</td>
<td>8·10¹⁴</td>
</tr>
<tr>
<td>6.7</td>
<td>1</td>
<td>0.16</td>
<td>2.4·10¹⁴</td>
<td>9·10¹⁴</td>
</tr>
</tbody>
</table>

Table 4. 1 Parameters of pulsed dc discharge in O₂ and results of O and O₃ concentration measurements.

Our objective is to detect ozone produced on the surface. But even at low pressures ozone may be formed in a 3-body reaction (4.3). In order to estimate relative contribution of surface and gas phase mechanisms of ozone formation, let’s first compare characteristic times of relevant processes. The rate of ozone formation in 3-body reaction in the gas phase is well known [111]:

\[
O + O₂ + O₂ \rightarrow O₃ + O₂; \quad k = 6.3 \cdot 10^{-34}\cdot (300/T₀)^2 \text{ cm}^6\text{s}^{-1}
\]  

(4.3)

In Table 4. 2, experimentally measured lifetime of atomic oxygen \(τ₀\) is compared with a calculation of the characteristic time of O losses in reaction (4.3), \(τ_{k1}=(k\cdot[O₂]⋅[O₂])^{-1}\). We can see that at \(p=1.3\) mbar atomic oxygen is lost mainly on the surface due to recombination into \(O₂\) and probably \(O₃\). When the pressure is increased to \(p=6.7\) mbar, the characteristic time of ozone formation in reaction (4.3) becomes comparable with the measured lifetime of atomic oxygen. This means that in our conditions recombination of atomic oxygen in the gas phase reaction (4.3) is not negligible compared to O losses on the surface. Quadratic increase of the rate of (4.3) as a function of the gas pressure may explain experimentally observed decrease of \(τ₀\) and \(τ_{O₃}\) when the gas pressure is increased.
We can conclude that in bare silica reactor the lifetime of atomic oxygen with respect to surface recombination is very long and gas phase reaction (4.3) may significantly contribute to the production of ozone. Therefore, we cannot unambiguously determine the fraction of ozone produced on the surface from experimental measurements of $[O_3]$. In such conditions kinetic modelling is required in order to determine the role of different ozone formation mechanisms. In the following we will perform a simple modelling of ozone kinetics in silica reactor. But an alternative way to identify the role of ozone formation on the surface is to change the nature of the material in contact with the plasma.

### 4.5.3 Ozone production in the presence of high specific surface material

In order to enhance the role of heterogeneous processes, a high specific surface material made of silica fibres coated with $\text{SiO}_2$ particles (Si40 material defined in § 4.4.1) was placed on the inner surface of the discharge tube. In Figure 4. 21 results of TALIF measurements of the lifetime of atomic oxygen in the presence of catalyst are shown. One can see that the decay of $[O]$ is much faster than in bare tube. Obtained values of $\tau_O$ at $p=1.3$ and $6.7$ mbar are approximately equal to the characteristic time of radial diffusion of oxygen atoms to the tube walls. The diffusion coefficient of O atoms decreases with increasing the pressure what explains why the lifetime of atomic oxygen is higher at $p=6.7$ mbar.

![Figure 4. 21 Decay of the atomic oxygen density in the presence of Si40 fibres measured by TALIF, t=0 corresponds to the end of the discharge pulse.](image-url)

<table>
<thead>
<tr>
<th>$p$ (mbar)</th>
<th>$\tau_O$ (ms)</th>
<th>$\tau_{k1}$ (ms)</th>
</tr>
</thead>
<tbody>
<tr>
<td>1.3</td>
<td>140</td>
<td>1460</td>
</tr>
<tr>
<td>2.7</td>
<td>140</td>
<td>364</td>
</tr>
<tr>
<td>4</td>
<td>100</td>
<td>162</td>
</tr>
<tr>
<td>6.7</td>
<td>70</td>
<td>58</td>
</tr>
</tbody>
</table>

Table 4. 2 Comparison between experimentally measured lifetime of atomic oxygen $\tau_O$ and the characteristic lifetime of atomic oxygen $\tau_{k1}$ with respect to the reaction (4.3).
Adsorption and reactivity of O atoms

Listed in Table 4. 2 characteristic times of ozone production in the reaction (4.3) are much longer than the lifetime of O in the presence of the catalyst. Thus, O atoms simply don’t have enough time to form ozone in the gas phase when fibres are introduced. However, absorption measurements demonstrate significant ozone production even in this case. In Figure 4. 22, time evolution of [O₃] at p=6.7 mbar and injected energy E=0.16 J/pulse with and without catalyst is shown.

Figure 4. 22 Comparison of ozone production in pulsed dc discharge at p=6.7 mbar with and without catalytic material inside the reactor. The injected energy was kept the same E=0.16 J/pulse.

One can see that regardless fast losses of O on the surface of silica fibres, even greater amount of ozone is produced in identical discharge conditions. In addition, with the catalyst the characteristic time of ozone production is much smaller than in bare reactor (τₒ₃=9 ms with catalyst and τₒ₃=63 ms in bare tube). Observed fast ozone formation cannot be explained by any gas phase reaction, and, therefore, it necessarily comes from the surface.

We have directly demonstrated that ozone can be formed on silica surface in recombination reaction (4.2). What is the efficiency of the atomic oxygen loss channel (O+O₂)w in comparison with usual recombination into O₂ and adsorption of O on the surface? In order to answer this question we should compare the number of O atoms produced in the discharge with the measured concentration of ozone. We haven’t performed TALIF measurements of atomic oxygen in reactor with introduced catalyst. But fibres were placed on the inner surface of the discharge tube and didn’t significantly modify the geometry of the discharge. We assume that at fixed pressure and injected energy the number of O₂ dissociations with and without the catalyst is the same. Therefore, for further estimations we use absolute [O] measurements performed in bare tube.

Seeing that in the presence of Si40 material losses of atoms and production of ozone take place exclusively on the surface, the ratio η=[O₃]ₘₐₓ/[O]ᵢₙⁱᵗᵢₐˡ represents the fraction of lost
atoms that recombine producing ozone. In conditions shown in Figure 4. 22, \( \eta \approx 0.3 \). This means that at \( p = 6.7 \text{ mbar} \) production of ozone accounts for 30\% of O losses on the surface!

4.5.3.1 Influence of gas pressure and surface pretreatment

We have studied how the value of \( \eta \) depends on the \( O_2 \) pressure and on the state of the \( SiO_2 \) surface. Concentration of ozone was measured 50 ms after the end of the discharge pulse at different gas pressures \( (p = 1.3 – 6.7 \text{ mbar}) \) in the conditions identical to bare tube experiment (see Table 4. 1). Two different types of catalyst surface pretreatment were compared. Normally, fibres were just introduced in the reactor and exposed for few hours to a pulsed dc discharge in \( O_2 \) (“fibres”). “Clean fibres” stands for pretreatment of the surface with a flowing capacitive rf discharge in \( O_2 \) in standard conditions for 1 hour.

In Figure 4. 23, the value of \( \eta \) is plotted as a function of the gas pressure for two types of catalyst preparation. For comparison, results obtained in empty reactor are also shown. As one can see, the value of \( \eta \) in the presence of fibres increases linearly with the pressure. This means that recombination of O and \( O_2 \) on the surface is the first order process with respect to \([O_2]\). In other words, catalyst surface plays the role of the 3rd body for recombination. In the empty reactor the value of \( \eta \) increases as a square of the pressure. This indicates that ozone is produced mainly in the 3 body reaction (4.3).

One can see that after pretreatment of fibres, ozone production is about 3 times less efficient. The same effect was observed when the catalyst was heated at 350°C under \( O_2 \) atmosphere for 1 hour. After cleaning, the efficiency of \( O_3 \) production was recovered to the normal level if the catalyst was left under continuous pumping for several hours.

It is known that water molecules and some hydroxyl groups are efficiently removed from silica surface upon heating or under \( O_2 \) plasma exposure [123][124]. The removal of adsorbed water and/or surface hydroxyls by \( O_2 \) rf discharge (in standard conditions) has been evidenced by optical emission spectroscopy. In Figure 4. 24, emission spectra of the discharge in the beginning and at the end of the cleaning procedure are shown. One can see that after 60 min of plasma exposure the intensity of OH emission band at 310 nm is strongly reduced. Therefore, the most likely explanation for the reduced efficiency of ozone production on clean fibres is the dehydroxylation of the surface. Observed slow recovery of ozone formation efficiency under pumping may be explained by the re-adsorption of water molecules coming from leaks in the vacuum system.

We conclude that the presence of OH and/or adsorbed \( H_2O \) on silica surface favours recombination channel \((O+O_2)_{a} \rightarrow O_3\) with respect to \((O+O)_{a} \rightarrow O_2\). The presence of OH and \( H_2O_{ads} \) on the surface may have a double effect, from the one hand they may play a role of active sites for \( O_3 \) productions and form the other hand they may inhibit the recombination into \( O_2 \).
Adsorption and reactivity of O atoms

Figure 4. 23 Efficiency of surface recombination with production of ozone $\eta$ as a function of the gas pressure. Discharge conditions are the same as listed in Table 4. 1. “Clean” fibres were treated by a capacitive rf discharge during 60 minutes.

Figure 4. 24 Emission spectra of rf discharge in $O_2$ used for cleaning of silica fibres. A strong reduction of the intensity of OH band at 310 nm is seen after 60 min of cleaning.

4.5.4 Modelling of ozone production in bare silica tube

In bare silica tube, surface reactions are slow and gas phase processes significantly contribute to the production of $O_3$. In order to determine the fraction of ozone that comes from the surface, a simple kinetic model was developed. The rates of gas phase reactions are supposed to be known with a good precision. Thus, ozone production on the surface may be evidenced
if gas phase reactions are not able to reproduce experimentally observed kinetics of O₃. The processes that were taken into account in the model are listed in Table 4.3.

Following [111] we suppose that only 1/3 of ozone is formed in vibrationally ground state and 2/3 of produced ozone molecules are excited into asymmetric stretching mode. As in [125] we consider only one effective vibrational level O₃. One can see that destruction of O₃ in collisions with O and O₂(a¹Δ) is much faster that for ground state O₃.

<table>
<thead>
<tr>
<th>Reaction</th>
<th>Rate constant</th>
<th>Ref.</th>
</tr>
</thead>
<tbody>
<tr>
<td>R1</td>
<td>O + O₂ + O₂ → O₃ + O₂</td>
<td>( \frac{1}{2} \cdot 6.3 \cdot 10^{-34} \cdot (300/T_p)^2 \text{ cm}^3\text{s}^{-1} )</td>
</tr>
<tr>
<td>R2</td>
<td>O + O₂ + O₂ → O₃⁺ + O₂</td>
<td>( \frac{1}{2} \cdot 6.3 \cdot 10^{-34} \cdot (300/T_p)^2 \text{ cm}^3\text{s}^{-1} )</td>
</tr>
<tr>
<td>R3</td>
<td>O + O₂ → O₂ + O₂</td>
<td>8 \cdot 10^{-12} \cdot \exp(-2060/T_p) \text{ cm}^3\text{s}^{-1}</td>
</tr>
<tr>
<td>R4</td>
<td>O₂(a¹Δ) + O → O + O₂ + O₂</td>
<td>5.2 \cdot 10^{-11} \cdot \exp(-2840/T_p) \text{ cm}^3\text{s}^{-1}</td>
</tr>
<tr>
<td>R5</td>
<td>O₃⁺ + O → O₂ + O₂</td>
<td>8 \cdot 10^{-12} \cdot \exp(-480/T_p) \text{ cm}^3\text{s}^{-1}</td>
</tr>
<tr>
<td>R6</td>
<td>O₂ + O₂(a¹Δ) → O + O₂ + O₂</td>
<td>5.2 \cdot 10^{-11} \cdot \exp(-1260/T_p) \text{ cm}^3\text{s}^{-1}</td>
</tr>
<tr>
<td>R7</td>
<td>O₂ + O₂ → O₃ + O₂</td>
<td>3 \cdot 10^{-15} \text{ cm}^3\text{s}^{-1}</td>
</tr>
<tr>
<td>R8</td>
<td>O₂ + O → O₃ + O</td>
<td>2 \cdot 10^{-13} \text{ cm}^3\text{s}^{-1}</td>
</tr>
<tr>
<td>R9</td>
<td>O₃ + wall → O₃ + wall</td>
<td>( \gamma = 0.1 )</td>
</tr>
<tr>
<td>R10</td>
<td>O + wall → ½O₂ + wall</td>
<td>( \gamma_0 = 2 \cdot 10^{-4} )</td>
</tr>
<tr>
<td>R11</td>
<td>O₂(a¹Δ) + wall → O₂ + wall</td>
<td>( \gamma = 1.8 \cdot 10^{-4} )</td>
</tr>
</tbody>
</table>

Table 4.3 The list of reactions that were taken into account in the kinetic model.

The recombination probability of O atoms on the surface was determined from the \( \tau_0 \) measurements at \( p=1.3 \) mbar shown in Figure 4.20 b). At this low pressure O losses due to ozone formation in the gas phase are negligible according to Table 4.2. At \( p=1.3 \) mbar ozone formation on the surface is much less efficient than recombination into O₂ as it follows from the measurements shown in Figure 4.23. Therefore, \( \gamma_0 \) can be calculated directly from \( \tau_0 \) using the well known expression [63]:

\[
\gamma_0 = \frac{2r}{\tau_0 v_{th}} \quad (4.4)
\]

where \( v_{th} \) is the average thermal velocity of O atoms. Calculation with (4.4) gives \( \gamma_0 = 2 \cdot 10^{-4} \) which is in a good agreement with literature data for silica [110]. In the model, we suppose that \( \gamma_0 \) is independent of the gas pressure.

An important quencher of ozone in the post discharge is singlet oxygen. The concentration of \( O₂(a¹Δ) \) hasn’t been measured, so it has to be estimated. According to [109], \( O₂(a¹Δ) \) in oxygen plasmas is produced mainly by electron impact excitation of ground state O₂ molecules. In conditions similar to ours [109], it was shown that the lifetime of \( O₂(a¹Δ) \) with respect to quenching by neutral species and de-excitation in collisions with electrons is of the order 100 ms. This means that in our experiments quenching of \( O₂(a¹Δ) \) may be neglected on
Adsorption and reactivity of O atoms

the timescale of the discharge pulse which is always shorter than 2 ms. Thus, the concentration of O$_2$(a$^1\Delta$) at the end of the discharge pulse is equal \[ [O_2(a^1\Delta)] = k_{O2a}n_e[O_2] \tau. \]

Where $n_e$ is the electron density, $k_{O2a}$ is the electron impact excitation coefficient and $\tau$ is the pulse duration. Similarly, one can express the concentration of atomic oxygen as $[O]=2k_{\text{diss}}n_e[O_2] \tau$ because the measured value of $\tau_O$ is always much longer than the pulse duration. Therefore, at the end of the discharge pulse \[ [O_2(a^1\Delta)]/[O] = k_{O2a}/2k_{\text{diss}}. \]

Assuming $E/N=60-100$ Td which is typical for our conditions according to [67] and using Bolsig EEDF solver, the ratio $k_{O2a}/2k_{\text{diss}}$ was found to be in the range 0.5 – 0.2. In the following we will assume that at the end of the discharge pulse $[O_2(a^1\Delta)]/[O]=0.5$ in order to estimate the maximum possible contribution of O$_2$(a$^1\Delta$).

Calculations were performed for the discharge afterglow. Experimentally measured atomic oxygen concentration [O] and the estimated value of [O$_2$(a$^1\Delta$)] were used as an input parameter. In the first instance ozone production on the surface was discarded in the model. The gas temperature was supposed to be equal to the room temperature.

Comparison between experimental results and modelling of ozone kinetics is shown in Figure 4. 25. Two different simulations were performed. In the first case (model 1) we neglected vibrationally excited ozone and assumed that all the O$_3$ molecules are produced in the vibrationally ground state. In the second case (model 2) a complete reaction set from Table 4. 3 was used.

One can see that model 1 strongly overestimates production of O$_3$ in the post discharge. Agreement obtained with the model 2 is somewhat better especially for $p=6.7$ mbar. But for lower pressures the discrepancy with the experiment is still strong. This means that some important reactions of O$_3^*$ are still missing even in the model 2. Probably, multilevel vibrational kinetics of O$_3^*$ should be taken into account as in [111]. However, at present the vibrational level-dependent reaction rates of excited ozone are not known with sufficient precision, and reliability of such detailed modelling would be questionable.

Figure 4. 25 Comparison between experimental and calculated time evolution of [O$_3$]. Model calculations shown in the left panel were performed assuming that ozone is formed in vibrationally ground state. Right panel shows results of a complete model.
Chapter IV

Based on this attempt of kinetic modelling of ozone production we can conclude that:

- In the conditions of our study, the kinetics of **vibrationally excited** ozone is of primary importance for correct description of \( \text{O}_3 \) production.
- But even taking \( \text{O}_3^* \) into account, the model overestimates production of ozone compared to the experiment. Thus in the model, there is no need for an additional (surface) \( \text{O}_3 \) formation term in order to reproduce experimentally measured values of ozone concentration. This means that with the actual knowledge of reaction rates of \( \text{O}_3^* \) it is impossible to assess the probability of ozone formation on the surface in our experiments.

An estimation of the ozone yield from surface recombination in case of bare silica tube can be made based on the results shown in Figure 4. 23. The efficiency of heterogeneous ozone production depends on the hydroxylation of silica surface. In contrast to highly porous Si40 material in which a great part of the surface is shadowed, the surface of bare discharge tube is exposed to uniform ion and atomic fluxes. We may, therefore, expect that under pulsed dc discharge conditions the surface of the discharge tube is free from OH and adsorbed water. Similarly in [57], Cartry following the recombination model of Jumper [41] supposed that under pulsed dc discharge in \( \text{O}_2 \), silica surface is covered by oxygen atoms double bonded to Si atoms of the substrate. In other words, experiments in bare tube correspond to the case “clean” shown in Figure 4. 23. Thus, ozone production on the surface of silica discharge tube represents at maximum 10% of the heterogeneous losses of O in the pressure range \( p = 1.3 – 6.7 \text{ mbar} \). The experimentally obtained value of \( \gamma_0 \) is of the order of \( 10^{-4} \), and hence the probability of ozone formation on silica surface should be of the order of \( 10^{-5} \) in the studied pressure range.

4.5.5 Conclusions on the ozone production study

- In this section we have shown that silica surface may play a role of the third body for ozone formation. Experiments with high specific surface silica fibres have shown that formation of ozone accounts for 30% of surface losses of atomic oxygen at \( p=6.7 \) mbar. Ozone can be formed only in recombination of weakly bonded O with molecular oxygen; hence our results prove the importance of \( \text{O}^{\text{weak}} \) for surface processes in oxygen. The possibility of recombination process \( \left( \text{O}^{\text{weak}} + \text{O}_2 \right) \) indicates that \( \left( \text{O}^{\text{weak}} + \text{O}^{\text{weak}} \right) \) or \( \left( \text{O}^{\text{weak}} + \text{O}^{\text{gas}} \right) \) may also contribute to surface losses of O.
- The presence of adsorbed water and/or hydroxyl groups increases the efficiency of ozone formation on the surface.
- Coming back to experiments in bare silica tube, we have found that in this case surface recombination is not likely to be the dominant source of ozone. This is explained by the fact that in bare tube, the lifetime of atomic oxygen with respect to surface recombination is long and gas phase production of ozone is important even at low pressures.
Adsorption and reactivity of O atoms

Kinetic modelling has revealed a very important role of vibrationally excited ozone as an intermediate of O₃ formation in the gas phase. Destruction of vibrationally excited ozone in collisions with O atoms and O₂(a'Δ) molecules is much faster compared to the ground state O₃. Therefore, introduction of O₃⁺ in the model reduces the resulting O₃ production. Due to the lack of reliable data on the reaction rates of O₃⁺, ozone production was overestimated by the model. As a consequence, determination of the fraction of ozone produced on the surface from comparison between the model and the experiment was not possible.

Results of this section are a good illustration to the fact that quantification of molecule production on the surface using a combination of kinetic modelling and experiment is not always an easy task. Even in such a simple system as an O₂ afterglow, the gas phase kinetics is rather complex and still not fully understood.

4.6 Conclusions

In this chapter we have studied interaction between O₂ plasma and three oxide surfaces – silica, Pyrex and TiO₂. Many similarities with the results of the previous chapter dealing with N-SiO₂ system have been observed. Namely, the exchange of the atoms of the crystalline network under direct plasma exposure, the distribution of the reactivity of adsorbed atoms and the importance of weakly bonded atoms for surface recombination. Below we summarize the main results of this chapter:

- Under direct O₂ plasma exposure, oxygen atoms that compose the outmost layer of silica and Pyrex are continuously exchanged with oxygen atoms and ions from the gas phase. Typically, in our standard pretreatment conditions (5-6)⋅10¹⁵ O atoms per cm² are replaced during 500 s of plasma exposure.
- We have found that under O₂ plasma exposure reactive O atoms are adsorbed on Pyrex or TiO₂. The reactivity of O_ads towards stable molecules depends on the nature of the surface and the target molecule.
- Oxygen atoms adsorbed on Pyrex surface are reactive towards NO (we denote these atoms O_ads⁺). Titration of O_ads⁺ using the reaction NO + O_ads⁺ → NO₂ allowed determination of the lower limit of the coverage [O_ads⁺] = 2.5⋅10¹⁴ cm⁻².
- A distribution of reactivity of O_ads⁺ towards NO have been observed. We suggest that this distribution is related to a spectrum of binding energies of adsorbed atoms. The maximum rate of NO oxidation on the surface corresponds to the effective surface reaction probability γ(NO→NO₂)=2⋅10⁻⁷.
- Oxygen atoms adsorbed on TiO₂ are reactive towards C₂H₂. The maximum number of C₂H₂ lost on the TiO₂ surface pretreated by O₂ plasma was ~ 5⋅10¹² molecules per cm². It was found that C₂H₂ is oxidized only partially by O_ads leaving some reaction intermediates on the surface. Further oxidation of these adsorbed species into CO₂ can be reached by heating or UV activation of the catalyst.
• We have found that ozone may be formed from surface recombination (O+O\textsubscript{2})\textsubscript{w} on silica surface. The presence of adsorbed water and surface OH groups favours ozone production on the surface. At p=6.7 mbar ozone production accounts for 30% of losses of O atoms on silica surface. This result demonstrates the importance of weakly bonded O\textsuperscript{weak} for surface catalyzed reactions in oxygen plasmas.

• Modelling of O\textsubscript{3} production in bare silica reactor has revealed a very important role of the kinetics of vibrationally excited ozone.
5. Chapter V: Study of surface vibrational relaxation of N$_2$

5.1 Introduction

Above we have seen that in low pressure N$_2$/O$_2$ plasmas surface processes play a key role in plasma chemical kinetics. Another aspect of surface interactions in molecular plasmas is heterogeneous vibrational relaxation. Relaxation of vibrationally excited molecules on reactor walls is often the dominant mechanism of losses of vibrational energy in laboratory plasmas at pressures in the mbar range \[126\]. Due to a low energy threshold, vibrational excitation by electron impact is very efficient and it controls the electron energy distribution function. Therefore, the knowledge of the rate of vibrational relaxation on the surface is important for understanding of the overall energy balance in bounded molecular plasmas.

In this work we investigate heterogeneous relaxation of vibrationally excited nitrogen molecules. There are only few published works devoted to the study of N$_2$(v) relaxation on surfaces \[127\][\[128\][\[129\] and they all deal with flowing post-discharge systems. So at present the number of studied surfaces is very limited and very little is known about the effect of plasma exposure on the probability of vibrational relaxation of N$_2$(v) on the surface. In this chapter we develop a new experimental technique for in-situ investigation of vibrational relaxation of N$_2$(v) in plasmas. We use the idea of titrating vibrationally excited N$_2$ by an admixture of infrared (IR) active molecules (CO$_2$, N$_2$O or CO). Gas mixtures containing 0.05 – 1 % of CO$_2$ (CO or N$_2$O) in N$_2$ were excited by a pulsed dc discharge and time resolved quantum cascade laser absorption spectroscopy was used to follow the relaxation kinetics of titrating molecules in-situ. Due to a very efficient vibrational coupling between nitrogen and CO$_2$(N$_2$O, CO), the excitation of titrating molecules reflects the degree of vibrational excitation of N$_2$. In this chapter we apply infrared titration technique to study the quenching of N$_2$(v) on different catalytic surfaces exposed to low pressure N$_2$/O$_2$ containing plasmas.

5.2 Kinetics of vibrationally excited nitrogen

5.2.1 Role played by N$_2$(v) in nitrogen containing plasmas

Vibrationally excited nitrogen molecules have been recognized as an important product of plasma-chemical processes in nitrogen in the 1950s due to their chemical activity \[130\] and high energy storage capacity \[131\]. In the aftermath of a flowing microwave discharge in N$_2$ at a pressure of 3-8 mbar \[132\], the energy associated with vibrationally excited nitrogen (about 0.25 eV/molecule) was found to be much higher than the kinetic energy of N$_2$ molecules. During the subsequent 50 years of research a very important and sometimes
Study of surface vibrational relaxation of N\textsubscript{2}

mysterious role of N\textsubscript{2}(v) in N\textsubscript{2} containing plasmas and afterglows was revealed experimentally and by means of kinetic modelling.

It is almost impossible to cite all the discovered and suggested reactions of vibrationally excited nitrogen molecules in plasmas. Here we will name only few processes:

- Vibration to dissociation (V-D) [97]
  \[ N_2(X, 10<v<25) + N_2(X, 10<v<25) \rightarrow N_2(X) + 2N \]
- Vibration to electronic (V-E) [133]
  \[ N_2(X, v>39) + N(4\text{S}) \rightarrow N_2(A) + N(\text{^3D}) \]
- Vibration to ionization (V-I) [99]
  \[ N_2(X, v>29) + N_2(X, v>29) \rightarrow N_4^+ + e \]
- Chemical reactions [63]
  \[ N_2(X, v>12) + O \rightarrow NO + N \]
- Collisions with electrons
  \[ N_2(X, v) + e \leftrightarrow N_2(X, w) + e \]

One can see that vibrationally excited nitrogen molecules influence directly or indirectly all the important processes in nitrogen containing plasmas. Therefore, understanding of the kinetics of N\textsubscript{2}(v) is indispensable for a correct description of physical-chemical processes in discharges in N\textsubscript{2} and N\textsubscript{2} containing mixtures.

Vibrational kinetics of N\textsubscript{2} may be split into three groups of processes:

- Electron impact excitation and super-elastic collisions with electrons.
- Gas phase vibrational relaxation and vibrational exchange.
- Surface vibrational relaxation.

In subsequent sections we will briefly discuss the actual state of our knowledge of the mechanisms of these processes.

5.2.2 Electron impact excitation/de-excitation of N\textsubscript{2}(v)

Let’s first imagine that N\textsubscript{2} molecule consists of two N atoms connected by an elastic spring and let’s suppose that an electron collides with one of the atoms. As it follows from the conservation of momentum and energy, the part of the kinetic energy of the electron that can be transferred to the atom is of the order of \( m_e/M_N \sim 10^{-4} \), where \( m_e \) is the electron mass and \( M_N \) the mass of N atom. The vibrational quantum of N\textsubscript{2} is \( \approx 0.25 \text{ eV} \); therefore, vibrational excitation in such direct impact with a heavy N atom can be efficient only for very high collision energies. However, it is known from the experiment that low-energy (having few eV) electrons are very efficient for excitation of vibrations of N\textsubscript{2} [134].

Thus, in order to excite N\textsubscript{2} vibrations, colliding electrons have to interact with the molecular electronic shell. In [135] and later theoretical works [136] it was shown that the incoming electron forms with N\textsubscript{2} molecule an unstable compound state, a so-called resonance. Then this negative ion decays and may leave the molecule in a vibrationally excited state. Schematically
Section V

The two-step excitation mechanism is illustrated in Figure 5.1. In Figure 5.2 the \( \text{N}_2(v=1) \) electron impact excitation cross section measured in [134] is shown.

![Figure 5.1 Illustration of the mechanism of electron-impact excitation of \( \text{N}_2 \).](attachment:figure5_1.png)

![Figure 5.2 Electron-impact excitation cross-section of \( \text{N}_2(v=1) \).](attachment:figure5_2.png)

The threshold energy 1.4 eV for \( \text{N}_2(v=1) \) excitation is much higher than the vibrational quanta of \( \text{N}_2 \) and it corresponds to the energy of the negative ion state. The peaks on the cross section may be explained by the interference with different vibrational levels of \( \text{N}_2^- \). The lifetime of \( \text{N}_2^- \) is of the order of few molecular vibrations (~10^{-14} s) and it determines the width of the \( \text{N}_2^- \) energy levels and hence the width of the peaks on the cross section shown in Figure 5.2. The existence of these relatively broad peaks makes vibrational excitation of \( \text{N}_2 \) so efficient in
Study of surface vibrational relaxation of N₂

plasmas. In contrast, molecules that have a stable negative ion state (O₂ for example) exhibit very narrow resonance peaks on the cross-section of electron-impact vibrational excitation. Excitation of these molecules by plasma electrons that have continuum energy spectrum is rather inefficient.

When the density of vibrationally excited N₂ molecules is high, the inverse process of electron impact de-excitation of molecular vibrations starts to play a significant role. Especially superelastic collisions are important in the absence of other electron-heating sources. For example in [137] it was demonstrated that in the N₂ afterglow, the electron temperature is controlled by de-excitation of N₂(v). The mechanism of N₂(v) de-excitation is similar to the direct process and its rate can be obtained from the detailed balance principle.

5.2.3 Vibrational relaxation of N₂(v) in the gas phase

Redistribution of vibrational energy between different degrees of freedom in collisions of N₂(v) with different species has been studied intensively over the past century. It was found that the most important processes that govern N₂(v) vibrational distribution are the following [126]:

- Vibrational – translational/rotational relaxation (V-T/R)
  \[ \text{N}_2(v,J_1) + M \rightarrow \text{N}_2(w,J_2) + M \]
- Vibrational – vibrational relaxation in N₂ (V-V)
  \[ \text{N}_2(v_1) + \text{N}_2(w_1) \rightarrow \text{N}_2(v_2) + \text{N}_2(w_2) \]
- Vibrational – vibrational relaxation with other molecules (V-V’)
  \[ \text{N}_2(v_1) + M(w_1) \rightarrow \text{N}_2(v_2) + M(w_2) \]

Nitrogen possesses 60 [138] vibrational levels and in order to model its vibrational kinetics the knowledge of the reaction rates for all the levels is required. Of course, experimental determination of the whole set of relaxation rates (especially for high vibrational levels) is not possible. Typically, the measurements are performed for a few lower levels and the complete dataset is obtained using analytical theoretical scaling laws or by means of numerical modeling.

The most widely used analytical treatment of vibrational relaxation is Schwartz, Slawsky and Hertzfeld (SSH) theory [139]. In SSH theory, the collision is supposed to be one dimensional and only repulsive forces between colliding molecules are considered. In addition, for relaxation processes listed above only single-quantum (Δv=1) exchange processes are considered. The Δv=1 selection rule is rigorous for harmonic oscillators and it is valid with a good precision for real anharmonic molecules. All above simplifications allow analytical solution of the problem that gives vibrational number dependence of V-T and V-V rates. Usually, the absolute values of relaxation rates are not well reproduced by simplified analytical theories and a normalization to experimental data is required. The SSH scaling laws for V-T and V-V relaxation of anharmonic oscillators are the following [126]:

124
Parameters $\delta_{VT}$ and $\delta_{VV}$ depend on the anharmonicity of the colliding species. In the case of harmonic oscillator, these parameters are equal to zero and the scaling laws transform into a simple linear dependence on the vibrational quantum number.

The most detailed theoretical investigation of the mechanisms of vibrational energy transfer in $\text{N}_2$-$\text{N}_2$ collisions has been recently performed in [140]. Authors used a semi-classical method in which the translational and rotational motion of molecules was treated classically, whereas the molecular vibrations were treated quantum mechanically. This technique allowed accurate calculation of the V-T and V-V rates in a broad temperature range. In contrast to analytical models, semi-classical calculations give absolute reaction rates which are in good agreement with the experimental values. Moreover, probabilities of multi-quantum transitions are calculated in [140].

### 5.2.4 Vibrational relaxation on surfaces: motivation of the study

Based on the previous discussion we conclude that the gas phase vibrational kinetics of $\text{N}_2$ containing plasmas is well established. However, in bound laboratory plasmas the relaxation of molecular vibrations on the reactor walls becomes important and it should be taken into account. According to [126] V-T relaxation in $\text{N}_2$ is extremely slow and quenching of $\text{N}_2(v)$ on the reactor walls may be the dominant vibrational quanta loss mechanism for pressures up to several tens mbars. At present, understanding of the mechanisms of gas-surface interactions with vibrationally excited molecules is rather limited.

Historically, one of the most studied gas-surface interaction process is the relaxation of NO($v$) on LiF, Ag and graphite single crystals [141][142][143] in molecular beam experiments. Nitrogen oxide molecules were prepared in a specific quantum state ($v$, $J$) with a tunable infrared laser and then vibrational, rotational and translational distributions of the scattered molecules were measured by state-specific multiphoton ionization using a tunable UV laser. On atomically smooth surfaces the vibrational quanta loss probability was found to be $0.1 – 0.25$. It was concluded that the most plausible mechanism of vibrational relaxation is the interaction between physisorbed NO($v$) and surface phonons. Experimentally observed increase of the deactivation probability with decreasing the temperature of the surface supported this hypothesis; at lower temperature physisorbed molecules spend more time on the surface before being desorbed. Coupling between vibrational and rotational/translational degrees of freedom as well interaction with the electrons of the solid were found to be inefficient for vibrational deactivation. The roughness of the surface was also a very crucial parameter, measured deactivation probability on rough (although optically polished) LiF surface was almost 1 in contrast to ~0.1 on a cleaved surface.
Study of surface vibrational relaxation of N₂

To the best of our knowledge with N₂ no detailed beam studies have been performed so far. As a matter of fact, the number of experimental studies devoted to the determination of N₂(ν) loss probabilities on different surfaces is rather limited. The main difficulty in such experiments is the detection of vibrationally excited nitrogen that does not exhibit dipole allowed transitions in emission and has absorption features only in VUV. Therefore, calorimetric methods [132], spontaneous or coherent Raman scattering[127][129] or infrared titration with CO₂ [128] were used in the past. Typically, all the experiments were carried out in a flowing discharge system and the concentration of N₂(ν) was measured as a function of the distance in the post discharge. The probability of vibrational quanta loss in collisions with the wall (γN₂) was determined from the measured decay of N₂(ν) concentration. Typically, the value of γN₂ for the first vibrational level on different surfaces lies in the range 10⁻⁴ – 10⁻². In [127][128] the results of γN₂ measurements on glass were interpreted in terms of the two step mechanism similar to one proposed for NO(ν) relaxation on LiF. Vibrationally excited N₂(ν) were supposed to physisorb on the surface and then to transfer the vibrational energy to surface phonons. Low relaxation probability of N₂(ν) was explained in [127] by the very short residence time of N₂(ν) on the surface and by the poor coupling of energy transfer involving phonon excitation.

In real plasma conditions the surface may be covered by a layer of adsorbed molecules. Vibrational energy transfer between impinging N₂(ν) and this surface layer may represent an efficient pathway for heterogeneous vibrational relaxation [144].

One of the shortcomings of the techniques described above is that the relaxation of N₂(ν) was studied in a flowing post-discharge zone. First, the values of γN₂ in the post-discharge may differ from those under direct plasma exposure as it was demonstrated for atomic recombination on surfaces [21]. Second, the state of the surface under post-discharge exposure is not well controlled and it may evolve in time. Indeed, authors [127][129] pointed out drifts in measured values of γN₂ with increasing exposure time to the afterglow.

We can conclude here that at present the modeling of vibrational kinetics in N₂ containing plasmas, very elaborated and exhaustive in what concerns gas phase kinetics, is limited by the knowledge of the rates of surface vibrational relaxation. Plasma simulations for new emerging applications such as material processing [145] or plasma-catalyst technology [11] require the knowledge of γN₂ for a number of surface materials.

The development of a simple and reliable technique for in-situ γN₂ determination was therefore our main motivation.

In addition, the following questions require a thorough investigation:

- How does plasma exposure modify the probability of N₂(ν) quenching on surfaces?
- How do molecular admixtures influence the value of γN₂?
5.3 Study of N$_2$(v) relaxation using infrared titration

5.3.1 Principles of the infrared titration technique

The basic idea of the infrared titration technique consists in the addition of a small amount of infrared active molecules (CO$_2$, N$_2$O, CO) into N$_2$. As it can be seen in the

Table 5. 1, titrating molecules have vibrational levels that are very close to the first level of nitrogen N$_2$(v=1). When N$_2$ undergoes vibrational excitation, a fast resonant vibrational energy exchange tends to equilibrate vibrational distributions of N$_2$(v) and IR active admixtures. Therefore, the degree of vibrational excitation of titrating molecules is an image of the degree of vibrational excitation of N$_2$. The described method was first proposed and applied in [128] for N$_2$(v) surface deactivation studies; CO$_2$ was added in the flowing nitrogen post-discharge and vibrationally excited CO$_2$ molecules were detected using their IR emission.

<table>
<thead>
<tr>
<th></th>
<th>v1, cm$^{-1}$</th>
<th>v2, cm$^{-1}$</th>
<th>v3, cm$^{-1}$</th>
</tr>
</thead>
<tbody>
<tr>
<td>N$_2$</td>
<td>2331</td>
<td></td>
<td></td>
</tr>
<tr>
<td>CO</td>
<td>2143</td>
<td></td>
<td></td>
</tr>
<tr>
<td>CO$_2$</td>
<td>1388  667</td>
<td>2349</td>
<td></td>
</tr>
<tr>
<td>N$_2$O</td>
<td>1285  589</td>
<td>2224</td>
<td></td>
</tr>
</tbody>
</table>

Table 5. 1 Wave numbers of the fundamental vibrational modes of N$_2$, CO, CO$_2$ and N$_2$O.

In our case, we wish to develop an in-situ diagnostics inside the plasma zone but not in the post-discharge. Therefore, IR active molecules are added to N$_2$ and then the mixture is excited by a pulsed DC discharge. Quantum cascade laser absorption spectroscopy is used to monitor kinetics of titrating molecules.

5.3.2 Experimental procedure

Figure 5. 3 illustrates the experimental procedure. First, the discharge tube is pre-treated by a flowing RF discharge in argon, N$_2$ or O$_2$. Then a mixture of N$_2$ containing 0.05-1% of CO$_2$ (N$_2$O, CO) is introduced in the reactor and a single-pulse DC discharge is ignited in static conditions. Time evolution of up to 3 species is followed in situ using the 3-channel QCLAS spectrometer with time resolution 5-200 µs.

Figure 5. 3 Experimental sequence.


Study of surface vibrational relaxation of \( \text{N}_2 \)

After each discharge pulse the reactor is refilled with a new gas mixture. The standard experimental conditions are the following:

- gas pressure \( p=1.33 \text{ mbar} \)
- discharge current \( I=50 \text{ mA} \)
- pulse duration \( \tau=5 \text{ ms} \)

Several discharge tubes made of different materials (silica, Pyrex, anodized aluminum) or silica with a sol-gel film of TiO\(_2\) or Al\(_2\)O\(_3\) deposited on its inner surface are studied.

5.3.3 Validity of the diagnostics

In Figure 5. 4, results of the relaxation measurements in \( \text{N}_2 – \text{CO}_2 \) (\( \text{N}_2\text{O}, \text{CO} \)) mixtures in standard conditions with silica-made discharge tube. The concentration of admixtures was in the range \((0.05 - 0.5)\%\). Before the measurements, the reactor was treated by argon RF plasma at a pressure of 0.3 mbar during 30 minutes. It should be noted that the acquisition is done in a single pulse without data accumulation.

First of all let us discuss the particularity of quantum cascade laser absorption measurements in the conditions of non-equilibrium vibrational excitation. According to expression (2. 2), the measured absorbance is proportional to the difference between the lower and the upper roto-vibrational level populations \( n_i \) and \( n_k \). Taking into account the Boltzmann relation between \( n_i \) and \( n_k \) and the total density of molecules on the lower (\( N_0 \)) and the upper (\( N_1 \)) vibrational levels (2. 2) and (2. 3) is expressed as follows

\[
\int \ln \left( \frac{I_v^{(L)}}{I_v^{(0)}} \right) \, dv = - \frac{\hbar v_B g_i B_{ik} e^{E_i / kT}}{Q_{\text{rot}}} \left( N_0 - e^{E_i / kT} N_1 \right) L K
\]

where \( E_i \) and \( E_k \) correspond to the rotational energy of the lower and the upper levels respectively, \( Q_{\text{rot}} \) is the rotational partition function, \( K \) is a calibration factor that accounts for the absorption line distortion due to the rapid passage effect. Effectively (5. 3) may be rewritten

\[
\int \ln \left( \frac{I_v^{(L)}}{I_v^{(0)}} \right) \, dv = - \alpha (N_0 - \beta N_1)
\]

where \( \alpha \) is found from the calibration and \( \beta \) depends on the chosen transition and can be calculated using the known molecular parameters. Typically \( \beta \approx 1 \) because the statistical weights and the rotational energies of the levels connected by allowed dipole transitions (\( \Delta J=0, \pm 1 \)) are close. The values of \( \beta \) at 300K for the absorption lines used in this study:

- \( \beta=1.145 \) for P28 CO\(_2\)(00\(^0\)1←00\(^0\)0) transition at 2324.976 cm\(^{-1}\)
- \( \beta=1.135 \) for P18 N\(_2\)O(00\(^0\)1←00\(^0\)0) transition at 2207.62 cm\(^{-1}\)
- \( \beta=0.67 \) for R18 CO(1←0) transition at 2209.508 cm\(^{-1}\)
Therefore, we conclude that the measured absorption signal is proportional to the population difference \((N_0 - \beta N_1)\) of the lower and the upper vibrational levels. This is reflected in the y-axis labels in Figure 5.4 (an further in this chapter).

Figure 5.4 a)-c) Relaxation measurements in \(N_2 – CO_2\) (\(N_2O\), \(CO\)) mixtures at \(p=1.33\) mbar, \(I=50\) mA, \(\tau=5\) ms in silica tube pretreated by argon RF plasma.

In Figure 5.4 all the titrating molecules exhibit the same behavior. The value of \((N_0 - \beta N_1)\) drops rapidly during the discharge pulse and then relaxes to a stationary level in the afterglow on the timescale of few tens milliseconds. Typically, the stationary level of \((N_0 - \beta N_1)\) in the afterglow is lower than the initial value which can be explained by the dissociation of the probe molecules in the discharge.

The fast decrease of the measured value of \((N_0 - \beta N_1)\) when the discharge pulse is applied may be caused by 3 principal processes:

1. Variation of the rotational distribution due to the gas heating.
2. Dissociation.
3. Vibrational excitation.

Here we will discuss the role of these processes under the conditions of this study.
Study of surface vibrational relaxation of N\textsubscript{2}

5.3.3.1 Gas temperature and its influence on the relaxation measurements

As it was shown in [78], in the discharge an increase of the gas temperature may alter significantly the laser absorption measurements of species concentrations. In this work we have independently measured the temporal variation of the gas temperature in the discharge active phase and in the afterglow using optical emission spectroscopy of the N\textsubscript{2} 2\textsuperscript{+} band at 337 nm as described in Chapter 2. In Figure 5.5 the time evolution of the $T_g$ in a 10 ms discharge pulse with I=50 – 150 mA is shown.

As it was discussed in Chapter 2, OES measurements tend to slightly overestimate the value of $T_g$ for low gas temperatures. In addition, in the presence of radial temperature gradients, the measured $T_g$ is an effective average over the discharge cross section. Therefore, the absolute values of $T_g$ obtained using OES under conditions of this study should be used with care. Nevertheless, the measured characteristic times of gas heating and cooling are meaningful. One can see that after 2-3 ms in the post discharge the value of $T_g$ is indistinguishable from $T_g$ measured in the beginning of the main discharge pulse when the gas is cold ($T_g$=300K). The relaxation of the value of ($N_0 - \beta N_1$), shown in Figure 5.4 is much slower and therefore it cannot be related to the temperature effects. Moreover, one can note that curves plotted in Figure 5.4 exhibit no fast changes when the discharge is stopped as it would be expected if the variation of the gas temperature had a strong influence on the absorption measurements [78]. In the further discussion we will be interested in relaxation processes that take place on the timescale of several tens of milliseconds when the gas temperature is already in equilibrium with reactor walls.

Figure 5.5 Evolution of the gas temperature determined by OES in N\textsubscript{2} pulsed DC discharge at 1.33 mbar. Discharge current is I=50 – 150 mA, pulse duration $\tau$=10 ms.

As it was discussed in Chapter 2, OES measurements tend to slightly overestimate the value of $T_g$ for low gas temperatures. In addition, in the presence of radial temperature gradients, the measured $T_g$ is an effective average over the discharge cross section. Therefore, the absolute values of $T_g$ obtained using OES under conditions of this study should be used with care. Nevertheless, the measured characteristic times of gas heating and cooling are meaningful. One can see that after 2-3 ms in the post discharge the value of $T_g$ is indistinguishable from $T_g$ measured in the beginning of the main discharge pulse when the gas is cold ($T_g$=300K). The relaxation of the value of ($N_0 - \beta N_1$), shown in Figure 5.4 is much slower and therefore it cannot be related to the temperature effects. Moreover, one can note that curves plotted in Figure 5.4 exhibit no fast changes when the discharge is stopped as it would be expected if the variation of the gas temperature had a strong influence on the absorption measurements [78]. In the further discussion we will be interested in relaxation processes that take place on the timescale of several tens of milliseconds when the gas temperature is already in equilibrium with reactor walls.
Dissociation of CO$_2$ (N$_2$O, CO) in the discharge with the subsequent recombination of produced fragments at reactor walls may also influence time evolution of the absorption signals. Special test experiments have been performed in order to evaluate the efficiency of dissociation/re-association reactions in the case of CO$_2$ and N$_2$O.

The main dissociation products of CO$_2$ are O and CO [146]. Recombination of these fragments may result in the production of CO$_2$ or 1/2O$_2$ and a CO molecule. It is known that surface association of oxygen atoms with carbon monoxide on silica surface (O+CO|$_w$) is inefficient [147] compared to the recombination of oxygen atoms (O+O|$_w$) [21]. Therefore it is unlikely that dissociation products recombine back into CO$_2$.

In order to confirm the low efficiency of O+CO|$_w$ recombination process under the conditions of the present study a test experiment was done. A single discharge pulse with $\tau=5$ ms and $I=50$ mA was applied in a mixture of CO/Ar/O$_2=0.5/49.5/50$ at $p=1.33$ mbar under static conditions in silica discharge tube. The concentration of CO$_2$ measured after the discharge pulse was about $1\cdot10^{13}$ molecules cm$^{-3}$. A simple estimation shows that the density of atomic oxygen at the end of the pulse was in the order of $10^{15}$ cm$^{-3}$. The density of CO was $1.5\cdot10^{14}$ molecules cm$^{-3}$. Thus even with an excess of atomic oxygen recombination into CO$_2$ doesn’t exceed 10% of the initial CO concentration. It is evident that in the experimental conditions shown in Figure 5. 4 a), the density of CO and O available for recombination are approximately equal and they are always smaller than in the experiment with the CO/Ar/O$_2$ mixture. Hence we conclude that surface re-association of CO and O has only a minor role in the conditions of this study. Therefore the ~15% depletion of the CO$_2$ concentration measured at the end of the post discharge, shown in Figure 5. 4 a), is the true value of the dissociation degree of CO$_2$ in the discharge.

Similar experiments were performed for the case of N$_2$O. According to [148] the main dissociation products of N$_2$O in the discharge are N$_2$ and O. In order to determine the efficiency of N$_2$O production from the recombination of O and N$_2$, a DC discharge pulse with $\tau=5$ ms, $I=50$ mA in N$_2$/O$_2=4/1$ at $p=1.33$ mbar was applied in static conditions in silica discharge tube. The concentration of N$_2$O measured after the discharge pulse was only $[\text{N}_2\text{O}]_{\text{pulse}}=4\cdot10^{12}$ cm$^{-3}$. This proves that production of N$_2$O in the postdischarge in the conditions of the experiment shown in Figure 5. 4 b) is negligible. The ~50% difference between the initial and the final concentrations of N$_2$O is due to the dissociation in the discharge.

Compared to CO$_2$ and CO, N$_2$O has the smallest bond dissociation energy $D(\text{NN-O})=1.67$ eV (for comparison $D(\text{C-O})=11.1$ eV and $D(\text{OC-O})=5.45$ eV). Hence, the dissociation of CO and CO$_2$ in the discharge is less pronounced, as it can be seen in Figure 5. 4.
Study of surface vibrational relaxation of N$_2$

5.3.3.3 Vibrational excitation of titrating molecules

We conclude here that 2-3 ms after the end of the discharge pulse temperature and dissociation effects do not influence the relaxation measurements. Therefore, the evolution of the value of ($N_0 - \beta N_1$) is determined by *vibrational excitation* of titrating molecules.

During the discharge ON phase gas mixtures N$_2$ – CO$_2$ (CO or N$_2$O) are excited by plasma electrons. Depletion of the value of ($N_0 - \beta N_1$) is caused by the decrease of the population of the ground state ($N_0$) and the increase of the population of the upper level ($N_1$). In the case of CO$_2$ and N$_2$O laser absorption measurements are performed in the asymmetric stretching mode $v_3$. As it follows from Table 5, 1, this mode is in resonance with N$_2$(v) and we will show later that it has the highest population compared to other vibrational modes. Excitation of $v_1$ and $v_2$ modes of CO$_2$ and N$_2$O reduces the value of $N_0$ and contributes as well to the depletion of the measured absorption signals.

When the discharge is stopped, relaxation of the mixture as a whole takes place. Vibrationally excited nitrogen molecules play the role of energy reservoir and their quenching on the reactor walls and in the gas phase determine the characteristic relaxation time of the system.

![Figure 5. 6 Comparison of CO$_2$ relaxation measurements in mixtures with Ar and N$_2$. Pulse duration $\tau$=5 ms, I=50 mA, p=1.33 mbar, silica discharge tube.](image)

In order to illustrate the role of N$_2$(v) for vibrational relaxation of titrating molecules in the afterglow, a test experiment has been performed. A mixture containing 0.2% of CO$_2$ in Ar was excited by a $\tau$=5 ms, I=50 mA discharge pulse at p=1.33 mbar in static conditions. In Figure 5. 6 time evolution of ($N_0 - \beta N_1$) in case of CO$_2$ diluted in Ar and N$_2$ is shown. One can see that in argon mixture the characteristic relaxation time is $\tau_{relax}$~2 ms while with N$_2$ $\tau_{relax}$~70 ms. This proves that in the afterglow, N$_2$(v) is the main source of the vibrational
excitation of CO₂. The degree of vibrational excitation of CO₂ literally follows the excitation of N₂.

5.4 Modeling of vibrational kinetics in N₂-CO₂

In order to interpret the result shown in Figure 5.4 and to get the information on surface relaxation processes a numerical model of the vibrational kinetics in N₂ – CO₂ (CO or N₂O) has to be developed. From the modeling viewpoint, the simplest case would be the N₂-CO mixture because CO has only one vibrational mode and reliable data on the vibrational relaxation rates in this system are available in the literature [149]. However, from the experimental viewpoint, the line of CO at 2209.508 cm⁻¹ (Hitran intensity 7.5·10⁻²⁰ cm⁻¹/(molecules·cm⁻²)) is much weaker than the lines of CO₂ (2.08·10⁻¹⁸ cm⁻¹/(molecules·cm⁻²)) and N₂O (9.07·10⁻¹⁹ cm⁻¹/(molecules·cm⁻²)). Therefore, measurements in wider concentration ranges, especially towards lower concentrations, have been performed with CO₂ and N₂O.

For kinetic modeling we have chosen CO₂ because of the existence of detailed information on the rates of vibrational relaxation in N₂-CO₂ [150][151][152] due to the development of CO₂ laser in 1960s [153] and due to the atmospheric relevance of this system [154][155]. Thus, a detailed model of vibrational kinetics in N₂-CO₂ was created and applied to the experimental conditions of this work. Using the insight into the relaxation kinetics gained with the combined experimental/modeling approach we will propose a simplified data interpretation procedure for measurements with CO and N₂O.

5.4.1 Relevant relaxation processes

Let us briefly consider the processes that are important for the relaxation kinetics shown in Figure 5.4. During the 5 ms plasma ON phase vibrations of both CO₂ and N₂ are efficiently excited by electron impact. In the afterglow, vibrational energy is exchanged between different modes of CO₂ and N₂ and the reactor walls.

Results shown in Figure 5.6 prove that vibrational excitation of CO₂ persists in the afterglow. As is shown in [128], excitation of CO₂ in the post discharge takes place in the V-V' exchange process.

\[ N₂(v) + CO₂(00¹n) \leftrightarrow N₂(v-1) + CO₂(00¹n+1) \]  \hspace{1cm} (5.5)

Figure 5.7 shows the diagram of the vibrational levels of N₂ and CO₂, the vibrational state notation is taken from [154]. For the first excited levels N₂(v=1) and CO₂(00¹1) the process (5.5) is almost resonant and as a consequence it is rather fast, \( k_{N₂-CO₂}=7·10^{-13} \text{ cm}^3\text{s}^{-1} \) at 300 K [155]. We will show later, that the high efficiency of (5.5) leads to the equalization of the vibrational temperatures of N₂(ᵣ) and the CO₂(00¹v₃).
Study of surface vibrational relaxation of N₂

For a correct description of the vibrational kinetics in the N₂ subsystem the V-V and V-T processes for all the vibrational levels of N₂ should be considered in the model. In nitrogen V-T relaxation at room temperature is very slow, for N₂(v=1) k VT=7·10⁻²² cm³s⁻¹[140]. Thus, the relaxation of the low lying vibrational levels is controlled by impurities and by quenching on the reactor walls [63] [126]. Under the conditions of the present study in pure N₂, surface relaxation is dominant due to the low level of impurities in the N₂ gas used. According to [156] V-T quenching by atomic nitrogen may be an important process of N₂(v) relaxation. However in our conditions at room temperature and with the typical degree of dissociation of 1% [97] the V-T relaxation by N atoms is negligible. Relaxation caused by CO₂ becomes increasingly important upon the addition of CO₂.

The modeling of the CO₂ subsystem requires consideration of the vibrational energy transfer from N₂(v). Apart from the excitation of v₁ mode in the reaction (5. 5) other vibrational levels of CO₂ may be in principle excited in collisions with N₂(v). However, as it is shown in [157] these processes are very inefficient due to either substantial energy mismatch or the necessity of multi-quantum excitation. Therefore, reaction (5. 5) is the only efficient process of the vibrational energy exchange between CO₂(00¹0) and N₂. Other CO₂ vibrational modes (ν1, ν2) are populated in so-called intramolecular vibrational exchange reactions (as for example CO₂(00¹0)+M→ CO₂(i,j0)+M). Typically, exchange between the levels having the smallest energy gap is the most efficient [150][157].

As one can see from Figure 5. 6, without the vibrational pumping by N₂(v) the relaxation time in CO₂ is of the order of 2 ms. Such a fast relaxation is explained by a very efficient surface quenching and spontaneous emission (radiative lifetime of CO₂(00¹0) is 2.4 ms [150]). It is known from a number of works [127][158] that the deactivation probability of CO₂(010) and CO₂(001) on glass surfaces is found to be in the range of γCO₂ ~ 0.18 – 0.4. To the best of our knowledge there is no data available for the ν₁ mode, but it would be reasonable to suggest that the deactivation probability of this mode is also relatively high. In our conditions, for γCO₂≥0.1 the lifetime of the vibrationally excited CO₂ is limited by the diffusion towards the wall and does not exceed 2 ms.
5.4.2 Model description

5.4.2.1 Gas phase processes

We used the approach to the modeling of vibrational kinetics similar to a number of published works [63] [159]. The model is zero dimensional and it incorporates excitation of vibrations by electronic impact (e-V), V-V and V-T exchange in the N\textsubscript{2} subsystem as well as the V-V' exchange (5. 5) between N\textsubscript{2} and CO\textsubscript{2} and intramolecular vibrational relaxation in CO\textsubscript{2}. Relaxation in collisions between two CO\textsubscript{2} molecules was neglected due to the low concentration of admixed CO\textsubscript{2}. Electron impact excitation of CO\textsubscript{2} was also ignored because we are interested only in the afterglow phase where CO\textsubscript{2} is excited in collisions with N\textsubscript{2}(v).

The system of kinetic equations can be written in a symbolic form:

\begin{align}
\frac{dN_{2}(i)}{dt} &= \left( \frac{dN_{2}(i)}{dt} \right)_{e-V} + \left( \frac{dN_{2}(i)}{dt} \right)_{V-V} + \left( \frac{dN_{2}(i)}{dt} \right)_{V-T} + \left( \frac{dN_{2}(i)}{dt} \right)_{\text{R1}} + \left( \frac{dN_{2}(i)}{dt} \right)_{\text{W}} \\
\frac{dCO_{2}(k)}{dt} &= \left( \frac{dCO_{2}(k)}{dt} \right)_{\text{R1}} + \left( \frac{dCO_{2}(k)}{dt} \right)_{\text{VT}} + \left( \frac{dCO_{2}(k)}{dt} \right)_{\text{intra}} + \left( \frac{dCO_{2}(k)}{dt} \right)_{\text{Rd}} + \left( \frac{dCO_{2}(k)}{dt} \right)_{\text{W}}
\end{align}

where W accounts for wall losses, RD is the spontaneous radiative decay term and R1 is the contribution of reaction (5. 5).

The system of equations was solved for 0 - 45 vibrational levels of N\textsubscript{2} and 6 levels of CO\textsubscript{2} (\((00^00),(00^01),(00^02),(01^00),[(02^00,10^00),(02^00,01^00)],[03^00,11^00),(03^10,11^10),(03^30)]\)). The groups of 3 levels in square brackets have close energies and they are affected by the Fermi resonance therefore these levels were treated as a single effective level [154] \((100)_{\text{eff}}\) and \((110)_{\text{eff}}\) respectively.

The e-V rates in N\textsubscript{2} were found from the solution of Boltzmann equation using the EEDF solver developed by Dyatko et al [160] taking into account superelastic collisions between electrons and vibrationally excited N\textsubscript{2} molecules. The average electron density was calculated based on the discharge current \((I)\) and the electron drift velocity \((v_{dt})\) obtained from the Boltzmann equation solution.

\[ n_{e} = \frac{I}{e v_{dt} S} \]

Where \(e\) is the electron charge and \(S\) is the discharge tube cross section. The electron density was assumed to be constant during the pulse in accordance with the experimentally measured current waveforms. The value of the reduced electric field in pure N\textsubscript{2} was taken from [99] [159] E/N=80Td and it was assumed to be constant during the pulse as it was done by Pintassilgo et al [149] under similar conditions in N\textsubscript{2}/O\textsubscript{2} pulsed DC discharge. Upon the addition of CO\textsubscript{2} the sustaining discharge voltage was gradually increased, 10% rise compared to pure N\textsubscript{2} was measured for 0.5% CO\textsubscript{2} in N\textsubscript{2}. We neglected the influence of CO\textsubscript{2} addition on the cathode fall voltage and therefore the increase of the E/N proportional to the discharge
Study of surface vibrational relaxation of N\textsubscript{2}

voltage was assumed taking into account a correction for the literature value U\textsubscript{c}=210 V of the cathode fall [68]. It is worth noting that e-V rates are not very sensitive functions of E/N because of the low energy threshold of vibrational excitation. Typically, variation of E/N from 70 to 90 Td leads to less than 20 % increase in the electron excitation rate of the first vibrational level of N\textsubscript{2}.

We used the most recent set of V-V and V-T rates in N\textsubscript{2} calculated in [140][161] using a semiclassical trajectory method. Only single-quantum transitions were taken into account. The rates of the V-V’ exchange between N\textsubscript{2} and CO\textsubscript{2} as well as V-T and intramolecular relaxation rates in CO\textsubscript{2} were taken from [150] [151] [152] [154]. Exchange reaction (5. 5) was considered for 45 levels of N\textsubscript{2} and 3 levels of CO\textsubscript{2}(00\textsubscript{0}v\textsubscript{3}). The dependence of the rate of (5. 5) on the vibrational quantum number of N\textsubscript{2} and CO\textsubscript{2} is not known. In the present study it was assumed to follow the analytical scaling of SSH theory [126]. Einstein coefficients for spontaneous emission in CO\textsubscript{2} were taken from [150].

5.4.2.2 Heterogeneous processes

Rigorous consideration of surface relaxation requires solution of a 1D problem that takes into account radial diffusion of species with appropriate boundary conditions. However, for the sake of simplicity surface processes are usually considered as volume ones with an effective frequency that can be written as [63]:

\[
\nu_w = \left( \frac{\Lambda^2}{D} + \frac{2r}{v_{th}\gamma} \right)^{-1} \tag{5. 9}
\]

where \(\Lambda=(r/2.4)\) is the characteristic diffusion length, \(r\) is the tube radius, \(D\) is the diffusion coefficient, \(v_{th}\) is the average thermal velocity of the molecules and \(\gamma\) is the probability of deactivation in a single collision with the surface.

For CO\textsubscript{2} it was assumed that \(\gamma_{\text{CO}_2}=0.2\) for all the vibrational levels of CO\textsubscript{2} [127], moreover a complete accommodation of vibrational energy was supposed. This lead to the characteristic surface relaxation time of CO\textsubscript{2} of the order of 2 ms, which is consistent with the results shown in Figure 5. 6.

In principle, different vibrational levels of N\textsubscript{2} may have different quenching probability in collision with the surface. At present there is no clear understanding of the dependence of \(\gamma_{N_2}\) on the vibrational quantum number \(v\). Usually in the literature, \(\gamma_{N_2}\) is assumed to be either constant for all vibrational levels or proportional to the vibrational quantum number:

i. \(\gamma_{N_2}(v) = \gamma_1\)

ii. \(\gamma_{N_2}(v) = \gamma_1 \cdot v\)

In both cases only single vibrational quantum is supposed to be lost. Although quite often employed in the literature [63][159], the first hypothesis has no theoretical ground. The
second assumption is similar to the scaling of the gas phase quenching of harmonic oscillators and consequently it seems to be more physical. We will, therefore, adopt this hypothesis as working one. The influence of the choice of the $\gamma_{N2}$ scaling on the resulting value of $\gamma_1$ deduced from the experiment will be discussed in subsequent sections.

The only tuning parameter of the model was the probability of the vibrational deactivation of $N_2$ on the surface $\gamma_1$. It was determined from the best agreement between the model and the experiment.

5.4.2.3 Numerical solution

The system of 52 differential equations (5. 6)-(5. 7) was solved numerically using Maple software package. Special solver for stiff ODEs was used. Pulsed discharge was simulated by introducing a time dependent discharge current which was set to zero in the afterglow. This allowed modeling of both plasma ON and plasma OFF phases in one run.

5.4.3 Validation of the model

The model developed in this work takes into account only kinetics of the vibrational levels of $N_2$ and completely omits other important plasma species, such as ions, atoms and electronically excited molecules. In order to verify the feasibility of our model (at least the part describing the vibrational kinetics of the $N_2$ subsystem) and to prove that the most important processes are well described, results of our calculations were compared with a complete self-consistd modeling performed by Vasco Guerra [159] for the same conditions ($p=1.33$ mbar, $I=50$ mA, $\tau=5$ ms). The model of V. Guerra has been applied for numerous experimental conditions and has proved its validity.

![Comparison between the results of our simplified model and a complete self-consistent simulation of V. Guerra for the same conditions (p=1.33 mbar, I=50 mA, $\tau$=5 ms). a) VDF at the end of the discharge pulse. b) Evolution of the effective vibrational temperature in the post discharge.](image)

In Figure 5.8 the VDF at the end of the discharge pulse and time evolution of the vibrational temperature $T_v = E_1 / \left( \ln \left( \frac{N_2(v=0)}{N_2(v=1)} \right) \right)$ in the post discharge are shown. One can see that the
Study of surface vibrational relaxation of N₂

results of the simplified modeling are in reasonable agreement with the complete simulation, especially taking into account that different sets of e-V, V-V and V-T rates have been used.

In addition to the verification of our model for lower vibrational levels we have performed calculations for the conditions of the work [162] where the density of N₂(ν=18) in a dc discharge in N₂ (p=2.3 torr, I=100 mA) was measured using CRDS. To the best of our knowledge [162] it is the only experimental determination of the vibrational population of N₂ in the so-called plateau part of the VDF. In Figure 5.9 the measured concentration [N₂(ν=18)] = (9±3.5)·10¹³ cm⁻³ is compared with our calculated VDF; an excellent agreement is obtained.

We conclude that our model is correct and it gives a good description of N₂ vibrational kinetics in low pressure DC discharges.

5.4.4 On the possibility of experimental determination of γN₂ dependence on ν

Before we start the analysis of experimental results let us first discuss the principle possibility of experimental determination of γN₂ dependence on ν in discharge experiments. The titration technique developed in this work allows time resolved measurements of the degree of vibrational excitation of N₂ (vibrational temperature). This information is not detailed enough, so some hypothesis concerning γN₂(ν) has to be introduced for data analysis.

The most detailed information on the kinetics of vibrational relaxation of lower vibrational levels of N₂ may be obtained using Coherent Antistokes Raman Scattering (CARS) measurements. For example, in [129] concentrations up to ν=5 were measured in a flowing N₂
discharge. We have calculated the time evolution of $[N_2(v)]$ for $v=0-5$ in the standard experimental conditions as in Figure 5.4.

![Figure 5.4](image)

Figure 5.4 Calculated time evolution of $[N_2(v)]$ for $v=1-5$ in a pulsed DC discharge in N$_2$ at $p=1.33$ mbar, $I=50$ mA, $\tau=5$ ms. Filled symbols correspond to $\gamma_{N_2}(v)=0.0011 \cdot v$, open symbols correspond to $\gamma_{N_2}(v)=0.0015$.

Two assumptions concerning $\gamma_{N_2}(v)$ dependence were tested:

i. $\gamma_{N_2}(v)=0.0011 \cdot v$ (we will see later that these values correspond to the relaxation on silica surface).

ii. $\gamma_{N_2}(v)=0.0015$ (this value was found by an adjustment to verify if the same result may be obtained with both hypotheses).

One can see that both hypotheses result in almost the same behavior of $[N_2(v)]$. Even for the $v=5$ level for which $\gamma_{N_2}(v)=\gamma_{1} \cdot v$ hypothesis gives 4 times faster surface relaxation rate. The only minor difference is observed for $N_2(v=1)$ in the late afterglow. Slower relaxation of the first level with $\gamma_{N_2}(v)=0.0015$ is caused by slower quenching of high vibrational levels which were populated by non-resonant VV exchange.

Apparent independence of the relaxation kinetics on the individual quenching probabilities of different vibrational levels is explained the fast V-V exchange that establishes a Treanor VDF on lower vibrational levels [126]. As a result, all the levels are coupled and the relaxation of the system as a whole takes place with the individual rates greatly masked.

Linear increase of $\gamma_{N_2}$ with $v$ suggests that for high vibrational levels surface relaxation may be much faster than for $v=1$. In order to check if the hypothesis concerning the scaling of $\gamma_{N_2}$ may influence the populations on higher vibrational levels (and keeping in mind possible measurements of $[N_2(v=18)]$), we have calculated VDFs in a continuous dc discharge in N$_2$ at
Study of surface vibrational relaxation of N₂

p=1.33 mbar, I=50 mA with the same assumptions concerning γ\(_{N₂}\) as in Figure 5. 10. As one can see in Figure 5. 11, VDFs exhibit only a minor difference for levels up to \(v=30\).

![Figure 5. 11 Calculated VDF in a continuous DC discharge in N₂ at p=1.33 mbar, I=50 mA. Filled symbols correspond to γ\(_{N₂}(v)=0.0011 \cdot v\), open symbols correspond to γ\(_{N₂}(v)=0.0015\).](image)

We conclude here that in typical low pressure discharge conditions, even detailed measurements of N₂(\(v\)) would not allow an unambiguous determination of γ\(_{N₂}\) dependence on \(v\). The reason for this is the fast vibrational exchange in the gas phase. Therefore, in order to determine γ\(_{N₂}\) for individual vibrational levels, experimental conditions should be specially selected to keep surface relaxation faster than the gas phase exchange processes.

Based on the above discussion we can state that regardless less detailed measurements, the titration technique for γ\(_{N₂}\) determination in low pressure discharge conditions is not less informative than CARS.

5.4.5 Modeling results in N₂ – CO₂ mixtures

Figure 5. 12 and Figure 5. 13 show the typical output of the model for experimental conditions as in Figure 5. 4. In Figure 5. 12, the vibrational distribution function (VDF) of N₂ is shown for different delays after the ignition of the discharge pulse. For times inferior to 1 ms the VDF is governed by the electron impact excitation which is efficient for \(v=1 – 9\) and VDFs reflect the excitation pattern. With increasing the degree of the excitation, V-V exchange tends to establish a Treanor distribution on low-lying vibrational levels. The population of high vibrational levels takes place in the ladder-like V-V exchange and it is delayed compared to the evolution of the VDF on lower levels. In the post discharge (delays longer than 5 ms), the relaxation of the VDF is determined by population of higher vibrational levels of N₂ and the loss of the vibrational energy on the reactor walls and in collisions with CO₂.

140
Figure 5. 12 Time evolution of the N₂ vibrational distribution function in a single discharge pulse with τ=5 ms, I = 50 mA and p=1.33 mbar in a 0.2%CO₂-N₂ mixture. The beginning of the discharge pulse corresponds to t=0.

Figure 5. 13 Time evolution of the population of the vibrational levels of CO₂. Discharge conditions are the same as in Figure 5. 12.

Figure 5. 13 depicts the time evolution of the CO₂ vibrational level population. During the 5 ms discharge pulse, one can see a depletion of the CO₂(00^0_0) concentration and the appearance of the molecules in the excited states due to the vibrational transfer from N₂(v). In the afterglow, the vibrational distribution of CO₂ relaxes to thermal equilibrium following the relaxation of the VDF of N₂(v). The analysis of the simulation results shows that N₂(v) and CO₂(00^0_0) are strongly coupled because the V-V' exchange (5. 5) is much faster than the quenching of CO₂(00^0_0). It was found that vibrational temperatures of N₂ and CO₂(00^0_0) are very close and obey the well known analytical relation [126]:

\[
\frac{E_{1}^{CO2}}{T_{1}^{CO2}} = \frac{E_{1}^{N2}}{T_{1}^{N2}} = \frac{E_{1}^{CO2} - E_{1}^{N2}}{T_{gas}}
\]  

(5. 10)
Study of surface vibrational relaxation of $N_2$

where $T_1^{CO_2}$ ($T_1^{N_2}$) and $E_1^{CO_2}$ ($E_1^{N_2}$) correspond to the effective temperature and the energy of the first vibrational level of CO$_2$ ($N_2$), $T_{gas}$ is the gas temperature (equal to 300K).

Vibrational modes other than CO$_2$(000$^3$) are weakly populated and do not contribute to the depletion of the value of ($N_0 - \beta N_1$). The overpopulation of CO$_2$(kl$^m$0) after the discharge pulse compared to the 296 K level doesn’t exceed 5% of the total CO$_2$ concentration. The low population of CO$_2$ modes, which are not directly coupled to $N_2$(v), can be explained by a relatively slow intramolecular exchange in CO$_2$ compared to surface losses and spontaneous emission. For example at a pressure of 1.33 mbar using the relaxation rates from [154] we estimate the total quenching frequency of CO$_2$(001) → CO$_2$(kl$^m$0) by $N_2$ to be $v_{intra} \sim 130$ s$^{-1}$ while the frequency of surface losses of each individual level CO$_2$(kl$^m$0) is $v_{W} \sim 600$ s$^{-1}$.

5.4.6 Determination of $\gamma_{N2}$ for silica. The influence of CO$_2$ admixture

In order to determine the probability of $N_2$(v) quenching on silica surface, the value of $\gamma_1$ ($\gamma_{N2}=\gamma_1$ scaling was adopted) in the simulations was varied to achieve the best fit with the experimental data shown in Figure 5.4. Experimental and simulated curves for 0.2% CO$_2$ are shown in Figure 5.14. The best fit value $\gamma_1=1.6 \cdot 10^{-3}$ was found. Calculated curves with $\gamma_1=1.4 \cdot 10^{-3}$ and $1.8 \cdot 10^{-3}$ illustrate the sensitivity of the model to the $\gamma_1$ variation and allow one to estimate the relative error of the $\gamma_1$ to be ±15%.

One can note that the magnitude of the measured relaxation signals is well reproduced in the simulation. Depletion of the value of ($N_0 - \beta N_1$) is determined by the degree of vibrational excitation of $N_2$ after the discharge. Therefore we conclude that electron impact excitation of $N_2$ is correctly treated in the model.

Calculations with different concentrations of added CO$_2$ were performed. The agreement between the experiment and the model was achieved by varying the value of $\gamma_1$ for every given CO$_2$ admixture. It was found that the best fit value of $\gamma_1$ increases systematically with increasing CO$_2$ concentration. Figure 5.15 shows the obtained dependence, an increase of $\gamma_1$ by a factor of 2 over the studied range of the CO$_2$ concentration can be seen.

From the calculation viewpoint the increase of the best fit value of $\gamma_1$ as a function of the CO$_2$ concentration signifies that gas phase processes of $N_2$(v) quenching by CO$_2$ that were taken into account in the model are not sufficient to reproduce experimentally observed relaxation kinetics. In the model, we have included all the known gas phase processes of $N_2$(v) quenching by CO$_2$. Therefore, we believe that the obtained increase of the surface quenching probability of $N_2$(v) upon the addition of CO$_2$ is a real physical effect and it is not related to the incompleteness of the model.
Figure 5. 14 Experimental relaxation curve with 0.2% of CO$_2$ (---), silica discharge tube. Results of calculations with $\gamma_1=1.4\cdot10^{-3}$ (--), $\gamma_1=1.6\cdot10^{-3}$ (---) $\gamma_1=1.8\cdot10^{-3}$ (—) ($\gamma_{N2}$ is supposed to increase linearly with the vibrational quantum number $\gamma_{N2}(v)=\gamma_1\cdot v$).

Figure 5. 15 Wall deactivation probability of N$_2$(v=1) as a function of the added CO$_2$ concentration (■). Linear fit with $\gamma_1=0.011+8.10^{-10}[\text{CO}_2]$ (---).

To support this statement let us consider the most important mechanisms of N$_2$(v) vibrational relaxation in the presence of CO$_2$. According to [154] V-T quenching of N$_2$(v) by CO$_2$ is very inefficient ($k_{VT}=1.10^{-22}$ cm$^3$s$^{-1}$). The effective mechanism of N$_2$ vibrational quanta losses in N$_2$-CO$_2$ mixture proceeds via the fast transfer N$_2$(v)$\leftrightarrow$CO$_2$(00$^0_0v3$) followed by the quenching of CO$_2$(00$^0_0v3$). Therefore, the “leakage” of N$_2$ vibrational quanta is proportional to the CO$_2$ concentration. Taking into account that CO$_2$(00$^0_0v3$) is nearly in equilibrium with N$_2$(v) the characteristic frequency of N$_2$ quanta losses in such two-step process can be written as follows:
Study of surface vibrational relaxation of N₂

\[ \varphi = [\text{CO}_2]\frac{v_{\text{intra+W+RD}}}{[\text{N}_2]} \]  \hspace{1cm} (5.11)

where \(v_{\text{intra+W+RD}}\) is the quenching frequency of CO₂(\(v=3\)), [N₂] and [CO₂] is the concentration of N₂ and CO₂ respectively. Calculation using (5.11) for CO₂ concentration ranging between \(2\cdot10^{13} - 2\cdot10^{14}\) cm\(^{-3}\) yields \(\varphi = 0.8 - 8\) s\(^{-1}\). At the same time the characteristic frequency of surface relaxation of N₂(\(v=1\)) calculated using (5.9) with the \(\gamma_1\) values from Figure 5.15 is found in the range 25 – 60 s\(^{-1}\). Therefore, the relaxation induced by the presence of CO₂ in the gas phase is far too slow to explain the experimental results from Figure 5.4. Using model calculations we have found that in order to reproduce experimentally observed time evolution of (\(N_0 - \beta N_0\)) at different levels of added CO₂ with a fixed value of \(\gamma_1\), the total quenching frequency of CO₂(\(00^0v=3\)) has to be increased by a factor of 10. In previous sections it was shown that the quenching of CO₂(\(00^0v=3\)) is dominated by the diffusion limited surface vibrational deactivation and spontaneous emission. Therefore, the value of \(v_{\text{intra+W+RD}}\) is known with a sufficient accuracy and its underestimation by a factor of 10 is very unlikely. Hence we conclude that the strong increase of the N₂(\(v\)) relaxation frequency with increasing CO₂ concentration is likely due to a modification of the surface state by the presence of CO₂.

The physical mechanism of the CO₂ induced enhancement of \(\gamma_1\) may consist in the transfer of the vibrational energy between N₂(\(v\)) and CO₂ molecules adsorbed on the quartz surface. In [163] a similar mechanism was proposed to explain the experimentally measured surface relaxation rates in pure CO₂.

In Figure 5.15 the data points are approximated by a linear function \(\gamma_1=0.0011+8\cdot10^{-18}[\text{CO}_2]\) where [CO₂] is the concentration of carbon dioxide in molecules cm\(^{-3}\). The intercept value \(\gamma_1^0=(1.1\pm0.15)\cdot10^{-3}\) can be considered as the wall deactivation probability of N₂(\(v=1\)) on fused silica in pure nitrogen. In contrast to \(\gamma_1\) values shown in Figure 5.15, it was found that the value of \(\gamma_1^0\) does not depend on the rates of CO₂ relaxation that were used in the model.

The value of \(\gamma_1^0\) obtained in this study is in reasonable agreement with the literature data which are found in the range \((2 - 7)\cdot10^{-4}\) [127] [129] depending on surface pretreatment history. One should note that any comparison between different experimental data is not straightforward due to the differences in the surface preparation; surface roughness may also vary depending on the specific materials supplier and it is almost never specified. Therefore, we consider the agreement between the results of this work and the available literature data to be generally good.

The influence of the assumption concerning the \(\gamma_{\text{N}_2}\) dependence on the vibrational quantum number.

The obtained value of \(\gamma_1\) depends on the assumption made regarding the vibrational quantum number dependence of \(\gamma_{\text{N}_2}\). As it was mentioned above, the \(\gamma_{\text{N}_2}=\gamma_1\cdot v\) hypothesis is justified by the similarity with the \(v\)-scaling of gas phase quenching processes. Nevertheless, other dependences cannot be excluded. For example, assuming \(\gamma_{\text{N}_2}\) to be constant for all the
vibrational levels of N$_2$, we obtain the best fit value of $\gamma_1^0 = (1.5 \pm 0.2) \cdot 10^{-3}$. Therefore, the choice of the vibrational level dependence of $\gamma_{N2}$ may introduce an additional systematic error of $\gamma_1$ determination.

However, the dependence of $\gamma_{N2}$ on $v$ is an unknown input parameter of any vibrational kinetics model of N$_2$. If in the future values of $\gamma_1$ obtained in this work are used for kinetic modeling, the $v$ scaling of $\gamma_{N2}$ employed in the model should be the same as we used to deduce $\gamma_1$. This will reduce the effect of the systematic error of $\gamma_1$ determination.

### 5.4.7 Conclusions on the study of the N$_2$ – CO$_2$ system

In this section we have obtained quite a detailed picture of the vibrational relaxation in the N$_2$-CO$_2$ system. Here we will briefly summarize the most important points.

- Temperature and dissociation/re-association effects are not important for the relaxation measurements of $(N_0 - \beta N_1)$ starting from 2-3 ms in the post discharge. The behavior of the measured signals is determined exclusively by the vibrational relaxation.
- Due to the fast vibrational exchange, almost equal (governed by (5.10)) vibrational temperatures of N$_2(v)$ and CO$_2(v3)$ are established at any moment in the post discharge.
- Vibrational modes of CO$_2$ other than $v3$ exhibit very weak overpopulation because of the fast quenching on the walls and insufficient intramolecular exchange in CO$_2$. As a result the depletion of the measured value of $(N_0 - \beta N_1)$ is governed exclusively by the excitation of the $v3$ mode.
- The value of $\gamma_1$ obtained from comparison between model and experiment for silica is in a good agreement with available literature data.
- The relaxation rate of N$_2(v)$ increases upon the addition of CO$_2$ due to the gas phase quenching and notably due to the increase of the value of $\gamma_{N2}$.

A detailed analysis of the measurements and determination of the value of $\gamma_{N2}$ from the best fit condition in N$_2$ – N$_2$O and N$_2$ – CO would require creation of a dedicated kinetic model for each case. This is rather time consuming task and in addition the relaxation rates in N$_2$O are known with less precision than in CO$_2$. A simplified data treatment procedure for $\gamma_{N2}$ determination is therefore desirable.

### 5.4.8 Data analysis using characteristic relaxation times

In fact, the value of $\gamma_{N2}$ influences the relaxation time of $(N_0 - \beta N_1)$ in the afterglow. The characteristic time may be introduced by fitting the experimental curves with an appropriate analytical function. We have found that the function
Study of surface vibrational relaxation of N$_2$

\[ f(t) = \frac{A}{1 + \alpha \cdot \exp\left(-\frac{(t-t_0)}{\tau_{\text{eff}}}\right)} \]  

(5.12)

perfectly describes the experimental time evolution of \((N_0 - \beta N_1)\) in a wide range of conditions.

The proposed data treatment procedure is the following (we will apply it to the case of N$_2$ – CO$_2$ to check if it gives the same results as the detailed modeling). First, the relaxation curves are fitted with (5.12) and then the value of the “characteristic relaxation frequency” \(\varphi = 1/\tau_{\text{eff}}\) is plotted as a function of the CO$_2$ concentration. The result of this operation for data depicted in Figure 5. 4 a) is shown in Figure 5. 16. Then using a linear fit, an extrapolation towards \([\text{CO}_2]=0\) is performed. The intercept value corresponds to the relaxation frequency in pure N$_2$.

\[ \frac{1}{\tau_{\text{eff}}} \]  

![Figure 5. 16](image)

Figure 5. 16 a) An example of the analytical fit using (5.12). b) The characteristic relaxation frequency as a function of the CO$_2$ concentration left after the discharge pulse. Data points are fitted with a linear function. Conditions are the same as in Figure 5. 4 a).

In order to obtain \(\gamma_{N_2}\) from the extrapolated value of \((1/\tau_{\text{eff}})_{\text{CO}_2=0}\) the kinetic model should be used. But in this case we can deal with the kinetics in pure N$_2$ without taking into account the addition of IR active molecules. The value of \((N_0 - \beta N_1)\) is constructed for N$_2$(v=0) and N$_2$(v=1). This operation is justified because N$_2$(v) is all the time in equilibrium with CO$_2$ (CO or N$_2$O). Then a set of relaxation curves is calculated with different values of \(\gamma_1\) (assuming that \(\gamma_{N_2}=\gamma_1 \cdot v\)) for the experimental conditions. And finally calculated relaxation curves are fitted with (5.12) in order to obtain the calibration curve of \(\gamma_1\) as a function \((1/\tau_{\text{eff}})\).

In Figure 5. 17 a) a set of calculated relaxation curves for standard experimental conditions with different values of \(\gamma_1\) is shown. One can see that simulated results may be also fitted with (5.12). The resulting calibration curve for \(\gamma_1(1/\tau_{\text{eff}})\) is shown in Figure 5. 17 b). Coming back to the results depicted in Figure 5. 16, with the described calibration we obtain that the intercept value \((1/\tau_{\text{eff}})_{\text{CO}_2=0}=22 \text{ s}^{-1}\) corresponds to \(\gamma_1=0.0011\). Therefore, the simplified data treatment procedure for CO$_2$-N$_2$ gives exactly the same resulting value of \(\gamma_1\) (extrapolated to \([\text{CO}_2]=0\)) as the complete kinetic modeling.
If $\tau_{\text{eff}}$ is a good characteristic of the relaxation process?

The procedure described in this section may be directly applied to any IR active admixture. However, it is important to verify that $\tau_{\text{eff}}$ is a universal characteristic of the relaxation process and it is independent of the type of the titrating molecule employed. In order to check if different titrating molecules give the same value of $\tau_{\text{eff}}$ in exactly the same conditions we used the multi-species detection capability of the TRIPLE Q spectrometer. A mixture containing $[\text{CO}_2]=[\text{N}_2\text{O}]=4.5 \times 10^{13} \, \text{cm}^{-3}$ in $\text{N}_2$ at 1.33 mbar was excited by a pulsed DC discharge ($I=50 \, \text{mA}$, $\tau=5 \, \text{ms}$). Both species were measured simultaneously. In Figure 5. 18 one can see that CO$_2$ and N$_2$O yield the same value of $\tau_{\text{eff}}$. Similar measurements were performed in a mixture containing CO and CO$_2$ (Figure 5. 19) and it was found that $\tau_{\text{eff}}$ for both species is the same within 15% uncertainty. It should be noted that the difference of the relaxation times shown in Figure 5. 18 and Figure 5. 19 is due to different pretreatment history of the reactor.

Therefore, we conclude that $\tau_{\text{eff}}$ is a good characteristic of the vibrational relaxation process in $\text{N}_2$ – CO$_2$ (CO, N$_2$O) and the same data treatment may be applied to all the studied mixtures.
Study of surface vibrational relaxation of N₂

Figure 5. 18 Time evolution of the absorption signals of CO₂ and N₂O measured simultaneously in a pulsed DC discharge at p=1.33 mbar, I=50 mA, τ=5ms. Fitting with (5.12) is shown by black solid line.

Figure 5. 19 Time evolution of the absorption signals of CO₂ and CO measured simultaneously in a pulsed DC discharge at p=1.33 mbar, I=50 mA, τ=5ms. Fitting with (5.12) is shown.
Chapter V

5.5 Application of the IR titration for $\gamma_{N2}$ determination on catalytic and plasma-pretreated surfaces

Now, when the IR titration technique is established and tested on a well studied silica surface, we can apply it to the investigation of other materials. The possibility of single pulse operation gives a unique opportunity to study surfaces pretreated by reactive plasmas.

In this section we will compare the utilization of three tracers CO$_2$, N$_2$O and CO for $\gamma_{N2}$ determination on different surfaces (SiO$_2$, Pyrex, TiO$_2$, Al$_2$O$_3$, anodized aluminum) pretreated by low pressure plasma (Ar, N$_2$, O$_2$). We will also investigate the effect of O$_2$ addition in the discharge.

5.5.1 The effect of plasma pretreatment

A series of experiments with silica discharge tube was performed in order to study the role of plasma exposure on the probability of surface vibrational relaxation of N$_2$(v). First, the reactor was pretreated by a flowing RF discharge in N$_2$, O$_2$ or argon during 30 min at a pressure p=53 Pa. Then single pulse experiments in N$_2$ – CO$_2$ (N$_2$O or CO) mixtures were performed with varying admixture concentrations. The discharge conditions were the standard ones (p=1.33 mbar, I=50 mA, $\tau$=5 ms).

Typically, measurements with six different concentrations were done (in the range of 0.05-0.5%) in order to perform extrapolation towards zero admixture. A series of experiments consisted in a pretreatment followed by relaxation measurements with one tracer. Even short discharge pulses may alter the state of the pretreated surface due to the exposure to the species produced in the plasma (ions, N, O, CO, NO). However, we have verified that this effect is rather small and the value of $\gamma_{N2}$ stays constant during more than 10 dc discharge pulses after the pretreatment.

Figure 5. 20 shows the dependence of $1/\tau_{eff}$ on the concentration of CO$_2$ (N$_2$O or CO) for three different pretreatments of the surface. Data points are fitted by linear function in order to obtain the intercept value which is used for $\gamma_{N2}$ determination. One can see that three molecules give similar results. The highest relaxation frequency is obtained after N$_2$ plasma pretreatment, Ar gives intermediate values and the slowest relaxation is after O$_2$ plasma. However, the intercept values of $1/\tau_{eff}$ are slightly different. In Table 5. 2, deduced values of $\gamma_1$ are summarized. After O$_2$ plasma treatment results obtained with CO$_2$, N$_2$O and CO are fairly close. After Ar plasma, CO gives $\gamma_1$ which is 60% higher than the measurements with CO$_2$ and N$_2$O. After N$_2$ pretreatment the strongest discrepancy between three tracers can be seen. Therefore, the measured values of $\gamma_1$ depend on both pretreatment procedure and employed IR tracer.

Observed variation with the type of the tracer for the same pretreatment procedure cannot be attributed to the irreproducibility of the measurements. The same experiments were performed over a period of several months and results were reproducible within 25%. For example,
Study of surface vibrational relaxation of N\textsubscript{2}

\( \gamma_1 = 1.1 \times 10^{-3} \) presented in § 5.4.6 and \( \gamma_1 = 8.8 \times 10^{-4} \) from Table 5. 2 were measured using CO\textsubscript{2} titration after Ar plasma cleaning in the same silica discharge tube with 12 month elapsed between 2 measurements. The fact that with different tracers different values of \( \gamma_1 \) are obtained even after extrapolation to zero admixture signifies that the state of the surface may be irreversibly modified by the presence of titrating molecules. Upon the first introduction of the mixture in the reactor chemisorption (or reactive adsorption) of IR active molecules on surface active sites may take place. The contribution of these irreversibly adsorbed species cannot be corrected by the extrapolation procedure.

\[
\begin{array}{|c|c|c|c|}
\hline
\text{Pretreatment} & \text{N}_2 \text{O} & \text{CO}_2 & \text{CO} \\
\hline
\text{N}_2 & 1.05 \times 10^{-3} & 1.5 \times 10^{-3} & 2.3 \times 10^{-3} \\
\text{Ar} & 8.2 \times 10^{-4} & 8.8 \times 10^{-4} & 1.4 \times 10^{-3} \\
\text{O}_2 & 5.7 \times 10^{-4} & 5.2 \times 10^{-4} & 6.5 \times 10^{-4} \\
\hline
\end{array}
\]

Table 5. 2 The values of \( \gamma_1 \) obtained using three titrating molecules after different plasma pretreatment of silica tube.

Let’s consider separately three types of plasma pretreatment and try to understand what is the contribution due to the introduction of IR tracers (diagnostics artifact) and what is the contribution of plasma pretreatment (real effect) in the measured values of \( \gamma_1 \).
Chapter V

*N₂ plasma treatment*

The highest relaxation probability was measured with CO after N₂ plasma exposure. In order to confirm the possibility of surface state modification by CO molecules in this case, a test experiment was performed. The reactor was treated by N₂ plasma for 30 minutes and then it was exposed to a flow of CO molecules (0.45% CO in N₂ at p=1.33 mbar) during 10 minutes followed by 10 min of pumping. Then the relaxation measurements were done with N₂O. Figure 5. 21 shows the dependence of 1/τ eff on the concentration of N₂O after N₂ plasma pretreatment with and without the exposure to CO flow. One can see that the exposure to CO increases the rate of vibrational relaxation. This proves that interaction of CO molecules with N₂ plasma treated silica may irreversibly change the probability of N₂(v) quenching on the surface.

From the results presented in Chapter 3 we know that under N₂ plasma exposure a silicon oxynitride (SiOₓNᵧ) layer with chemically active adsorbed N atoms is formed on silica surface. It is known from the literature [164] that CO may react with N atoms on V₂O₅/Al₂O₃ forming adsorbed NCO species; similar reaction may take place with N atoms on SiOₓNᵧ in our case. Less is known about the reactivity and chemisorption of CO₂ and N₂O on SiOₓNᵧ and in principle we cannot exclude the possibility of chemisorption of these tracers and their influence on γ₁ measurements.

Therefore, high values of γ₁ measured after N₂ plasma exposure are caused by two effects:

- The increased N₂(v) relaxation probability on SiOₓNᵧ compared to SiO₂
- The interaction of the titrating molecules with SiOₓNᵧ surface.

At present we are not able to separate these two contributions. The value of γ₁ measured with N₂O is the smallest one. Therefore, it is less disturbed by N₂O adsorption effects and it gives the best approximation for the true value of N₂(v) quenching probability on SiOₓNᵧ.

![Figure 5. 21 Dependence of the 1/τ eff on the concentration of N₂O in silica reactor pretreated by N₂ plasma with and without the exposure to CO. Standard DC discharge conditions.](image-url)
Study of surface vibrational relaxation of $\text{N}_2$

**Argon plasma treatment**

After argon plasma pretreatment a clean $\text{SiO}_2$ surface is expected according to the results of Chapter 3 and Chapter 4. However, due to argon plasma exposure some new surface active sites may be formed [110] which can explain the increased values obtained using CO titration. Carbon monoxide may occupy these active sites and enhance surface vibrational relaxation of $\text{N}_2$. Results obtained with CO$_2$ and N$_2$O are identical within experimental uncertainty what let us assume that in this case chemisorption effects are negligible. And we suppose that the true value of $\gamma_1$ on argon plasma treated $\text{SiO}_2$ is obtained with CO$_2$ and N$_2$O after extrapolation to zero tracer admixture.

**Oxygen plasma treatment**

Pretreatment by O$_2$ plasma results in the $\text{SiO}_2$ surface saturated with adsorbed O atoms as we have shown in Chapter 4. Apparently, there is no significant adsorption of titrating molecules on this surface because identical result of measurements with 3 different tracers. The true value of $\gamma_1$ is obtained with all tracers.

Among three molecules used in this study, N$_2$O is known to be the most inert from the viewpoint of adsorption on catalytic surfaces [164]. In catalysis studies it is often employed as a non-reactive IR tracer [118]. Therefore, we expect that the values of $\gamma_1$ obtained using N$_2$O are less perturbed by chemisorption effects. Looking at the $\gamma_1$ values measured with N$_2$O we conclude that depending on plasma pretreatment the relaxation probability of N$_2$(v) on silica surface may be changed by a factor of 2. This is a new effect, and its observation was possible only because of the single-pulse operation mode of the IR titration technique.

**5.5.2 Vibrational relaxation on TiO$_2$.**

Titanium dioxide is a promising material for air pollution control using plasma-catalyst technology [11]. To the best of our knowledge, there is no literature data available for the relaxation probability of $\text{N}_2$(v) on TiO$_2$. In this study we used a silica discharge tube with a TiO$_2$ sol-gel coating on its inner surface.

Measurements with three different tracers and three different plasma pretreatments were performed with TiO$_2$ coating in the same way as it was described in the previous section for $\text{SiO}_2$. In Figure 5. 22 the dependencies of $1/\tau_{\text{eff}}$ on the concentration of IR tracers left after the discharge pulse for different pretreatments are presented. The resulting values of $\gamma_1$ are summarized in Table 5. 3. One can see that with CO$_2$ somewhat higher values of $\gamma_1$ are obtained. This may be explained by the modification of the TiO$_2$ surface by the chemisorption of CO$_2$ as it was discussed above for silica surface.

As in the case of $\text{SiO}_2$, the lowest (and hence the most precise) values of $\gamma_1$ are measured with N$_2$O indicating the inert nature of this tracer. Results obtained with N$_2$O are almost independent on plasma pretreatment.
The studied sol-gel coating was smooth and it had a specific surface approximately equal to the geometric surface of the reactor. In real applications high specific surface catalytic materials are usually used [11]. We have performed relaxation measurements with a TiO$_2$ coating impregnated with Degussa P25 TiO$_2$ particles identical to one used in § 4.4.2.1. Compared to the smooth coating, the impregnated sol-gel film was rough having the total surface of approximately 4 m$^2$. Figure 5. 23 shows the time evolution of the absorption signal measured in 0.3% CO$_2$ – N$_2$ mixture in standard DC discharge conditions. Fitting of the experimental curve with (5.12) gives $\tau_{\text{eff}}=2.4$ ms, which is comparable with the characteristic diffusion time of N$_2(v)$ in our conditions. As it was discussed before, $\tau_{\text{eff}}$ is weakly dependent on the value of $\gamma_1$ when it approaches the characteristic diffusion time (when surface relaxation is limited by the diffusion). Therefore, only the lower boundary of the value of $\gamma_1$ can be determined in this case. From the results shown in Figure 5. 23 we have found that $\gamma_1 \geq 0.04$ on impregnated TiO$_2$. Faster relaxation on the impregnated film may be caused by the increase of the surface area due to the presence of TiO$_2$ particles. In addition to this geometric effect, TiO$_2$ particles may possess an enhanced efficiency for quenching of N$_2(v)$ due to the presence of different active sites compared to the sol-gel film.

This example demonstrates that IR titration allows measurements of N$_2(v)$ vibrational relaxation times in the conditions ranging from diffusion-limited to surface step limited heterogeneous vibrational relaxation.

<table>
<thead>
<tr>
<th>Pretreatment</th>
<th>N$_2$O</th>
<th>CO$_2$</th>
<th>CO</th>
</tr>
</thead>
<tbody>
<tr>
<td>N$_2$</td>
<td>1.9·10$^{-3}$</td>
<td>3.6·10$^{-3}$</td>
<td>3.1·10$^{-3}$</td>
</tr>
<tr>
<td>Ar</td>
<td>2·10$^{-3}$</td>
<td>2.6·10$^{-3}$</td>
<td>2.2·10$^{-3}$</td>
</tr>
<tr>
<td>O$_2$</td>
<td>1.8·10$^{-3}$</td>
<td>3.6·10$^{-3}$</td>
<td>2.5·10$^{-3}$</td>
</tr>
</tbody>
</table>

Table 5. 3 The values of $\gamma_1$ obtained using three titrating molecules after different plasma pretreatment of TiO$_2$ coating.
Study of surface vibrational relaxation of N₂

Figure 5. Time evolution of the absorption signals of CO₂ measured in a pulsed DC discharge at p=1.33 mbar, I=50 mA, t=5 ms in a 0.3% CO₂ – N₂ mixture. The reactor with impregnated TiO₂ coating was used. Fitting of experimental data with (5.12) is shown.

5.5.3 Vibrational relaxation on other catalytic surfaces

Above we have seen that N₂O is the most inert tracer that gives the most reliable values of γ₁. In contrast to CO₂, N₂O may be used with Al₂O₃ which is known for its CO₂ trapping properties [165]. Thus, experiments with different materials of the reactor inner surface pretreated by low pressure plasma were performed using N₂O as a titrating molecule. As before, for each material a series of measurements with different concentrations of N₂O was done in order to obtain the extrapolation of 1/τₑᵤ at [N₂O]→0. The value of γ₁ was then determined using the calibration curve from Figure 5. 17. The results of all the measurements done with N₂O are summarized in Table 5. 4 and compared with available literature data. One can see that our results are in good general agreement with already published data.

<table>
<thead>
<tr>
<th>Surface</th>
<th>γ₁ this work</th>
<th>literature values</th>
<th>Ref.</th>
</tr>
</thead>
<tbody>
<tr>
<td>Silica (O₂ plasma pretr.)</td>
<td>5.7·10⁻⁴</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Silica (N₂ plasma pretr.)</td>
<td>10.5·10⁻⁴</td>
<td>(1.8-7)·10⁻⁴</td>
<td>[127]</td>
</tr>
<tr>
<td>Silica (Ar plasma pretr.)</td>
<td>8.2·10⁻⁴</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Pyrex (O₂ plasma pretr.)</td>
<td>6·10⁻⁴</td>
<td>(2,3-10)·10⁻⁴</td>
<td>[127]</td>
</tr>
<tr>
<td>Pyrex (N₂ plasma pretr.)</td>
<td>11·10⁻⁴</td>
<td></td>
<td>[129]</td>
</tr>
<tr>
<td>Al₂O₃ (O₂ plasma pretr.)</td>
<td>15·10⁻⁴</td>
<td>(11-14)·10⁻⁴</td>
<td>[127]</td>
</tr>
<tr>
<td>Anodized Al (O₂ plasma pretr.)</td>
<td>29·10⁻⁴</td>
<td></td>
<td></td>
</tr>
<tr>
<td>TiO₂ sol gel film (N₂, O₂, Ar plasma pretr.)</td>
<td>19·10⁻⁴</td>
<td>no</td>
<td></td>
</tr>
</tbody>
</table>

Table 5. 4 Summary of all the γ₁ measurements done using N₂O titration. Comparison with available literature data is shown.
5.5.4 Vibrational relaxation on silica surface in air plasma.

We have seen in previous sections that molecular admixtures may change the probability of N$_2$(v) vibrational quenching on the surface. In air discharge, substantial amounts of NO and NO$_2$ are formed [16]. Usually in kinetic models of low pressure air plasmas, the value of $\gamma_{N_2}$ is taken the same as in pure N$_2$. To the best of our knowledge, no measurements in N$_2$-O$_2$ mixtures have been done so far.

A series of measurements in N$_2$/O$_2$=4/1 with CO$_2$ and N$_2$O admixtures was performed. The discharge conditions were the same as before (p=1.33 mbar, I=50 mA, $\tau$=5 ms), silica and Pyrex tubes were used. The surface was exposed to a pulsed dc discharge in air for 10 minutes. The value of $\gamma_1=(8\pm3)\cdot10^{-4}$ was found for both materials. The relatively high uncertainty of the measurements is due to the unknown contribution of the VT quenching by atomic oxygen. The upper limit of $\gamma_1$ was calculated by completely neglecting the contribution of VT quenching by O. The lower limit was estimated by assuming a constant concentration [O]=10$^{15}$ cm$^{-3}$ [149] in the post discharge with the VT relaxation constant taken from [166] $k_{VT} = 4.5\cdot10^{-15}$ cm$^3$s$^{-1}$.

We conclude here that the presence of O$_2$ and NO$_x$ doesn’t significantly modify the quenching probability of N$_2$(v) on silica and Pyrex and the use of values of $\gamma_1$ measured in pure N$_2$ discharges is justified.

5.6 Infrared titration as a plasma diagnostics tool: determination of the vibrational temperature of N$_2$

We have shown that the depletion of the measured value of $(N_0 - \beta N_1)$ in the afterglow is caused by the vibrational excitation of the titrating molecules which is in turn determined by the vibrational excitation of N$_2$. In this section we will show how the time evolution of the vibrational temperature of N$_2$, $T_v = E_1 f \left( \ln \left( \frac{N_2(v=0)}{N_2(v=1)} \right) \right)$, can be directly obtained from laser absorption measurements. First, we will consider the N$_2$ – CO$_2$ system because it is better characterized and then we will apply the same treatment to N$_2$-N$_2$O and N$_2$-CO.

5.6.1 Formulation of the method and its application to the N$_2$ – CO$_2$ system

As it has been shown in § 5.4.5, in standard pulsed DC discharge conditions, only the CO$_2$(00$^0_3$) mode has a significant population. This means that the amplitude of the depletion of $(N_0 - \beta N_1)$ can be related to the vibrational temperature of this mode. Assuming Boltzmann distribution of CO$_2$(00$^0_3$), the normalized value of $(N_0 - \beta N_1)$ can be expressed as follows:

$$(N_0 - \beta N_1)_{\text{norm}} = \left( (1 - \theta) - \beta (1 - \theta) \theta \right) \quad (5.13)$$
Study of surface vibrational relaxation of N$_2$

where $\theta = e^{-\frac{E_1}{T_v}}$. Only the relative variation of the value of $(N_0 - \beta N_1)$ is significant, so it is normalized to the stationary post discharge level. The vibrational temperature of CO$_2$(00$^0$v$_3$), which is related to the vibrational temperature of N$_2$ by (5.10), can be calculated by solving (5.13) at any time point. The measurements are free from the distortion by the variation of the gas temperature starting from the ~ 3 ms in the post discharge. In Figure 5.24 evolution of the vibrational temperature of N$_2$ calculated using (5.10) and (5.13) in a mixture containing 0.2% CO$_2$ in N$_2$ at 1.33 mbar in Pyrex discharge tube is shown. The discharge current was 50 mA, pulse duration was 1 ms and 5 ms. A good agreement between the model and the experiment proves the feasibility of the proposed method for $T_v$ determination. It is important to note, that the complete time evolution of $T_v$ in the afterglow is obtained in a single discharge pulse.

![Figure 5.24 Evolution of the vibrational temperature of N$_2$ in the afterglow of a discharge pulse with I=50 mA in a 0.2% CO$_2$ – N$_2$ gas mixture at p=1.33 mbar. Pyrex discharge tube. Pulse durations were 1 ms (---○---) and 5 ms (---□---). Simulation results are shown by solid lines.](image)

5.6.2 On the vibrational temperature measurements in N$_2$ - N$_2$O and N$_2$ - CO

As it has been shown for CO$_2$, the deduction of the vibrational temperature of N$_2$ from the absorption measurements in N$_2$-CO$_2$ relies on the fact that only the $v3$ mode has a significant population. If $v1$ and $v2$ were strongly involved, the depletion of $(N_0 - \beta N_1)$ signals would be determined by the population of the whole vibrational manifold of CO$_2$, and the direct determination of $T_v$ would be impossible. The low population of $v1$ and $v2$ under the conditions of this study is due to the fast surface quenching and slow intra molecular vibrational exchange. Another important condition is the applicability of the relation (5.10). It was derived based on the assumption that V-V’ exchange between N$_2(v)$ and titrating molecules is much faster than other relaxation processes. In principle, a complete kinetic
model is required to check the possibility of direct $T_v$ determination under the conditions of this study for $N_2$-$N_2O$ and $N_2$-$CO$ mixtures.

At present, we tentatively apply the same treatment as has been developed for $N_2$–$CO_2$ to relaxation measurements in $N_2$–$CO$ and $N_2$–$N_2O$. For tests we use the experimental data shown in Figure 5. 18 and Figure 5. 19. Simultaneous measurements allow direct comparison of $T_v$ evolution determined using two different tracers in exactly the same conditions.

![Figure 5. 25](image1)

**Figure 5. 25** a) Evolution of the vibrational temperature of $CO_2(00\nu_3)$ and $N_2O(00\nu_3)$ obtained by applying (5. 13) in the conditions shown in Figure 5. 18. b) Vibrational temperature of $N_2$ calculated using (5. 10) for $T_v$ from the left panel. Result of the model calculation of the vibrational temperature of $N_2$ is also shown.

![Figure 5. 26](image2)

**Figure 5. 26** a) Evolution of the vibrational temperature of $CO_2(00\nu_3)$ and $CO$ obtained by applying (5. 13) in the conditions shown in Figure 5. 19. b) Vibrational temperature of $N_2$ calculated using (5. 10) for $T_v$ from the left panel. Result of the model calculation of the vibrational temperature of $N_2$ is also shown.

First we have calculated the vibrational temperature of IR tracers using (5. 13) based on the experimental data. Figure 5. 25 a) and Figure 5. 26 a) show time evolution of the vibrational temperatures of couples of tracers [$CO_2(00\nu_3)$ and $N_2O(00\nu_3)$] and [$CO_2(00\nu_3)$ and $CO$] respectively. Then (5. 10) was used (with corresponding vibrational quanta of $N_2O$ and $CO$) to calculate the evolution of $T_v$ of nitrogen in each case. The results of calculation are shown in Figure 5. 25 b) and Figure 5. 26 b). One can see that results obtained with $CO$ and $N_2O$ differ from those obtained with $CO_2$ (which are in good agreement with the model).
Study of surface vibrational relaxation of $N_2$

The possible reason of this discrepancy is an unjustified application of (5. 10) which yields too low vibrational temperatures of $N_2$. As is shown in Table 5.1, $CO_2(00^0v3)$ is almost in perfect resonance with $N_2(0v)$ (the difference is of only 18 cm$^{-1}$). This leads on the one hand to faster vibrational exchange between two species, and on the other hand the correction introduced by (5. 10) is very small. The departure of CO and $N_2O(00^0v3)$ from the resonance is much stronger (187 cm$^{-1}$ and 106 cm$^{-1}$ respectively) what may lead to underestimation of the vibrational temperature of $N_2$. More detailed analysis of the vibrational kinetics is required in order to get a correct interpretation of the relaxation measurements in $N_2$-CO and $N_2$-$N_2O$ mixtures.

5.7 Conclusions

In this chapter we have developed a method for in-situ investigation of relaxation of vibrationally excited nitrogen molecules on different surfaces. This method uses a combination of quantum cascade laser absorption measurements in mixtures $N_2$-$CO_2$($N_2O$ or CO) excited by a pulsed dc discharge and modeling of vibrational kinetics.

Laser diagnostics

We have used a novel type of tunable solid state lasers – quantum cascade lasers which are specially designed for fast kinetics measurements. The main challenges in using quantum cascade lasers in intra-pulse mode are associated with their extremely fast chirp rate (~ 0.02 cm$^{-1}$/ns in the QCL used for CO$2$ detection) so the laser is swept across the absorption line in few nanoseconds. Apart from technical difficulties, associated with the use of very fast detectors and acquisition systems (~1GHz bandwidth), fast tuning of QCLs induce non-linear (rapid passage) effect in absorption of laser light. Interpretation of QCL absorption spectra distorted by the rapid passage effect in equilibrium conditions is well documented [75]. In this study QCLs were used for the first time for measurements in vibrationally excited gases.

In order to account for stimulated emission from upper vibrational levels of molecular transitions probed with the laser we used expression (5.3) which is not justified a-priori in case of absorption lines distorted by rapid passage effect. Excellent agreement between measured and modeled depletion signals obtained in § 5.4.6 prove the validity of our treatment of laser absorption measurements. Validity of (5.3) is a prerequisite condition for measurements of vibrational temperature of $N_2$ that were performed in § 5.6.1.

Another important point is the high time resolution achievable with the QCL lasers. With maximum time resolution of 5 $\mu$s we were able to follow relaxation kinetics even when the characteristic time of vibrational relaxation was of the order of 1 ms (as in Figure 5.23).

Kinetic modeling

A 0-dimentional model of vibrational kinetics in pure $N_2$ and $N_2$ – CO$2$ mixtures has been developed in order to give interpretation of experimental relaxation measurements and determine vibrational relaxation probability of $N_2(v)$ on the surface. With a small number of
input parameters (discharge tube radius, gas pressure, discharge current and pulse duration) the model predicts the time evolution of coupled VDFs of N$_2$ and CO$_2$. The model is based on a reduced set of processes that are relevant to vibrational kinetics only and it contains 52 coupled equations for 0 – 45 levels of N$_2$ and 6 levels of CO$_2$. The validity of our model for pure N$_2$ was confirmed by comparison with more detailed self-consistent simulations performed by V. Guerra for our conditions. The predictions of our model were found to be in excellent agreement with the experimental measurements of population of N$_2$(v=18) measured in [162].

Unknown parameter in simulations is the probability of vibrational relaxation of N$_2$(v) on the surface (γ$_{N2}$) and its dependence on the vibrational quantum number. We have chosen linear scaling law γ$_{N2}$ = v·γ$_1$ as more physical and γ$_1$ was used as the only tuning parameter in the model. The value of γ$_1$ for various surfaces was obtained from comparison between characteristic times of vibrational relaxation measured experimentally and calculated by the model for a set of different γ$_1$.

**Surface vibrational relaxations of N$_2$(v)**

All the experiments have been performed in a single discharge pulse without data accumulation. This excluded uncontrollable drifts of the state of the surface due to long plasma exposure and allowed measurements with specially prepared surfaces. The validity of IR titration technique has been confirmed by measurements of γ$_1$ for well studied surfaces - Pyrex and silica. A good agreement with literature values has been obtained. The values of γ$_1$ have been also measured for different materials – TiO$_2$, Al$_2$O$_3$, anodized aluminium.

We have found that the value of γ$_1$ depends on a number of factors:

- Chemical nature of the surface
- Surface morphology
- Plasma pretreatment of the surface
- Presence of physisorbed and chemisorbed molecules

The influence of plasma exposure on silica surface has been thoroughly investigated. It has been shown that depending on the pretreatment by low pressure plasma (N$_2$, Ar or O$_2$) the value of γ$_1$ may be changed by a factor of 2. Typically the highest relaxation probability has been obtained after N$_2$ pretreatment, i.e. when silicon oxynitride layer is formed on the surface. The lowest value of γ$_1$ has been measured on silica surface pretreated by O$_2$ plasma. As we know, in this case grafted O atoms are present on SiO$_2$. This result demonstrates that O and N atoms chemisorbed on SiO$_2$ are not only involved in surface reactivity but also influence mechanisms of vibrational relaxation of N$_2$(v) on the surface.

We have observed for the first time that molecular admixtures in N$_2$ increase the value of γ$_1$ on silica surface. This effect was explained by vibrational energy transfer between adsorbed molecules and N$_2$(v). It is interesting that both physisorbed and chemisorbed molecules can be involved in N$_2$(v) relaxation on the surface. It has been found that N$_2$O is the most reliable
Study of surface vibrational relaxation of N$_2$

titrating molecule and it can be used for $\gamma_1$ measurements on different catalytic surfaces without significant distortion effects due to the chemisorption.
6. Chapter VI: General conclusions and outlook

6.1 General conclusions

In the beginning of this work the only “image” of recombination of O and N atoms on silica-like materials was the one developed in the mesoscopic models of Kim&Boudart [5] and Jumper [41]. The investigation of the mechanism of N\(_2(v)\) vibrational relaxation on the surface was limited to few studies in the flowing post-discharge[127] [128]. Our results provide new information on the modification of the state of the surface under low pressure plasma exposure and give an insight into the mechanisms of chemical reactions and relaxation processes on the surface. We can outline three principle findings of this work which are generic for surface interactions in reactive molecular plasmas.

The role of plasma exposure

Under low pressure plasma exposure atoms of the material are replaced by atoms and/or ions from the gas phase. Therefore, the surface is not static, it is constantly restructured and modified. In such conditions the notion of chemisorption has to be redefined; surface atoms belonging to the crystalline network of the material are indistinguishable from atoms grafted to the surface under plasma exposure.

The distribution of reactivity of adsorbed atoms

Due to the inhomogeneous nature of real surfaces adsorbed atoms exhibit a distribution of reactivity which is most probably related to the spectrum of their binding energies. Weakly bonded atoms are more reactive and play an important role for surface catalyzed reactions.

The role of adsorbed atoms and molecules in the relaxation of vibrational energy on the surface

In addition to the vibrational relaxation mechanisms that are typical for clean surfaces (as for example interaction with phonons and electrons of the solid) in real plasma conditions new pathways of vibrational quenching on the surface become possible. We have found that the presence of adsorbed atoms and molecules may significantly modify the probability of vibrational relaxation on the surface.

Experimental technique developed in this study allowed us to isolate and investigate elementary surface reactions (for example NO + O\(_{\text{ads}}\). → NO\(_2\) or O + N\(_{\text{ads}}\). → NO). In the future this approach may be used for investigation of reactions catalyzed by different adsorbed atoms on various surfaces.
6.2 Summary of the main results

Here we give a list of the most important results of this work:

*Adsorption and reactivity of N*

- Under N\textsubscript{2} plasma exposure silicon oxynitride layer is formed on the surface of silica discharge tube. Nitridation is driven by ion bombardment and it takes place only under direct N\textsubscript{2} plasma exposure. When silica surface is exposed to a flowing post-discharge nitridation is negligible.
- Formation of SiO\textsubscript{x}N\textsubscript{y} layer is very sensitive to the presence of O\textsubscript{2} admixtures in N\textsubscript{2} plasma. Addition of 0.1\% of O\textsubscript{2} into N\textsubscript{2} reduces the number of grafted N atoms by a factor of 10.
- Under N\textsubscript{2} plasma exposure N\textsubscript{ads} are continuously exchanged with N atom and ions from the gas phase. We have found two groups of N\textsubscript{ads}: i) first with a characteristic turnover time $\sim 10$ s in our standard rf discharge conditions ii) second having the characteristic replacement time $\sim 300$ s. The first group was assigned to N on the outmost surface layer and the second one to atoms distributed in the SiO\textsubscript{x}N\textsubscript{y} layer.
- Nitrogen atoms on the surface of SiO\textsubscript{x}N\textsubscript{y} exhibit a distribution of reactivity. We have found a small fraction of N\textsubscript{ads} (having a coverage $[N^*_{\text{ads}}] = 3.5 \cdot 10^{13}$ cm\textsuperscript{-2}) that can recombine with atomic oxygen producing NO molecules.
- N\textsubscript{ads} participate in recombination of N on the surface, but recombination with these atoms cannot explain the rate of N losses on the surface. We suppose therefore that recombination of N atoms takes place on weakly bonding active sites.

*Adsorption and reactivity of O*

- Under direct O\textsubscript{2} plasma exposure, oxygen atoms that compose the outmost layer of silica and Pyrex are continuously exchanged with oxygen atoms and ions from the gas phase. Typically, in our standard pretreatment conditions $(5-6) \cdot 10^{15}$ O atoms per cm\textsuperscript{2} are replaced during 500 s of plasma exposure.
- We have found that under O\textsubscript{2} plasma exposure reactive O atoms are adsorbed on Pyrex or TiO\textsubscript{2}. The reactivity of O\textsubscript{ads} towards stable molecules depends on the nature of the surface and the target molecule.
- Oxygen atoms adsorbed on Pyrex surface are reactive towards NO (we denote these atoms $O^*_{\text{ads}}$). Titration of $O^*_{\text{ads}}$ using the reaction NO + $O^*_{\text{ads}} \rightarrow$ NO\textsubscript{2} allowed determination of the lower limit of the coverage $[O^*_{\text{ads}}] = 2.5 \cdot 10^{14}$ cm\textsuperscript{-2}.
- A distribution of reactivity of $O^*_{\text{ads}}$ towards NO have been observed. We suggest that this distribution is related to a spectrum of binding energies of adsorbed atoms. The maximum rate of NO oxidation on the surface corresponds to the effective surface reaction probability $\gamma_{\text{NO\rightarrowNO}_2} = 2 \cdot 10^{-7}$.
- Oxygen atoms adsorbed on TiO\textsubscript{2} are reactive towards C\textsubscript{2}H\textsubscript{2}. The maximum number of C\textsubscript{2}H\textsubscript{2} lost on the TiO\textsubscript{2} surface pretreated by O\textsubscript{2} plasma was $\sim 5 \cdot 10^{12}$ molecules per cm\textsuperscript{2}. It was found that C\textsubscript{2}H\textsubscript{2} is oxidized only partially by O\textsubscript{ads} leaving some reaction
General conclusions and outlook

intermediates on the surface. Further oxidation of these adsorbed species into CO\textsubscript{2} can be reached by heating or UV activation of the catalyst. Observed adsorbed oxygen atoms may be responsible for reported in the literature improved pollutant destruction by plasma-TiO\textsubscript{2} combination.

- We have found that ozone may be formed from surface recombination (O+O\textsubscript{2})\textsubscript{w} on silica surface. The presence of adsorbed water and surface OH groups favours ozone production on the surface. At p=6.7 mbar ozone production accounts for 30% of losses of O atoms on silica surface. This result demonstrates the importance of weakly bonded O\textsuperscript{weak} for surface catalyzed reactions in oxygen plasmas.

Vibrational relaxation of N\textsubscript{2}(v) on surfaces

- A new infrared titration technique has been developed for determination of N\textsubscript{2}(v) relaxation probability on the surface (\(\gamma_{N2}\)) at mbar pressures.
- A 0-dimentional modeling of vibrational kinetics in pure N\textsubscript{2} and N\textsubscript{2} – CO\textsubscript{2} mixtures has been performed in order to give interpretation of experimental relaxation measurements and determine vibrational quenching probability of N\textsubscript{2}(v) on the surface. Results of our simplified kinetic model are in a good agreement with more sophisticated complete self-consistent simulations. In the model we have assumed the linear scaling of the quenching probability with the vibrational quantum number \(\gamma_{N2}=v\cdot\gamma_1\). The value of \(\gamma_1\) was determined from the best agreement between the experiment and the simulations.
- The validity of IR titration technique has been confirmed by measurements of \(\gamma_1\) for well studied surfaces - Pyrex and silica. Our results (\(\gamma_1=(5-10)\cdot10^{-4}\)) are in good agreement with literature values. Using the new technique the values of \(\gamma_1\) have been determined for different materials – TiO\textsubscript{2}, Al\textsubscript{2}O\textsubscript{3}, anodized aluminium.
- The influence of plasma exposure on silica surface has been thoroughly investigated. It has been shown that depending on the pretreatment by low pressure plasma (N\textsubscript{2}, Ar or O\textsubscript{2}) the value of \(\gamma_1\) may be changed by a factor of 2. Typically the lowest value of \(\gamma_1\) is obtained after O\textsubscript{2} plasma treatment and the highest after N\textsubscript{2} plasma.
- We have observed for the first time that molecular admixtures in N\textsubscript{2} increase the value of \(\gamma_1\) on silica surface. This effect was explained by vibrational energy transfer between adsorbed molecules and N\textsubscript{2}(v).

6.3 Implication for modelling of surface recombination

Mesoscopic modelling

We have shown in this work that losses of N atoms on the surface cannot be described by recombination on one type of chemisorption sites and there exists a distribution of active sites with different binding energies. This means that separation of surface atoms into two groups – physisorbed (mobile) and chemisorbed (stable) which is usually used for mesoscopic
General conclusions and outlook

description of atomic recombination is very schematic. The existence of a distribution of adsorption energies literally bridges the gap between physisorption and chemisorption.

It is clear that distribution of adsorption energies (including weakly bonded atoms) has to be considered in the models for correct description of atomic recombination on surfaces. Recently, only by assuming a broad distribution of binding energies of atoms on anodized aluminium surface Donnelly et al. [54] have been able to reproduce the kinetics of LH recombination of O and Cl atoms in spinning wall experiments. At present similar effort has never been done for modelling of atomic recombination on silica-like surfaces.

Microscopic modelling

Recent studies of O and N recombination on model SiO₂ surfaces [35][38] take into account only strongly bonded atoms. Our results demonstrate that weakly bonded atoms are active for recombination and, therefore, they have to be included in ab-initio simulations of surface catalyzed recombination of atoms.

6.4 Future work

Surface reactivity

Based on the new results on surface reactivity in N₂ and O₂ plasmas obtained in this work we suggest the following direction for further research:

- We have found that O and N atoms composing the material of the surface (SiO₂ or SiOₓNᵧ) are continuously replaced under plasma exposure. The role of ions in the exchange process is still not clear. Experiments with independent atomic and ion beams should be performed in order to separate the contribution of charged and neutral species.
- In this thesis we have revealed that weakly bonded N and O atoms on silica-like surfaces play a very important role for surface catalyzed reactions. The nature and properties of these unstable species have to be further investigated. This will require application of different surface diagnostics techniques, capable of detecting species having short lifetime on the surface.
- We have separately investigated interaction between plasmas in pure O₂ and N₂ and different oxide surfaces. The next step would be the understanding of surface processes that take place under air plasma exposure. We have already obtained some valuable results as, for example, suppression of SiOₓNᵧ layer formation when O₂ is added into N₂ plasma.

Application of isotopic techniques developed in this work may be very useful for understanding of complex chemical kinetics of surface catalyzed reactions in N₂/O₂ plasmas. For example, utilization of N₂ isotopes with time resolved ¹⁴NO and ¹⁵NO detection allows distinction between gas phase and surface mechanisms of NO production. In Figure 6, production of NO in a pulsed dc discharge in ³⁰N₂/O₂ = 4/1 mixture in silica reactor pretreated
by $^{28}$N$_2$ plasma is shown. One can see that $^{15}$NO is formed only during the discharge pulse while $^{14}$NO that comes from the surface is produced predominantly in the afterglow. This experiment demonstrates different time scales of surface and volume mechanisms of NO production in N$_2$/O$_2$ pulsed discharges.

Figure 6. Production of NO isotopologues in a pulsed dc discharge (10 ms, 100 mA pulse) in $^{30}$N$_2$/O$_2$ = 4/1 mixture at 1.3 mbar. Silica discharge tube was pretreated by a rf discharge in $^{28}$N$_2$.

Surface vibrational relaxation

The work on the investigation of surface vibrational relaxation using IR titration may be continued in the following way:

- Investigation of the temperature dependence of $\gamma$N$_2$ which may give a deeper insight in the mechanism of N$_2$(v) relaxation on surfaces. So far there exists only one example in the literature where the variation of $\gamma$N$_2$ with the temperature have been measured [128]. In addition it would be interesting to investigate the effect of molecular additions at different temperatures. We have supposed that the enhancement of the value of $\gamma$N$_2$ upon the addition of CO$_2$ is caused by the vibrational transfer between N$_2$(v) and physisorbed CO$_2$ molecules. The coverage of physisorbed CO$_2$ should be very sensitive to the variations of the temperature of the wall.
- Study of the pressure dependence of $\gamma$N$_2$. Similarly to the role of the wall temperature, data on the $\gamma$N$_2$ dependence on the gas pressure are very scarce.
General conclusions and outlook

6.5 New diagnostic techniques

In this work we have developed and validated several new diagnostics techniques for investigation of surface and gas phase processes in \( N_2/O_2 \) containing plasmas. They are all based on the combination of pulsed discharge excitation with the measurements of gas phase species concentrations.

**Mass-spectrometric measurements of \( N_2 \) dissociation**

Using the QMS measurements of the isotopic exchange upon dissociation in \( ^{30}N_2/^{28}N_2 \) mixtures we have determined the dissociation fraction of \( N_2 \) in a pulsed dc or rf discharges. This technique has been applied at one particular pressure and discharge current (or injected power). A very interesting result obtained using this new technique is that in studied conditions the dissociation and surface recombination of different nitrogen isotopologues is identical.

In the future this technique may be used for parametric investigation of \( N_2 \) dissociation at different pressures and discharge currents. According to [97] at pressures of the order of few mbars, processes with vibrationally excited \( N_2 \) (V-D processes) contribute significantly to \( N_2 \) dissociation. Due to the difference in the vibrational quanta of different isotopologues, V-D processes are isotopologue-dependent. Therefore, the rate of isotopic exchange is expected to be different in different \( ^{28}N_2/^{30}N_2 \) mixtures when V-D processes are important.

In principle, isotopic exchange technique may be applied to investigation of dissociation in different diatomic gases. An important parameter that has to be verified for each gas is the rate of isotopic exchange in collisions between atoms and molecules in the gas phase. For example in the case of \( O_2 \), a very efficient exchange in \( O – O_2 \) collisions make impossible dissociation measurements using isotopic exchange.

**IR titration of vibrationally excited molecules**

The IR titration technique developed in this work allows simultaneous measurements in a single discharge pulse of the value of \( \gamma_{N_2} \) and the time evolution of the vibrational temperature of \( N_2 \). It may be used for diagnostics of pulsed discharges in \( N_2 \) with different molecular admixtures.
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Related publications

Chapter II

«TRIPLE Q: A three channel quantum cascade laser absorption spectrometer for fast multiple species concentration measurements»

Chapter III

«Production of molecules on surface under plasma exposure: Example of NO on pyrex»

Chapter IV

«Evidence for surface oxidation on Pyrex of NO into NO₂ by adsorbed O atoms»

«Evidence of atomic adsorption on TiO₂ under plasma exposure and related C₂H₂ surface reactivity»

Chapter V

«Surface vibrational relaxation of N₂ studied by CO₂ titration with time resolved quantum cascade laser absorption spectroscopy»